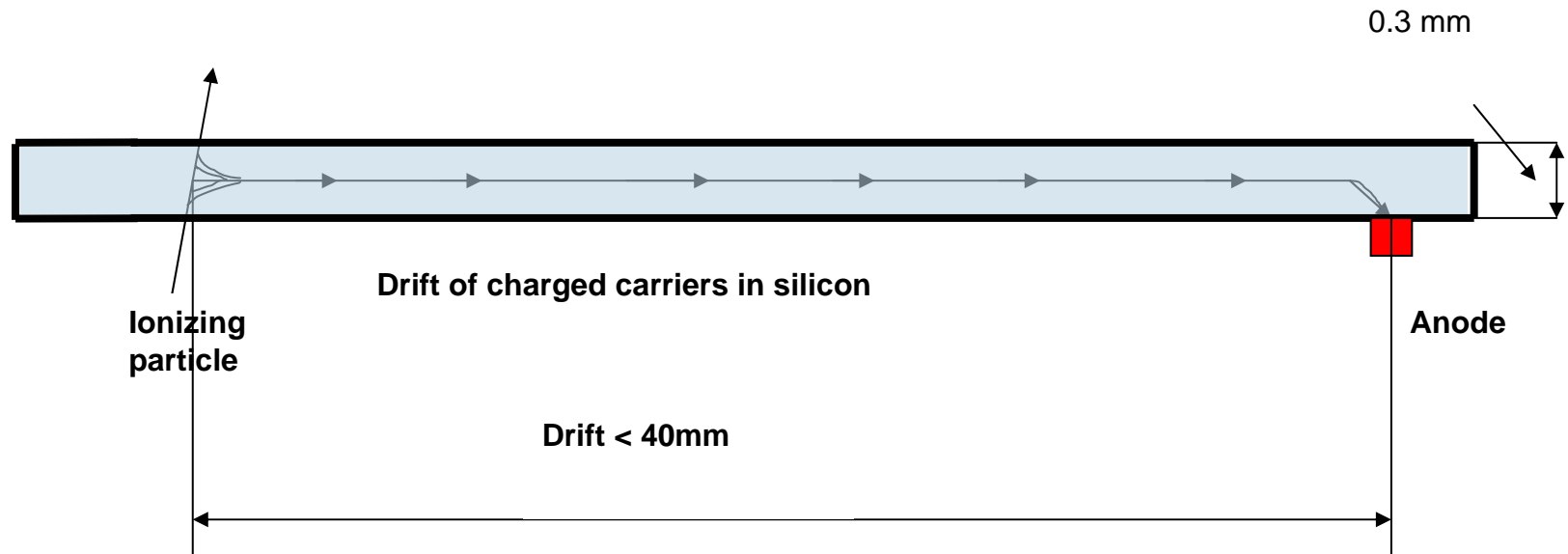


The Semiconductor Drift Detector (SDD)

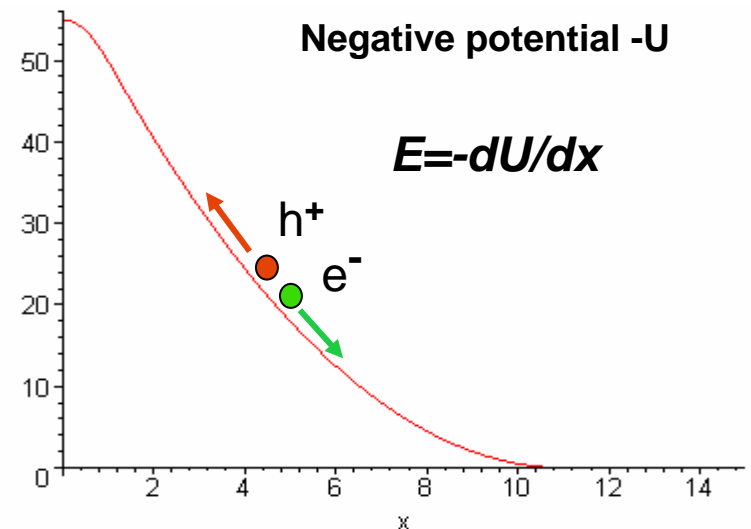
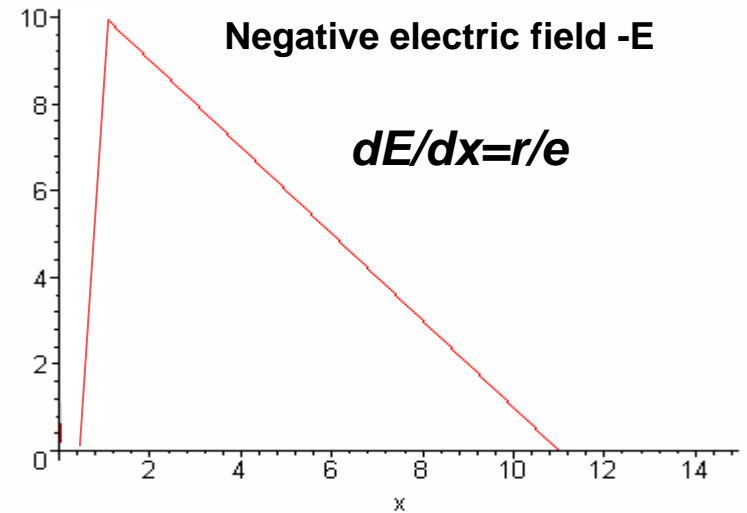
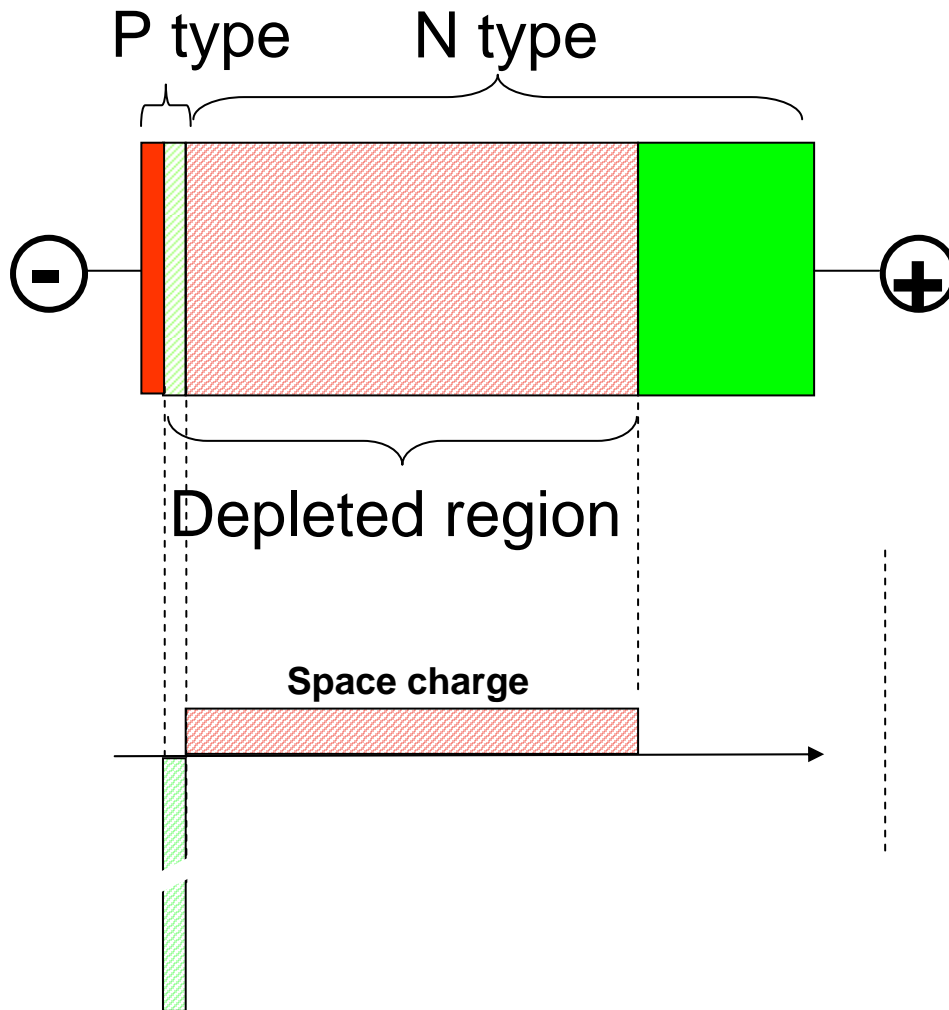
The Concept of Semiconductor Drift Detector

History of the development

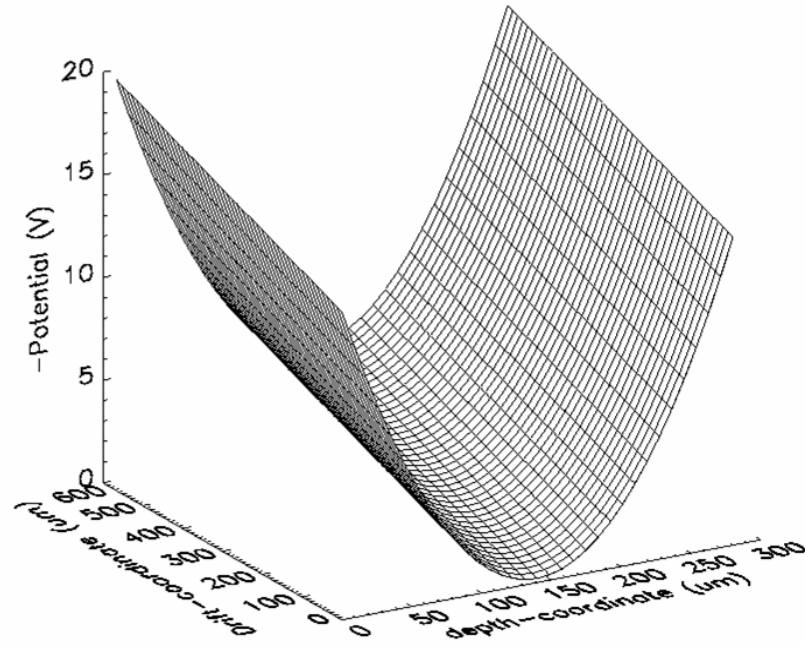
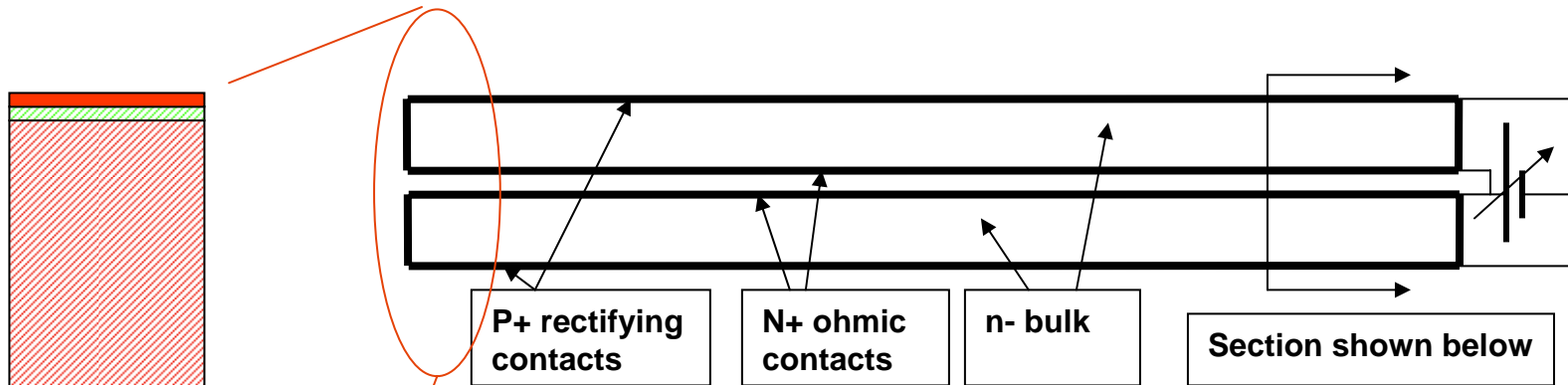
Transport of charged carriers in thin fully depleted semiconductor detectors in direction parallel to the large surface of the detector.



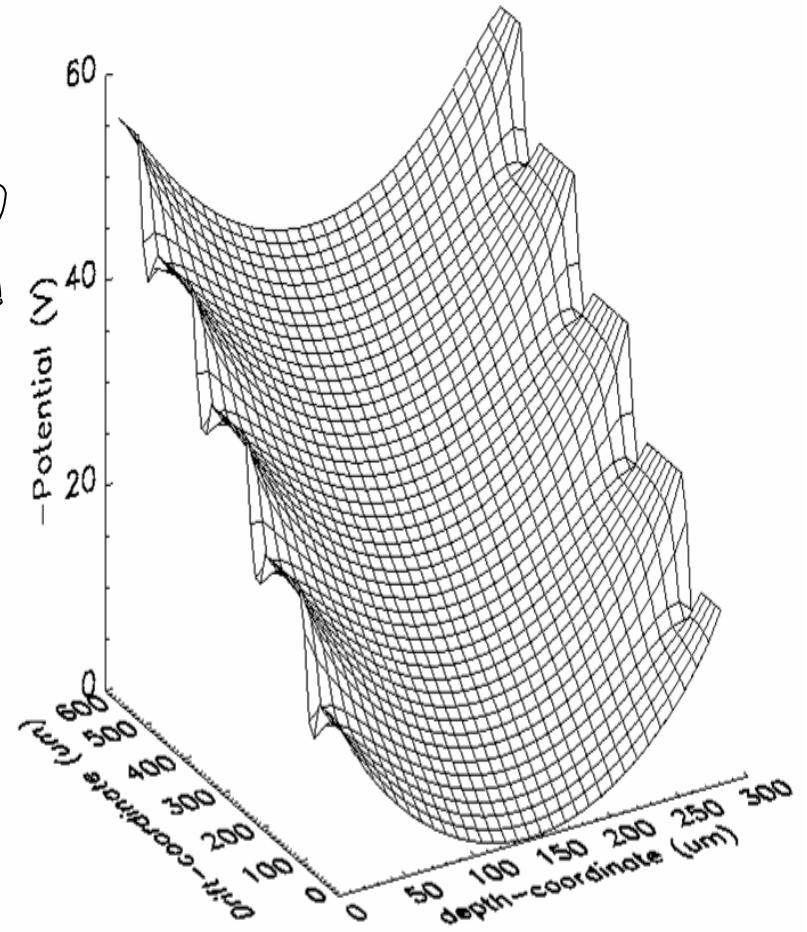
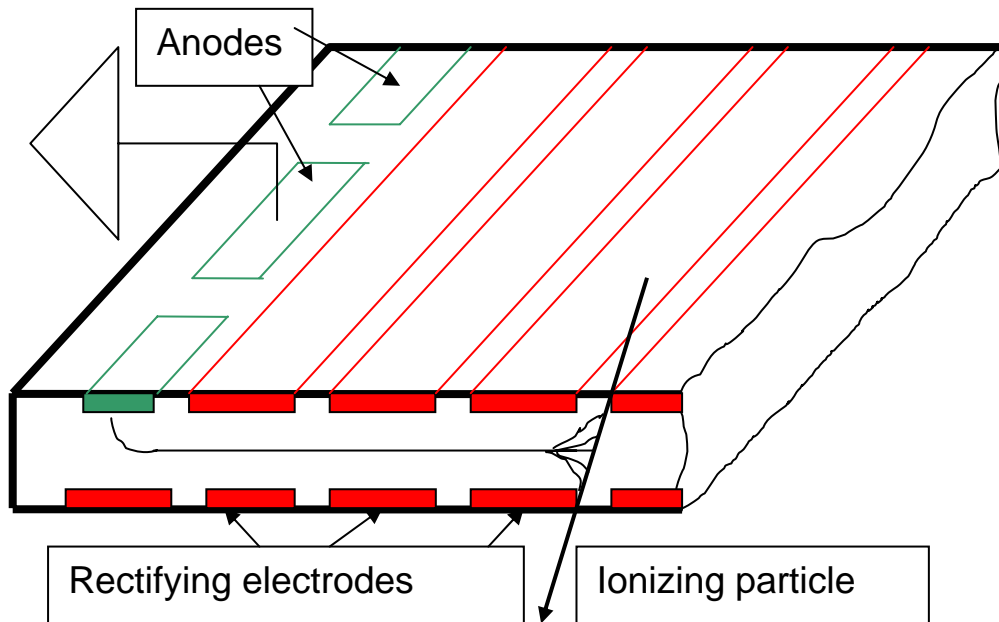
Reverse-biased one sided step p-n junction in 1 dimension



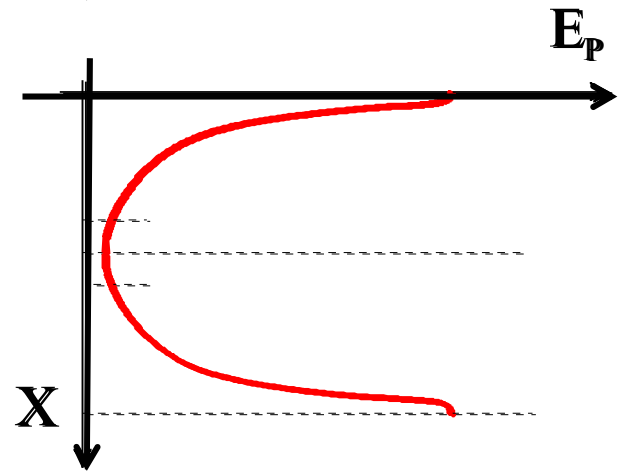
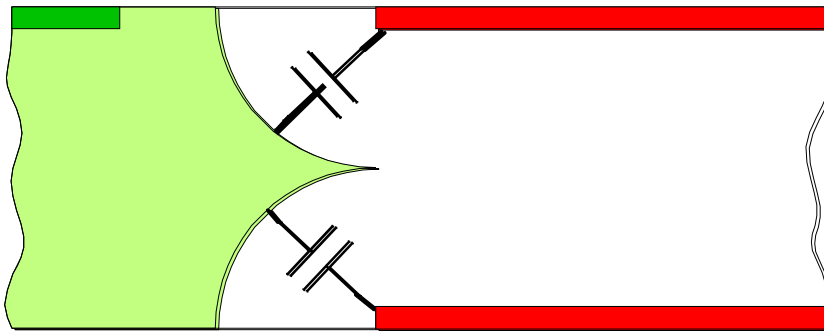
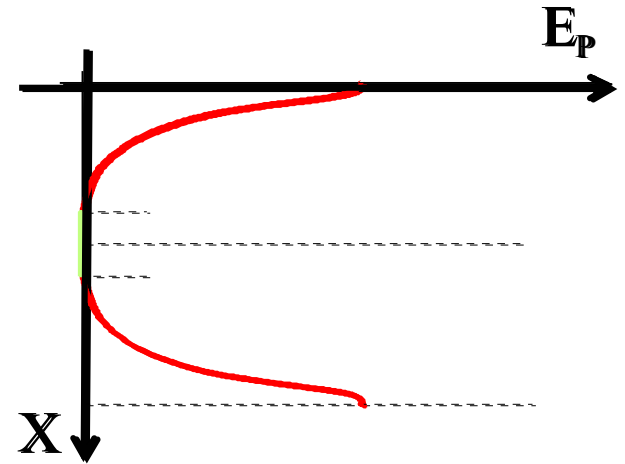
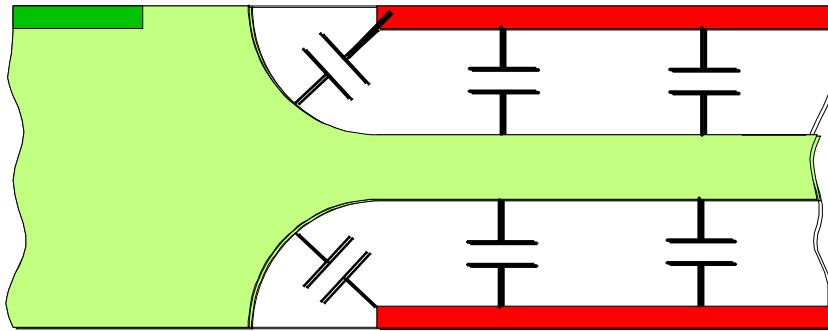
Depletion from two sides



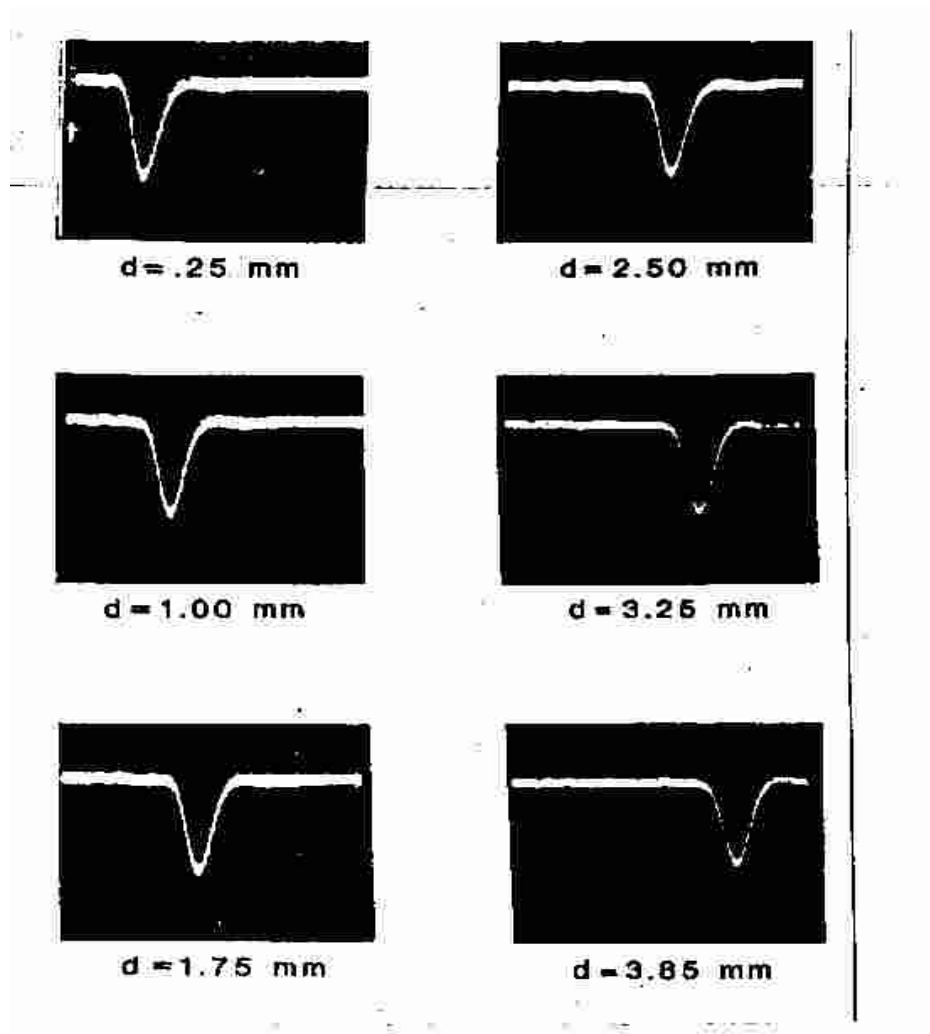
SDD principle



Low capacitance anode

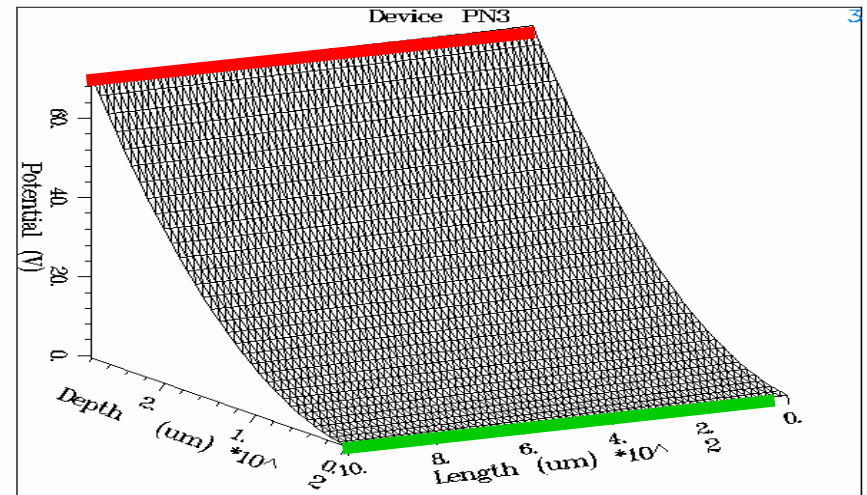
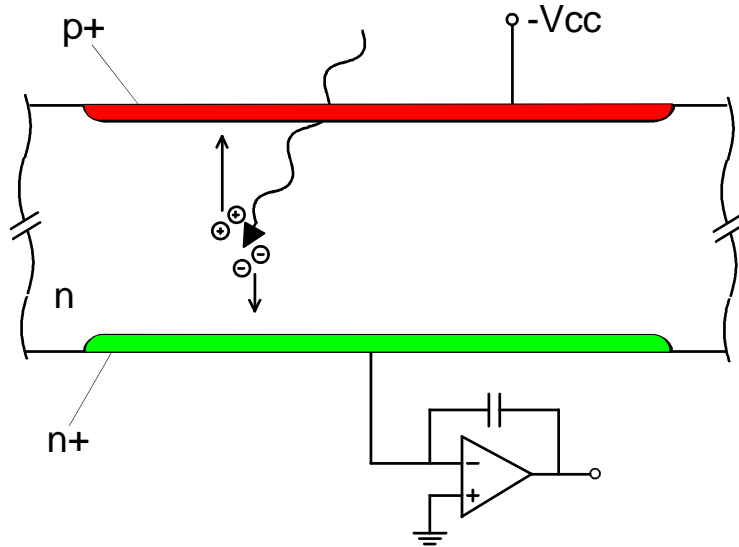


The first signals from a SDD



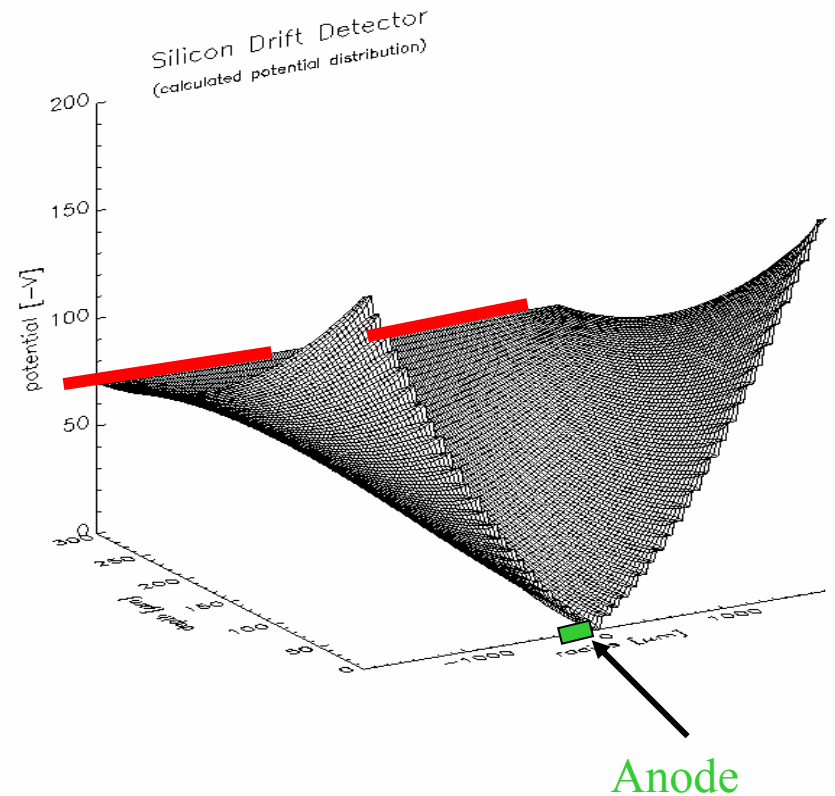
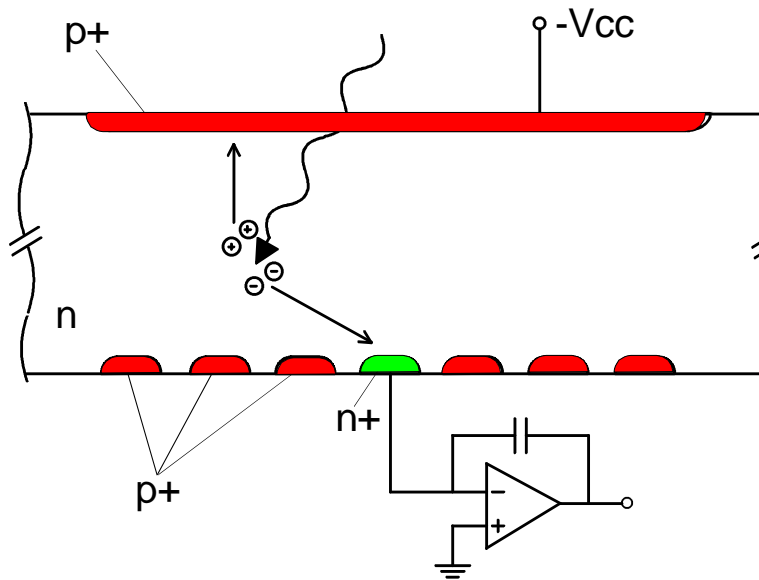
BWL, 1983

The classical PIN diode detector



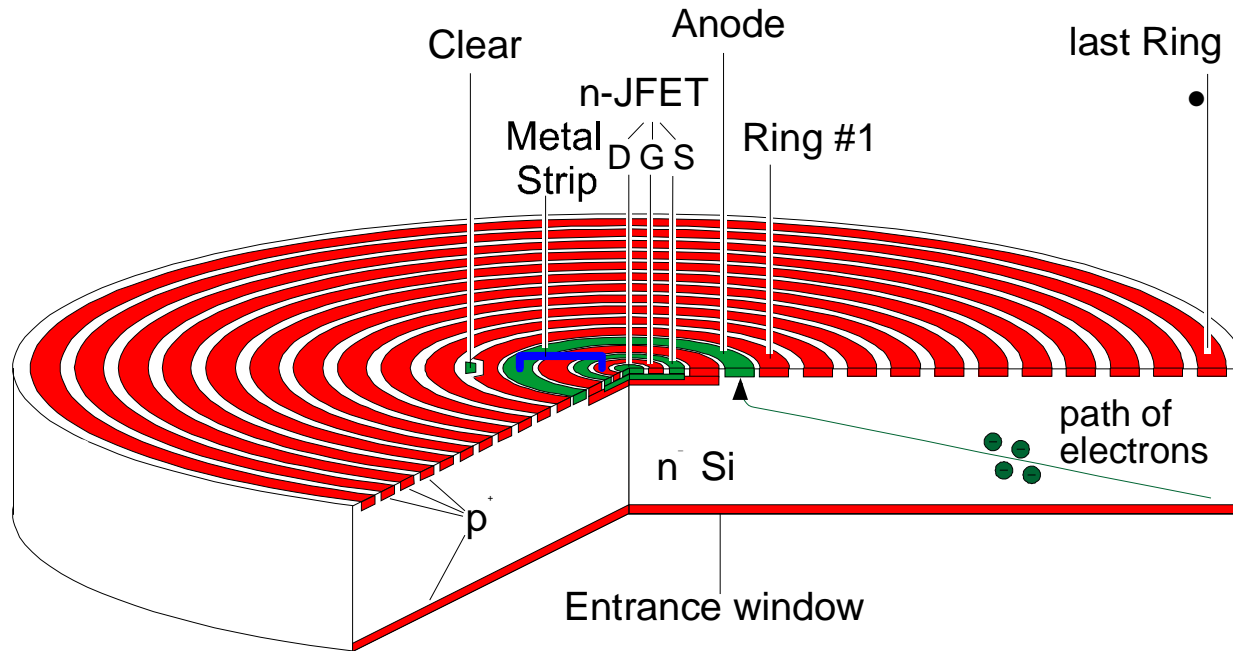
The anode capacitance is proportional to the detector active area

The SDD for X-ray spectroscopy



The electrons are collected by the small anode, characterised by a **low output capacitance** which is **independent on the active area of the detector**.

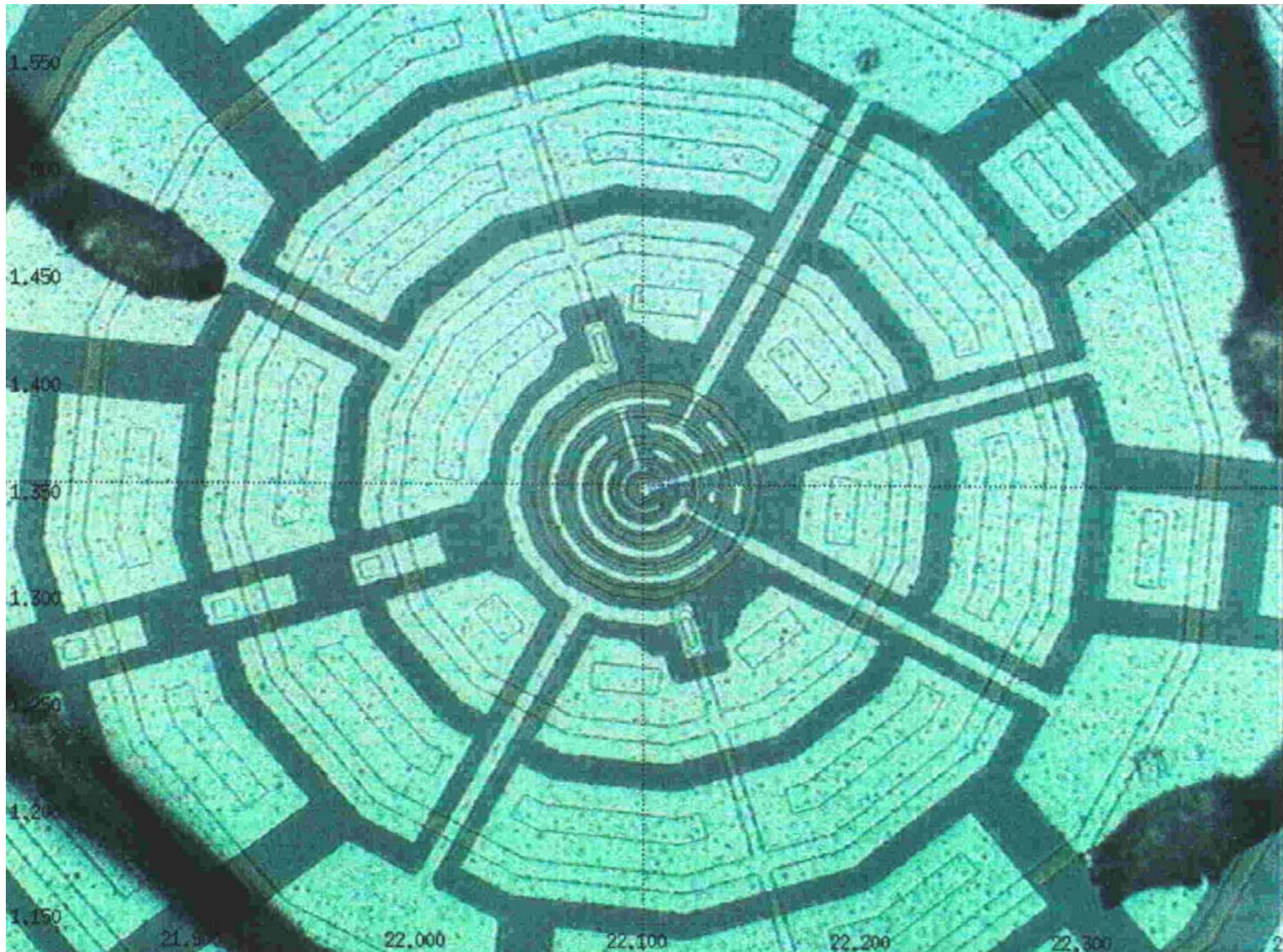
The SDD structure



The electrons, generated in the fully depleted silicon by the X-ray photons, are collected by the small anode (having a very low capacitance, $C_{det}=150\text{fF}$). The integrated front-end transistor ($n\text{-JFET}$) allows the capacitive matching between detector and amplifier ($C_{det}\approx C_{gate}$)

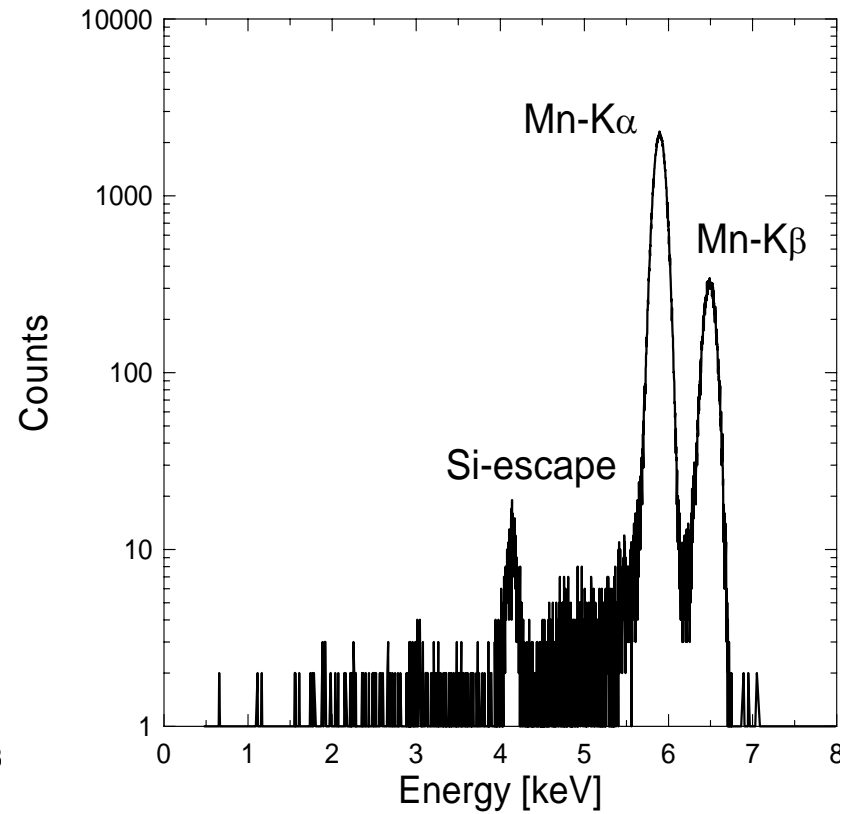
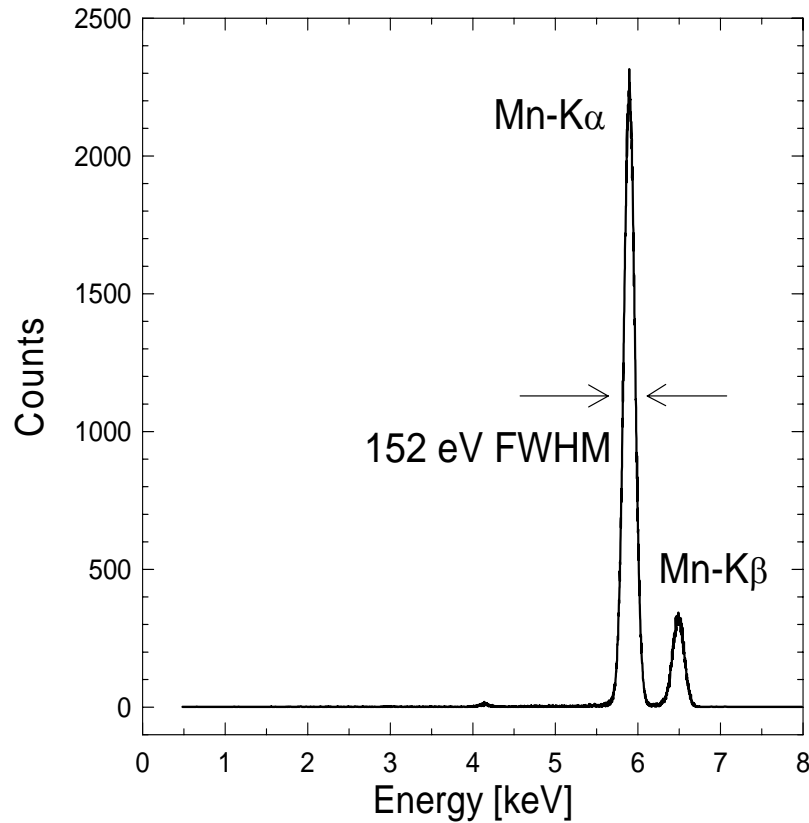
Advantages: very high energy resolution at fast shaping times, due to the small anode capacitance, independent of the active area of the detector

The integrated JFET



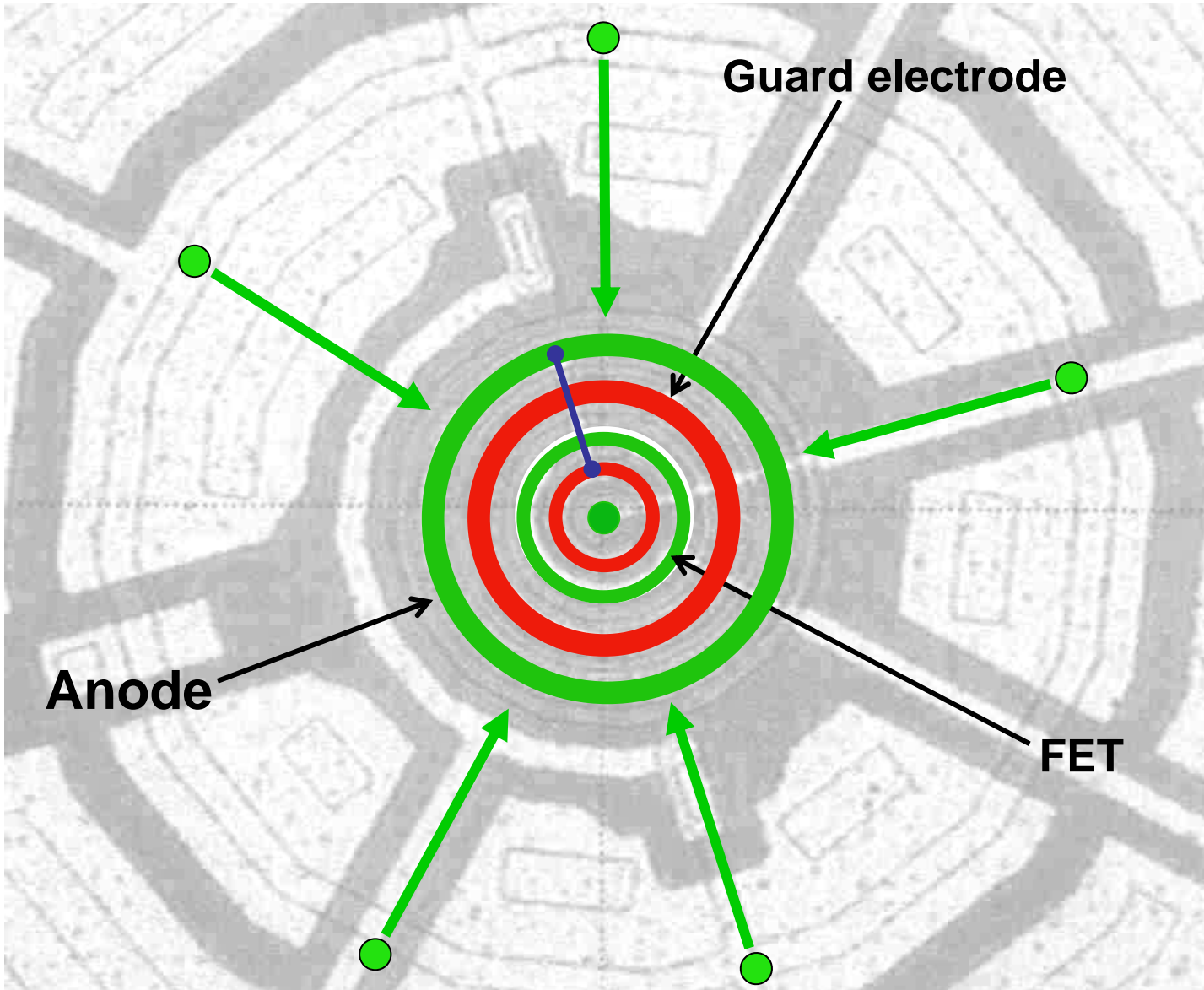
Detector produced at the MPI Halbleiterlabor, Munich, Germany

SDD performances

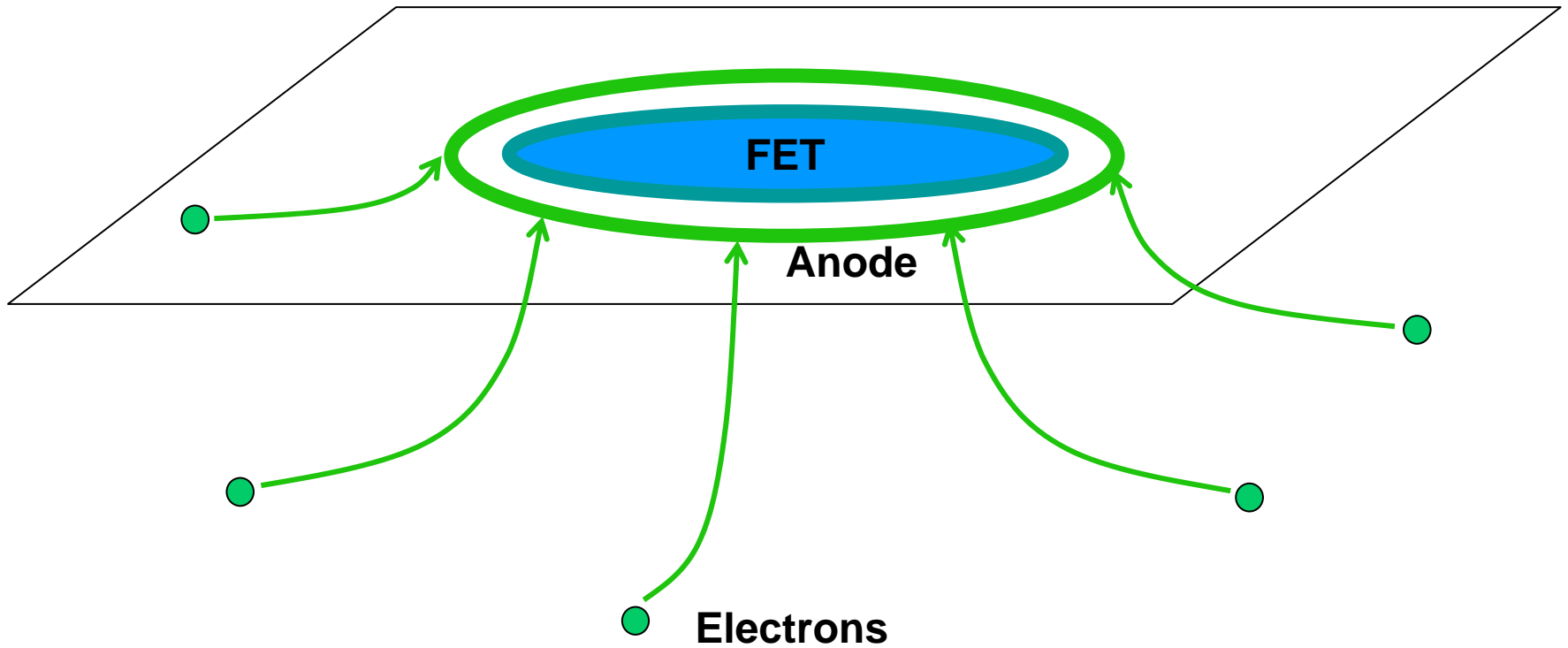


- ^{55}Fe spectrum measured with the SDD module at $T = -8^\circ\text{C}$ and a shaping time of $0.5 \mu\text{s}$.

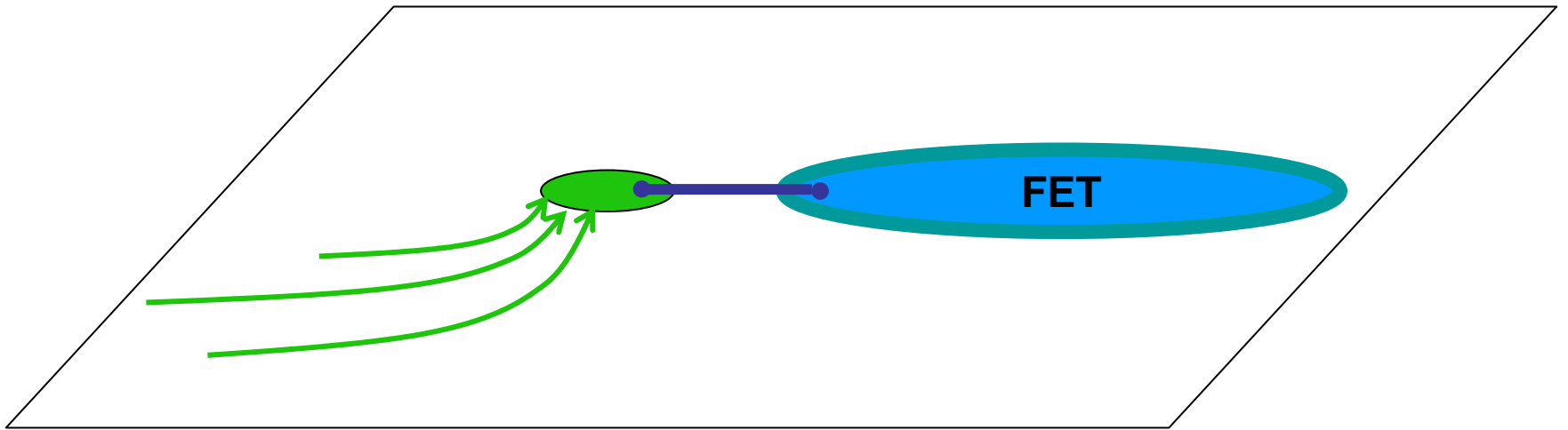
The integrated JFET



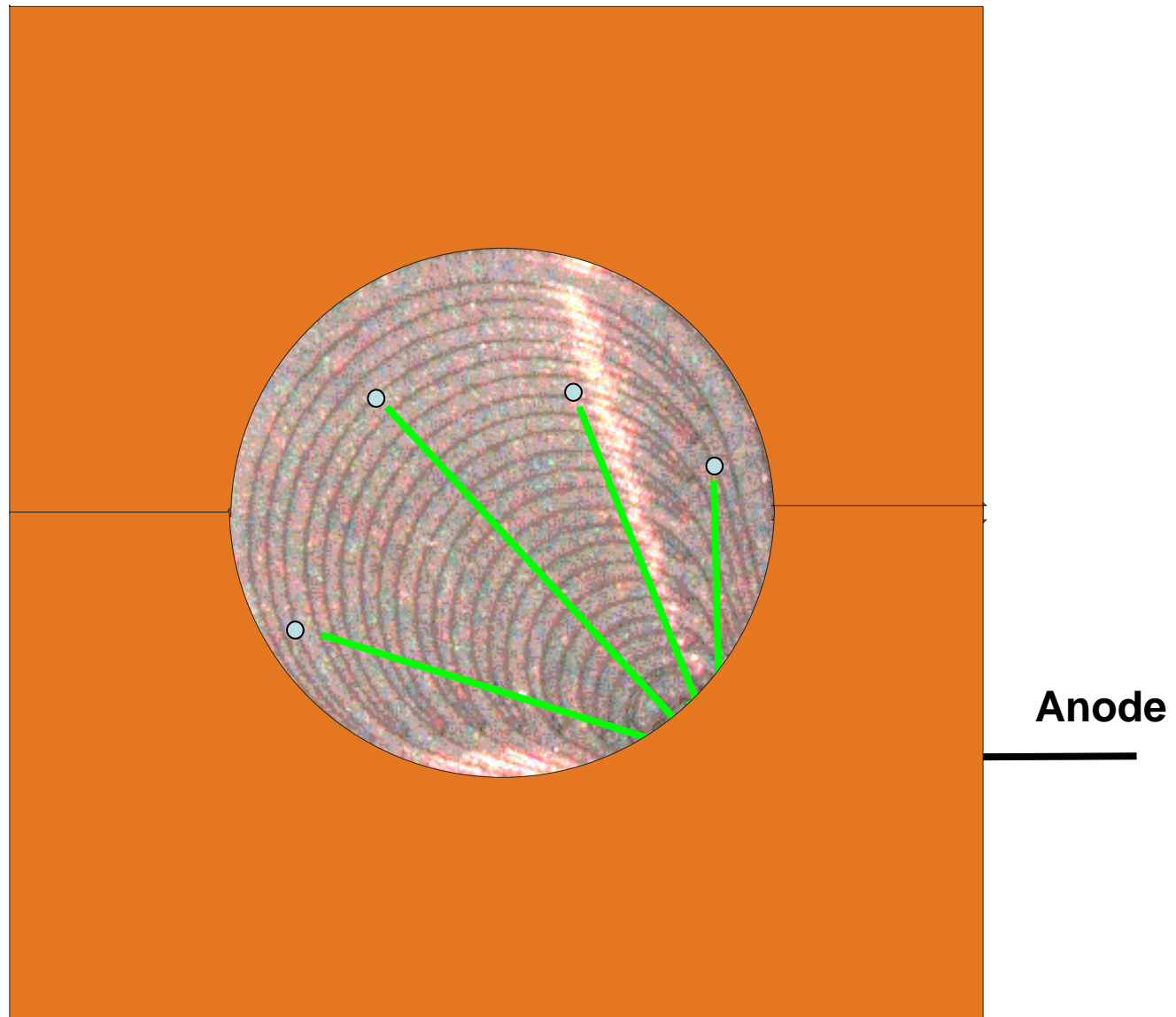
The “conventional” central anode containing the FET

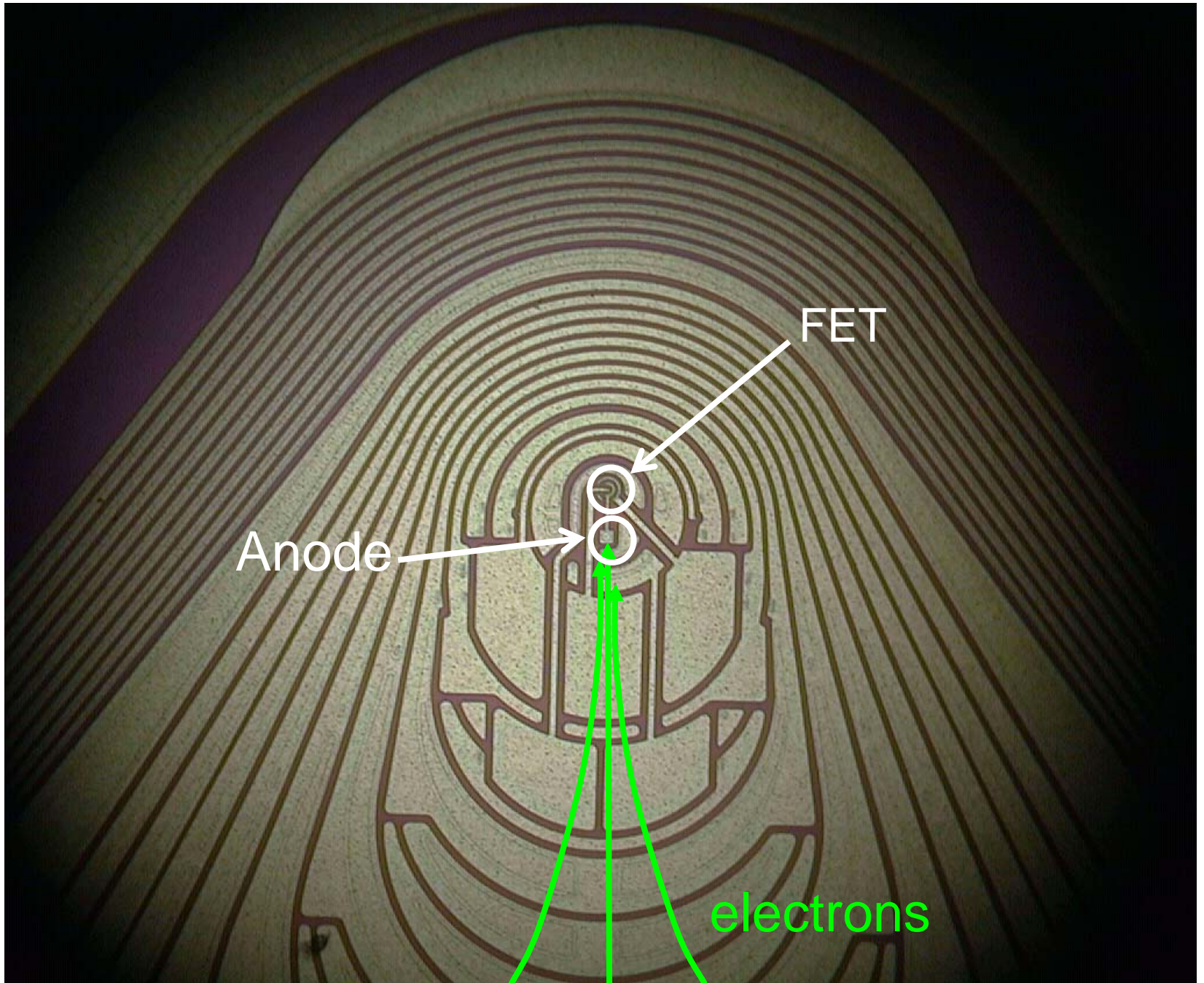


The “lateral” anode with side FET



The new Silicon Drift Detector Droplet (SD³)





The resolution of the new SD³

STANDARD SDD

Anode capacitance = 150 fF

FWHM= 150 eV (typ)

at T= -10°C

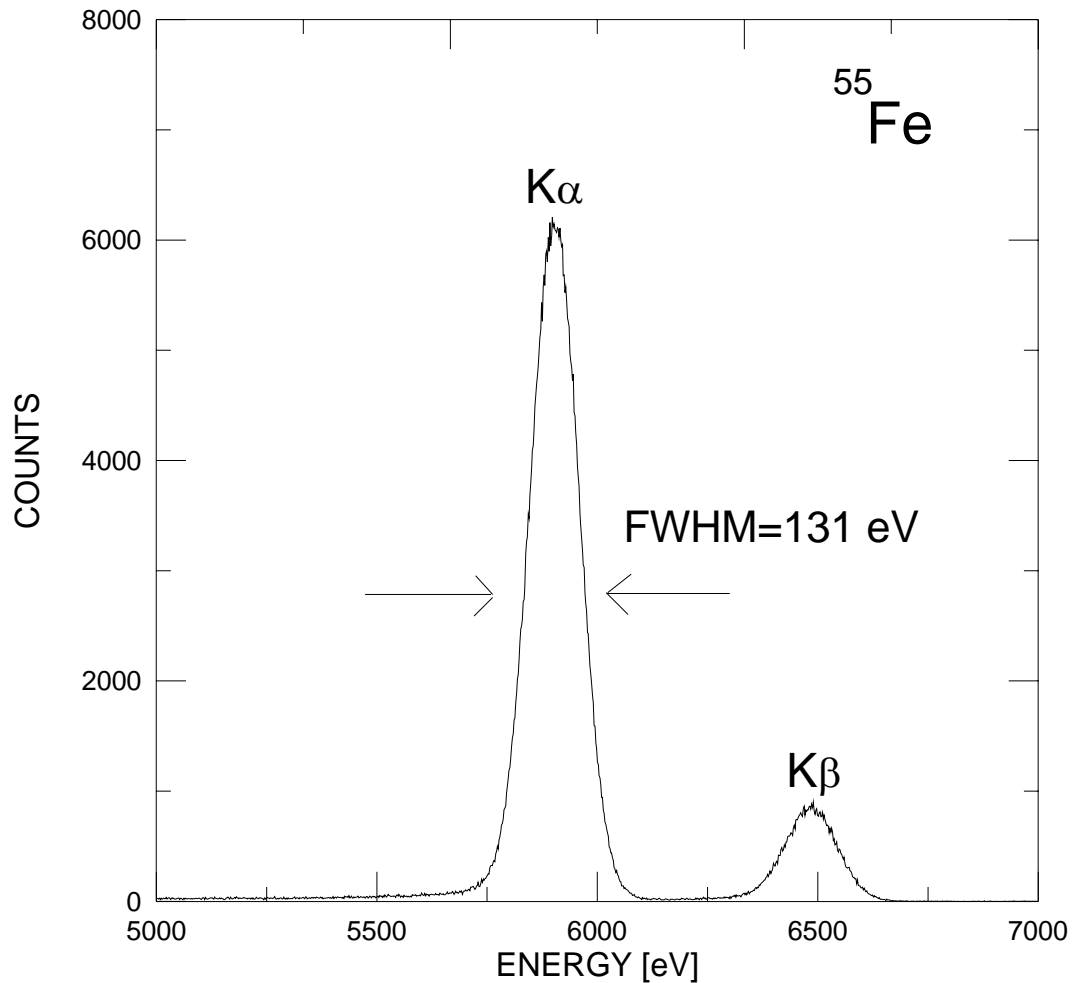
DROPLET SDD

Anode capacitance = 50 fF

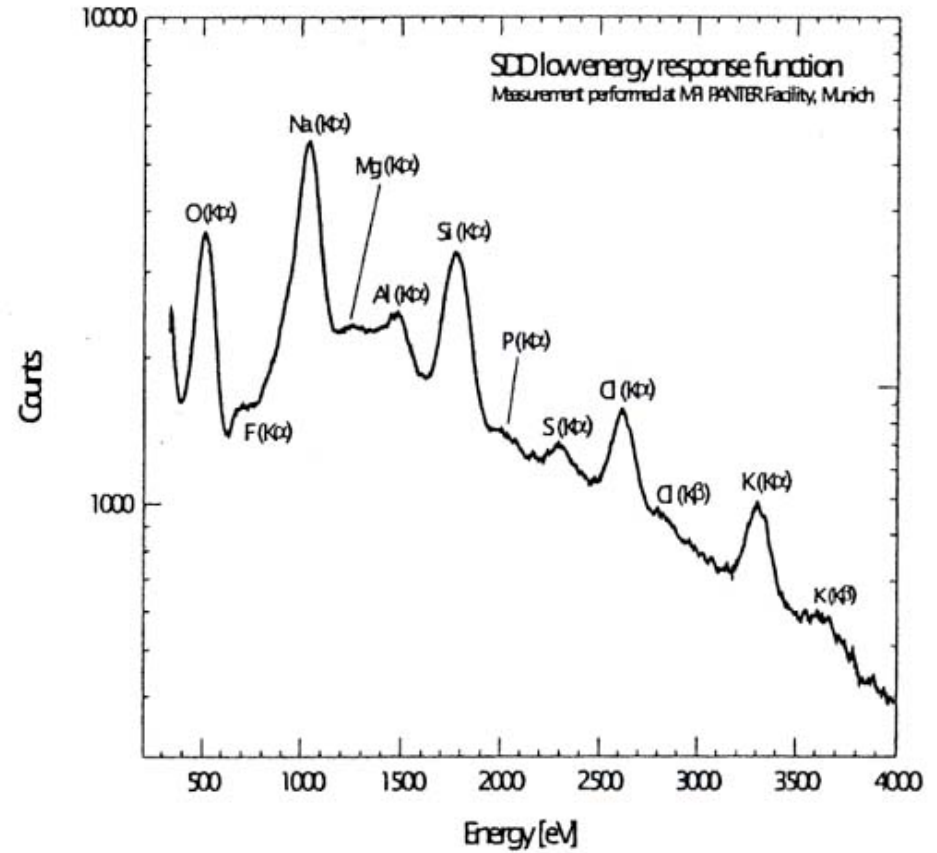
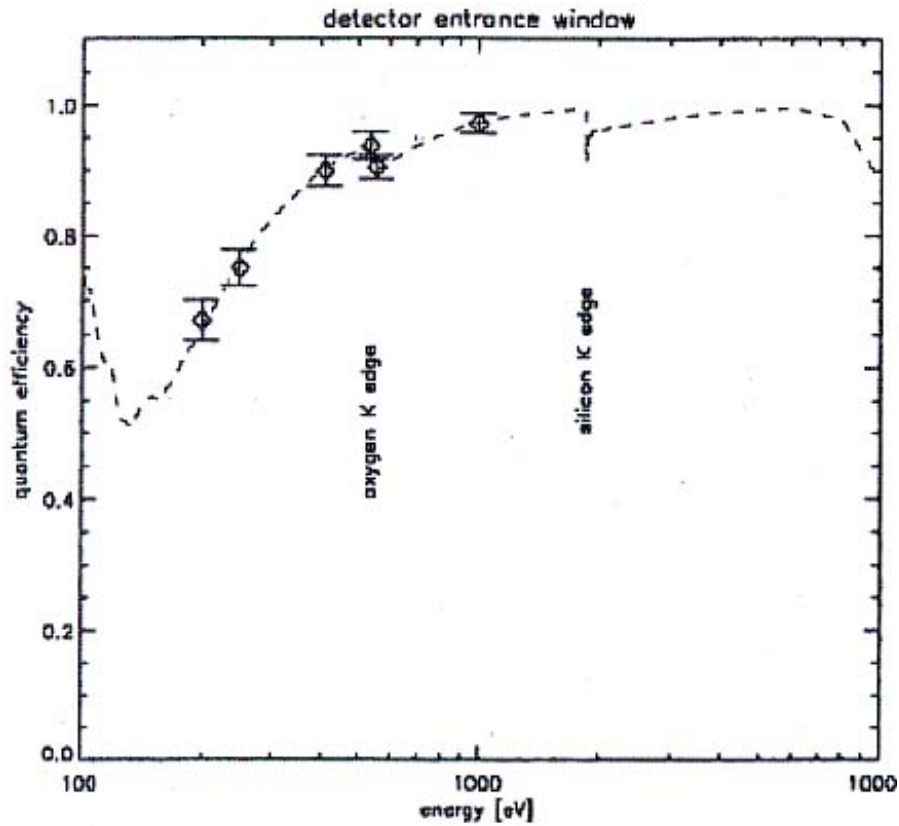
FWHM= 130 eV (typ)

at T= -20°C

Peak/Background > 5000

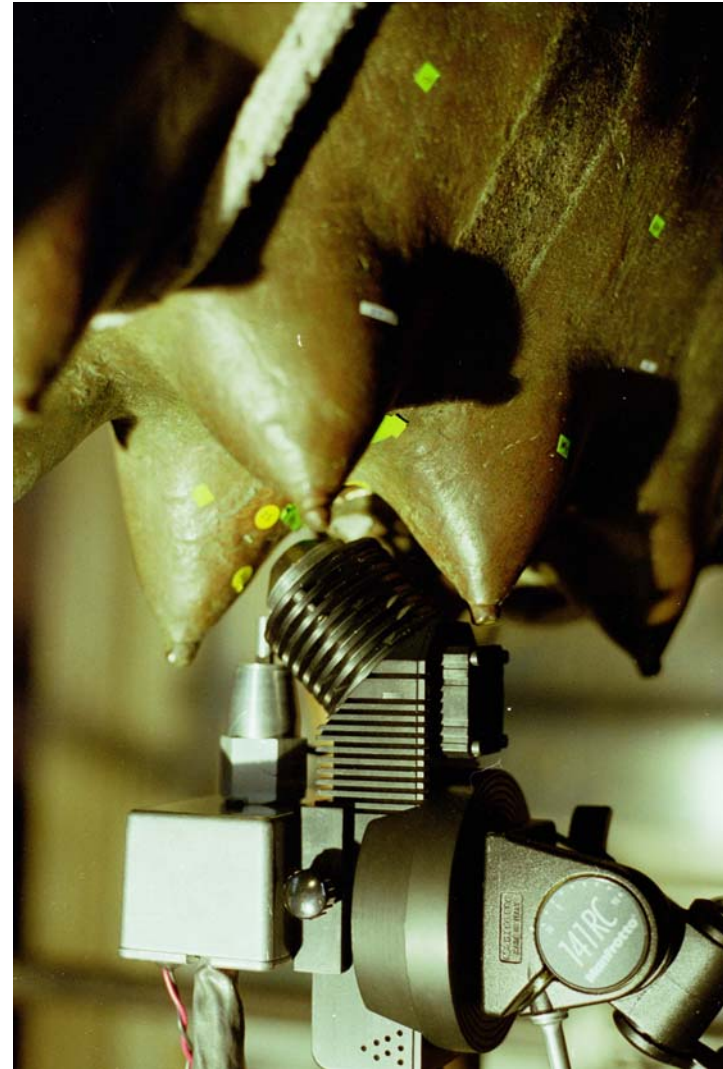


Performances with soft X-ray



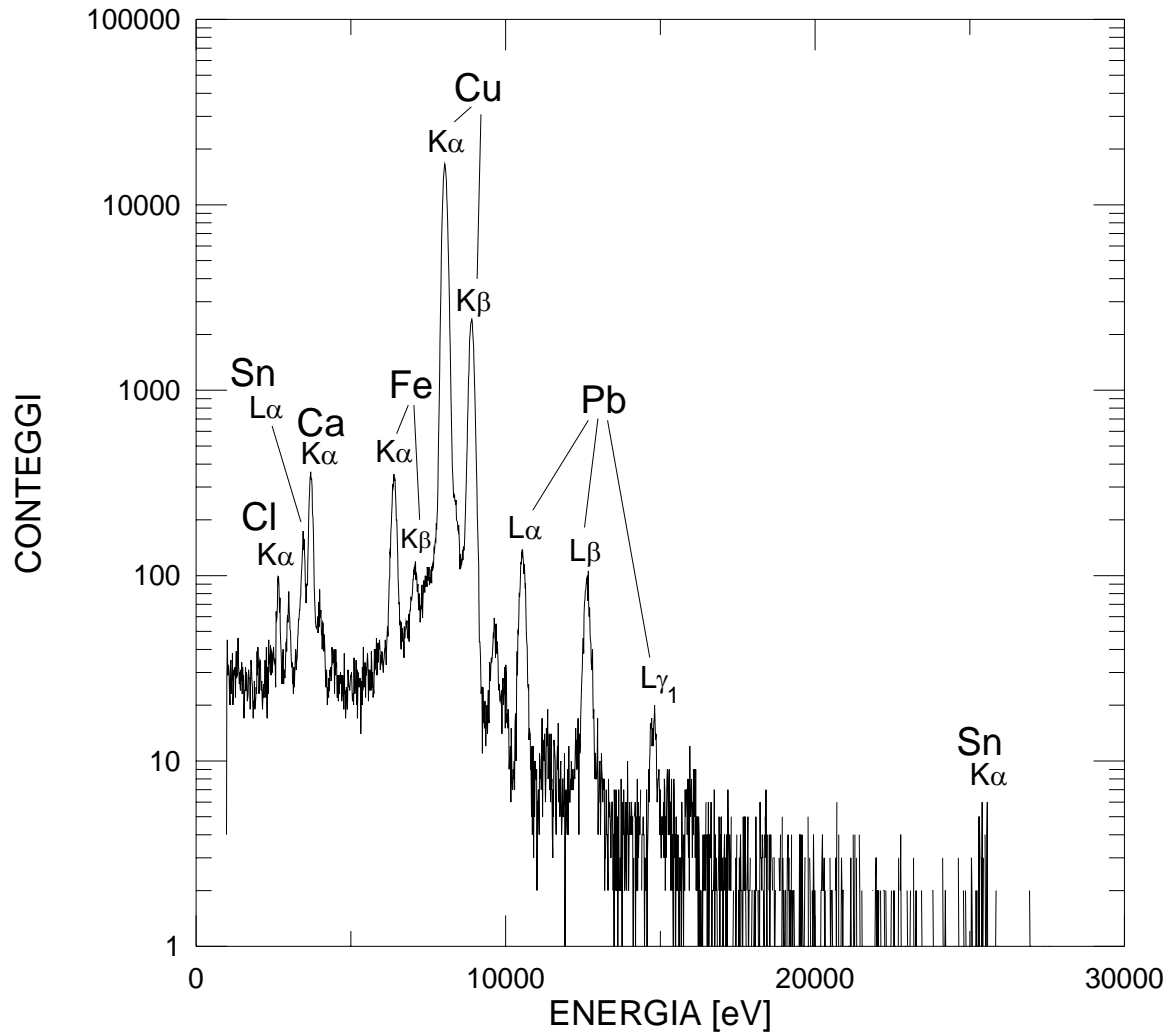
**Some applications of the
single-element SDDs
in X-ray spectroscopy**

Analysis of the alloy composition of the 'Lupa Capitolina'

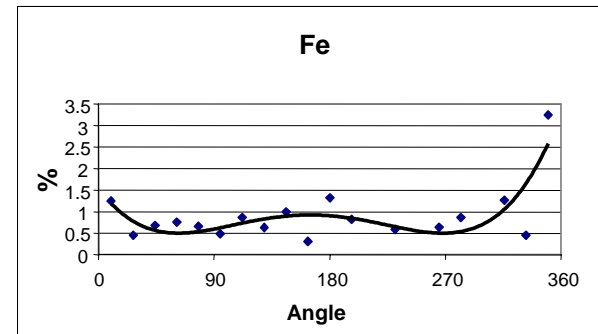
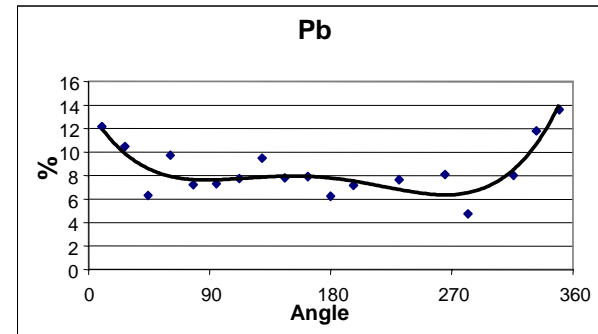
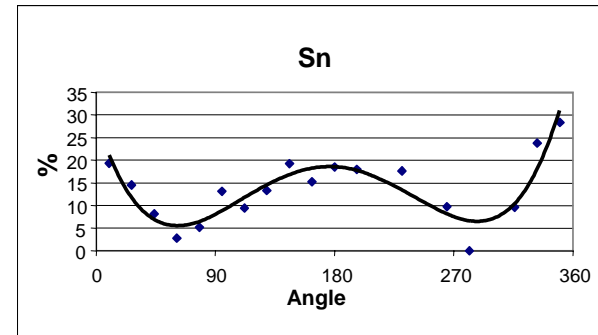
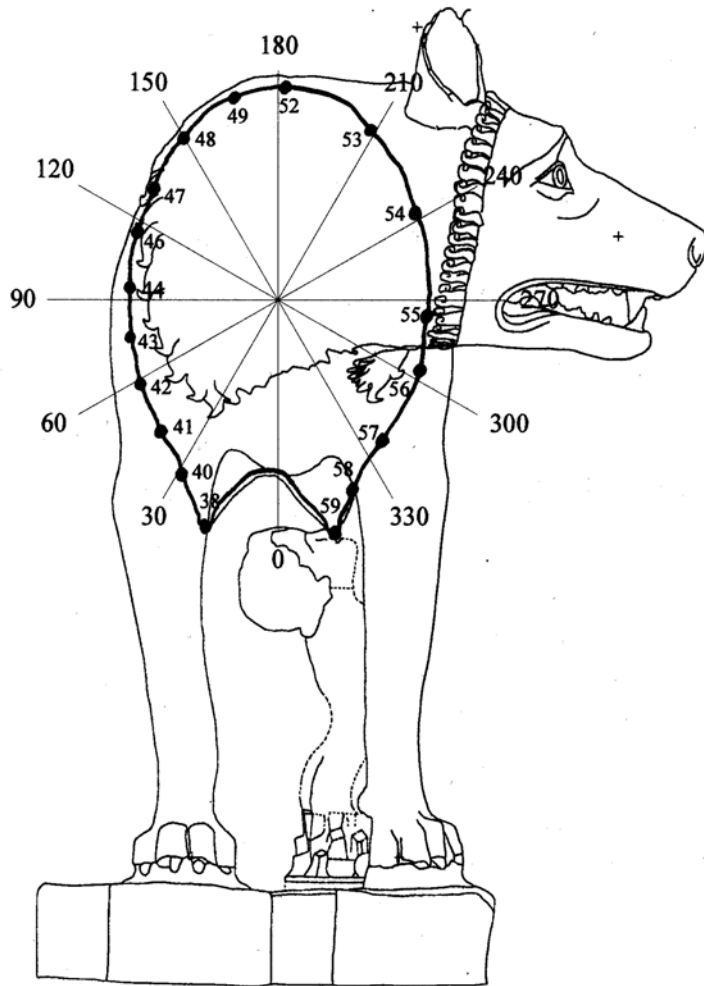


Musei Capitolini, Roma

XRF spectrum of the bronze alloy of the 'Lupa'



Element distribution on the 'Lupa' body

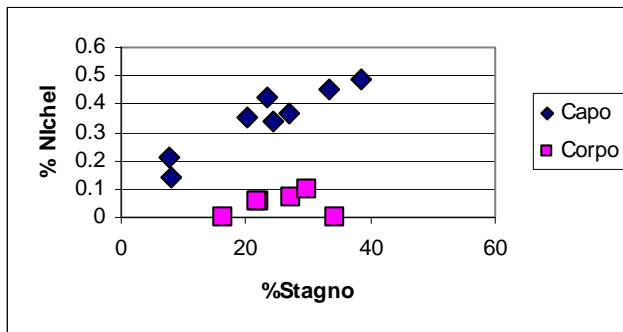
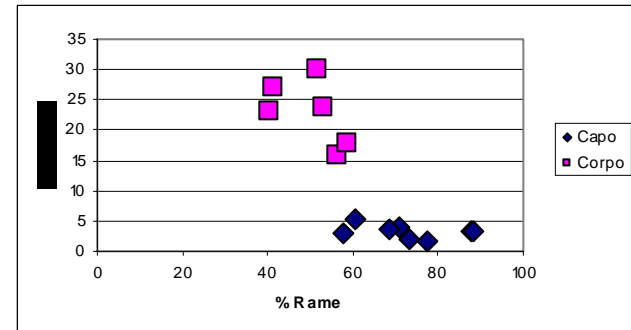
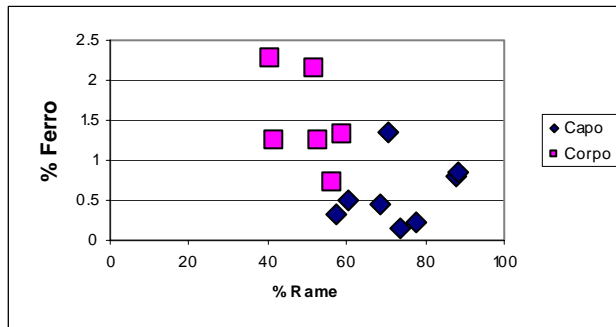
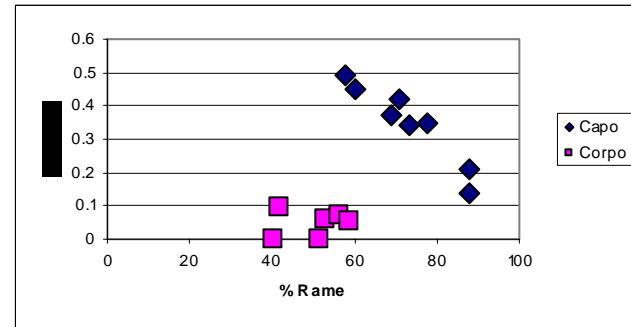
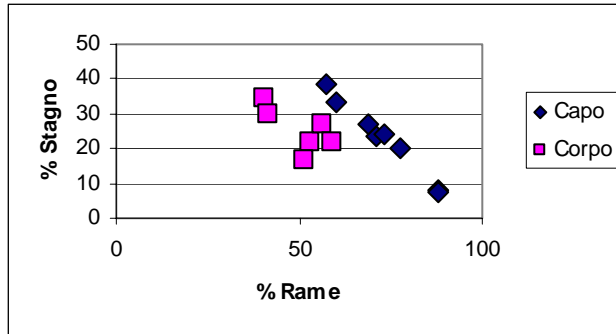


Analysis of the alloy composition of the “Spinario”



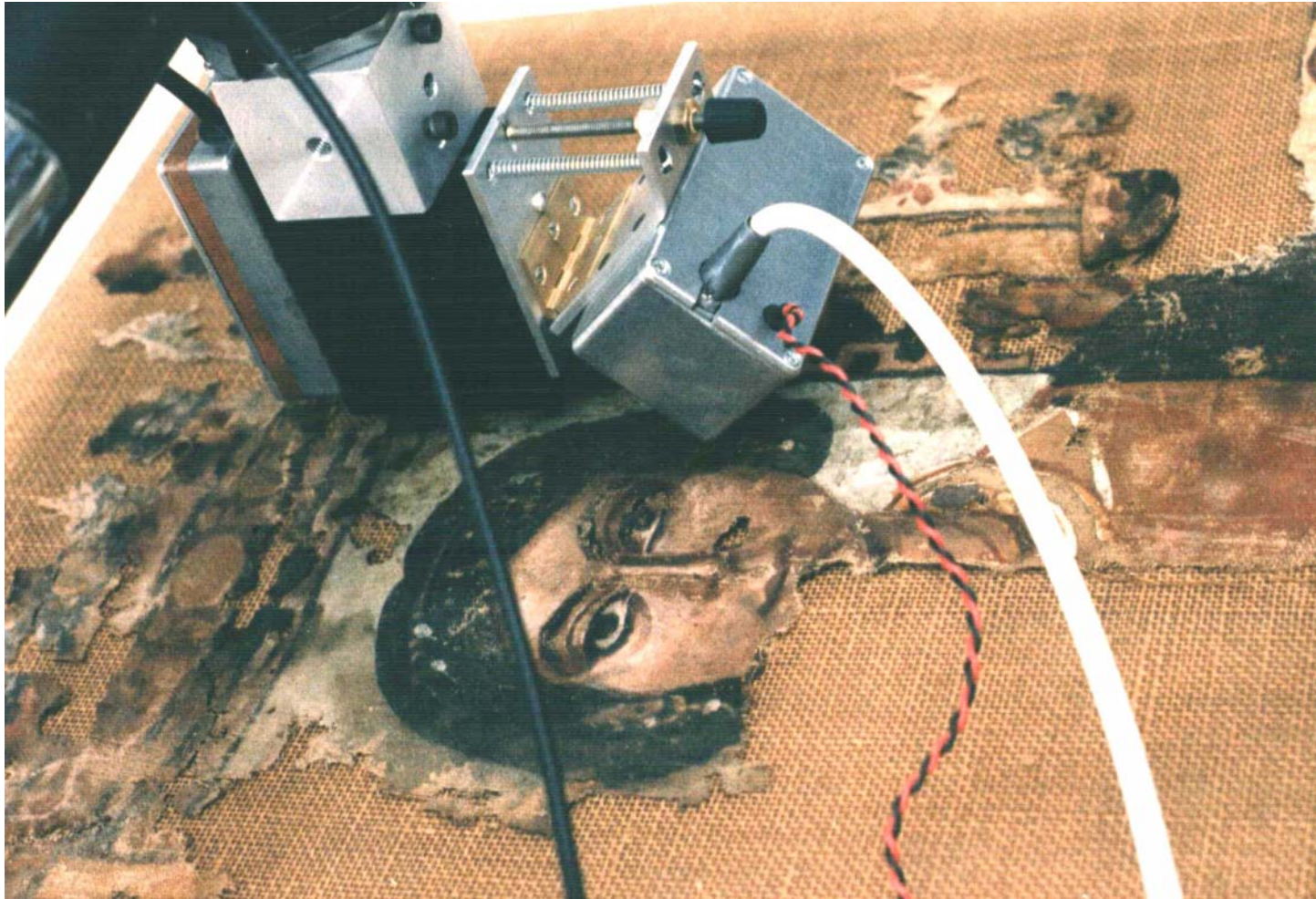
Musei Capitolini, Roma

Analysis of a bronze roman sculpture

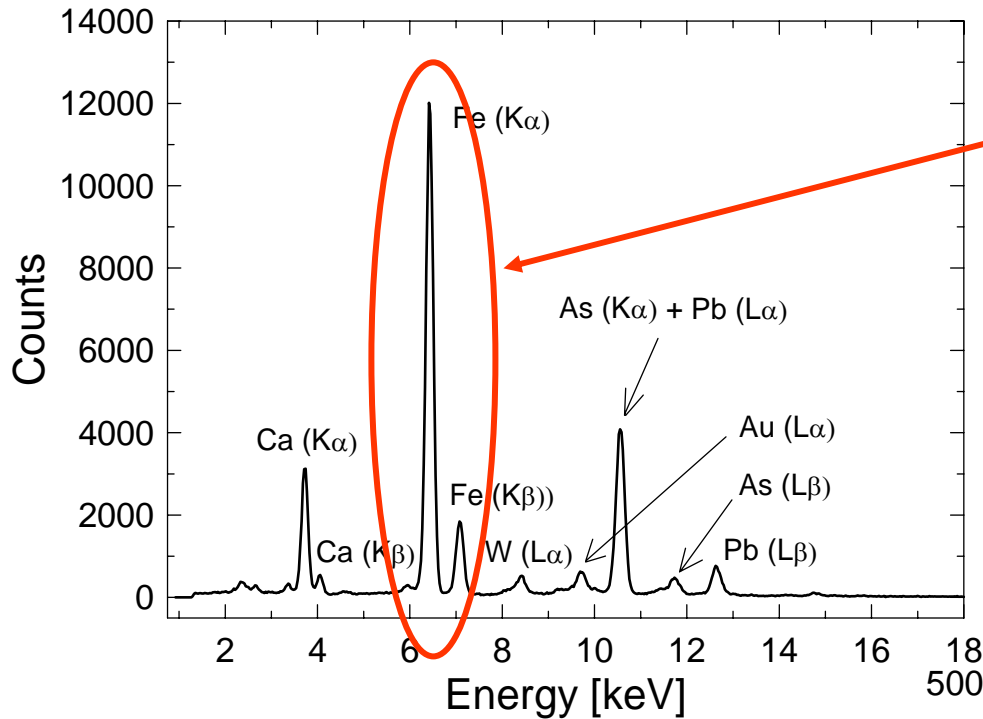


Correlation diagrams of the bronze composition of several points of the head and of the body of the sculpture, showing that the two parts have been produced with different fusion (maybe in a different historical period). The last diagram shows that Ni has been probably introduced as impurity of Sn.

Analysis of an Egyptian Linen (Antinopolis, III century A.C.)



Museo Vaticano, Roma



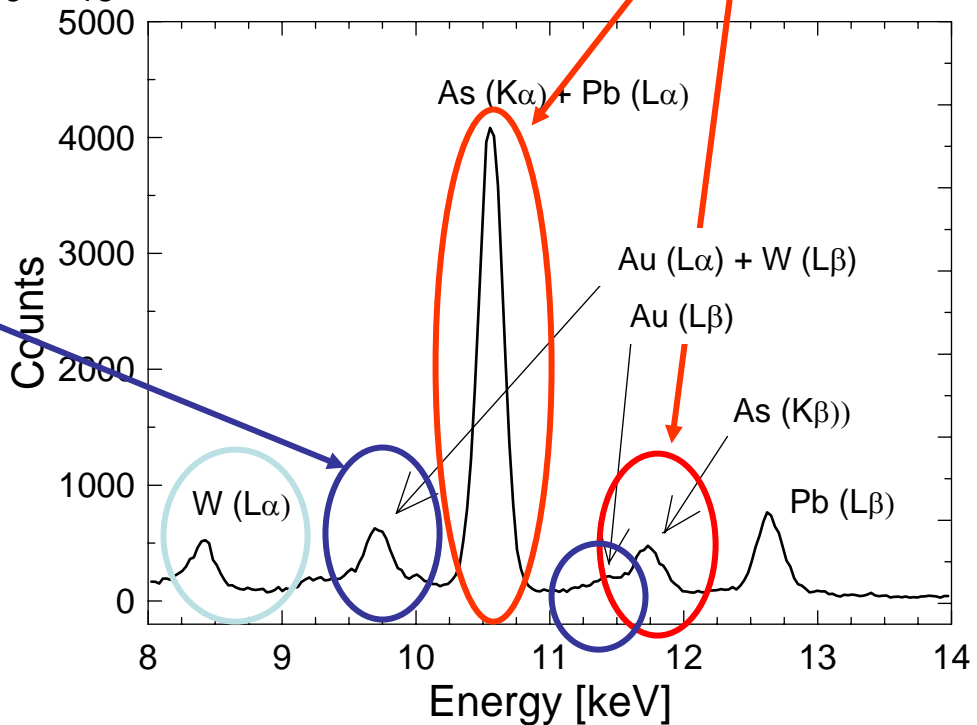
Yellow ochre $\text{Fe}(\text{OH})_3$

Orpiment As_2S_3

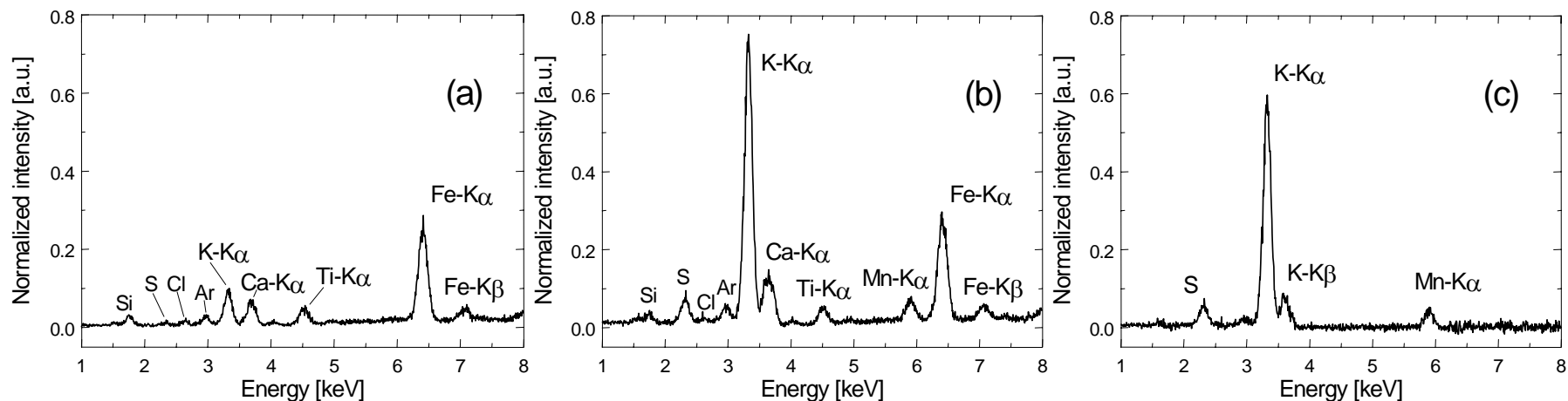
Analysis of the earring

It can not be **only** W because
 $\text{W L}\alpha / \text{W L}\beta$ should be ≈ 1

Gold Au



Authenticity verification

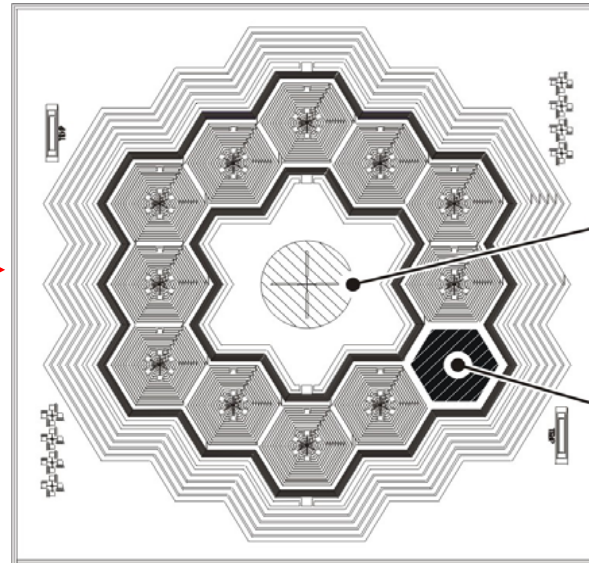


Fluorescence spectra of a document in a reference point (a) and in a point where stain remover was supposed to be applied (b) (the spectra are normalized with respect to the Ti-K α line). In (c) the difference between the two spectra (a) and (b) is reported, revealing a probable application of a conventional stain remover containing S, K, and Mn.

Multi-element SDDs

The 12-element SDD detector

“Front” Side
collecting anode,
JFET,
Basing electrodes

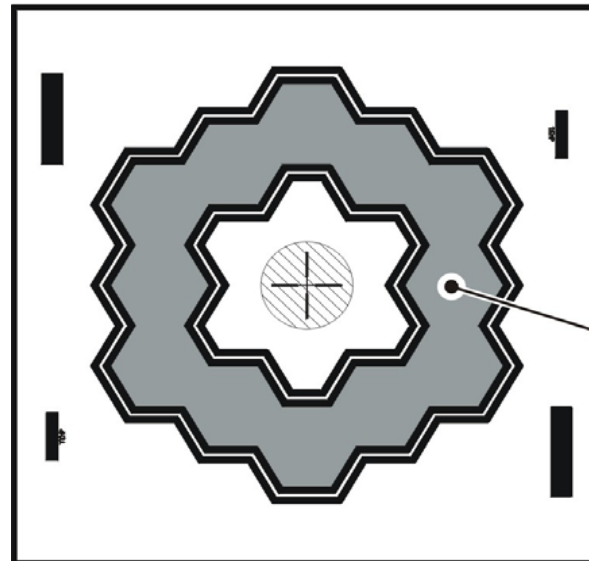


Center hole
2.4 mm

SDD cell
5 mm²

Detector thickness 300 μm

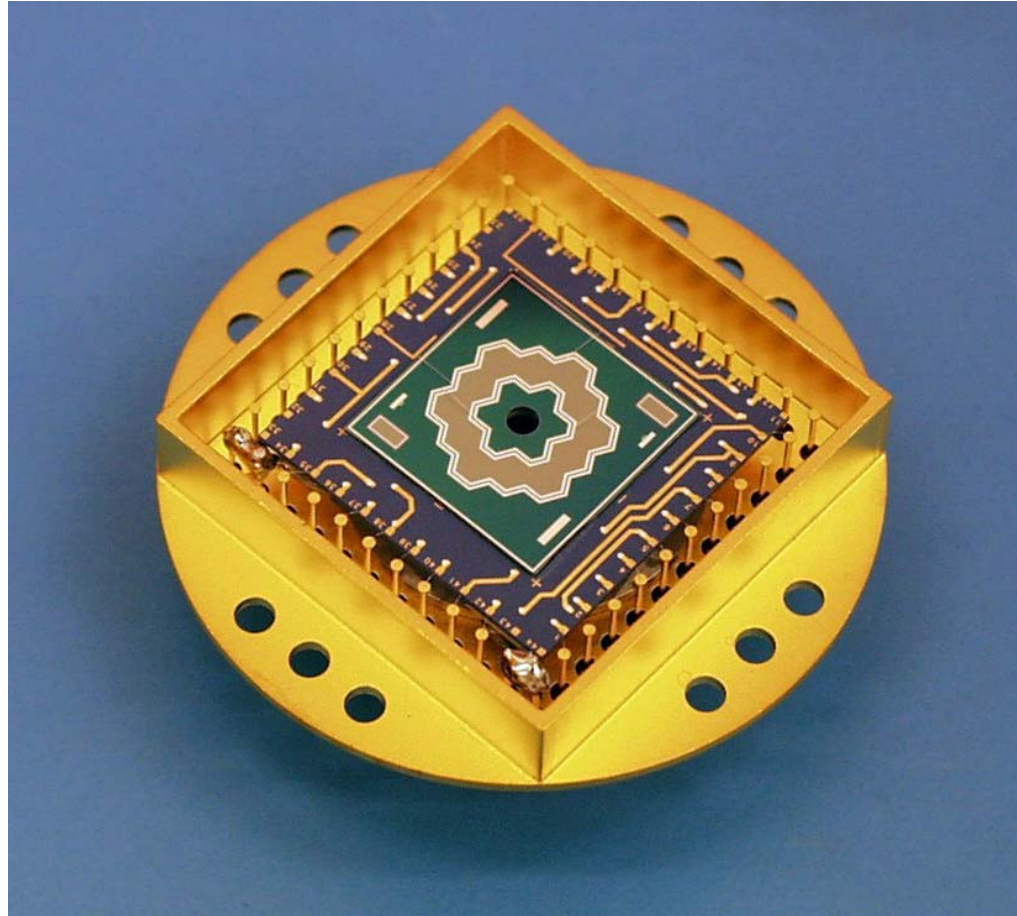
“Back” Side
non-structured
radiation
entrance window.



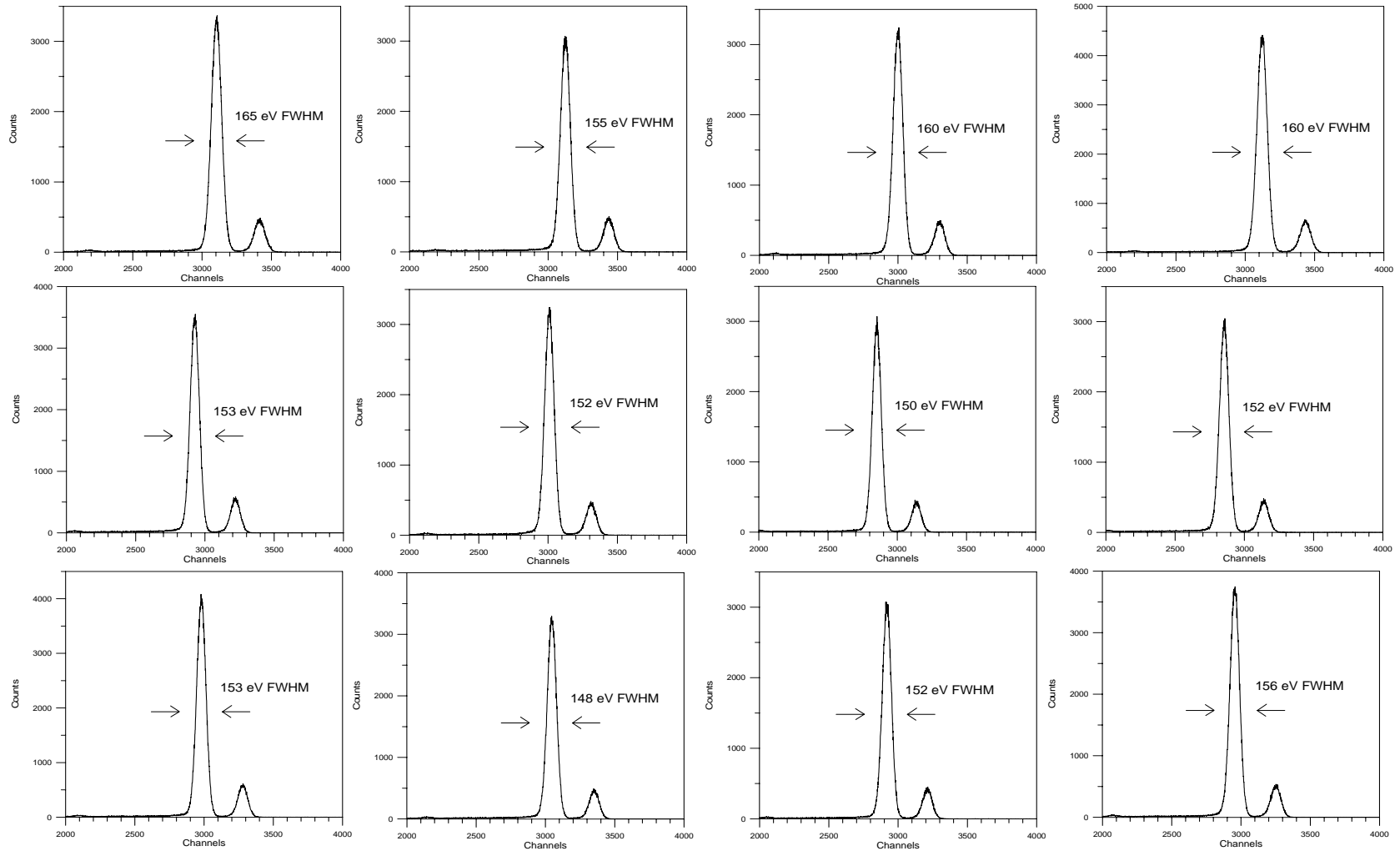
Detector chip
17x17 mm²

Sensitive area
12x5 mm²
= 60mm²

The 12-element SDD detector

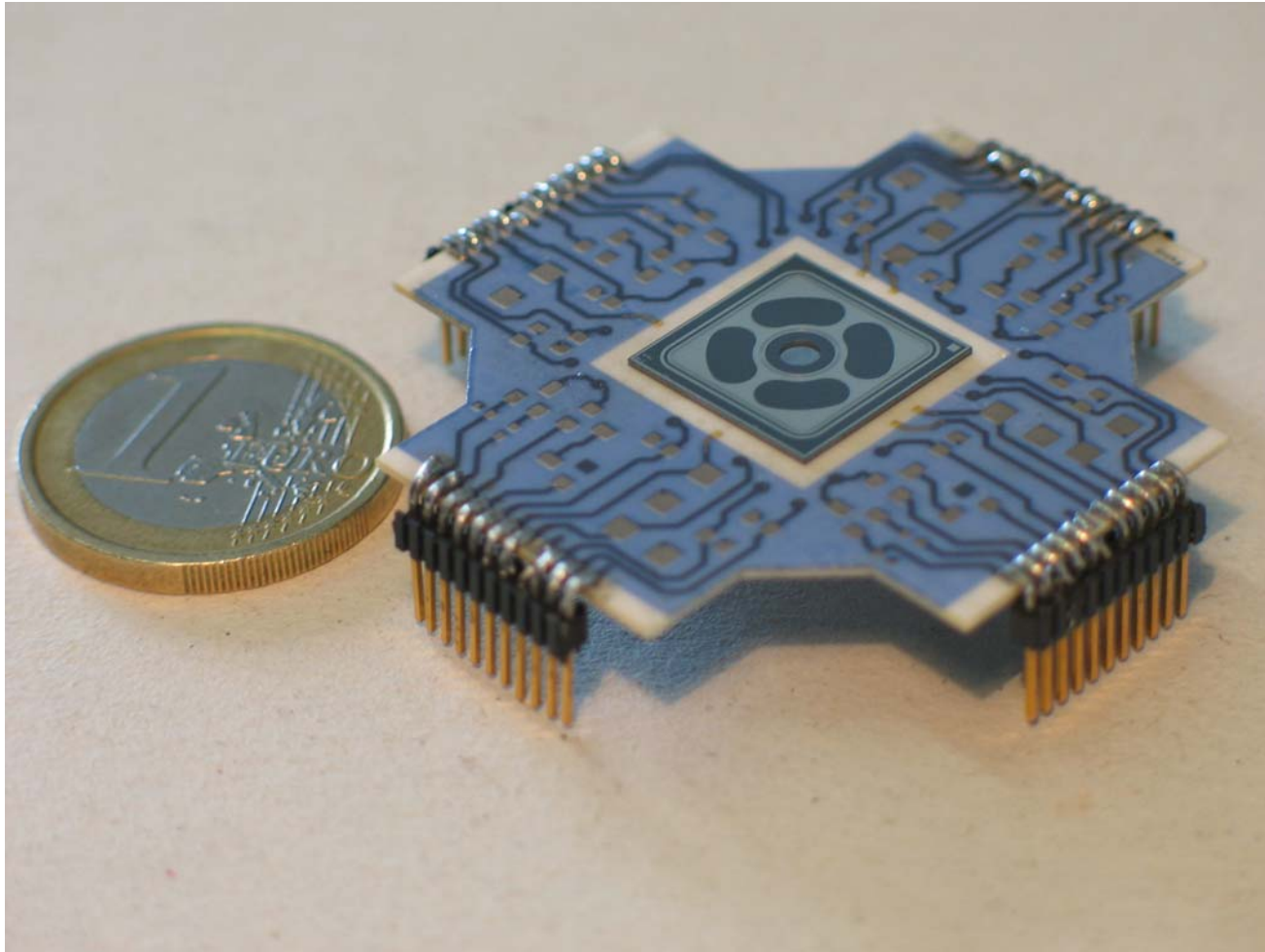


Detector performances



^{55}Fe radioactive source – $T = -10\text{ }^{\circ}\text{C}$ – Tennelec TC244 gaussian shaping amplifier $\tau_{\text{sh}} = 0.5\text{ }\mu\text{s}$
Count rate $\approx 10\text{ kcps / channel}$. Average FWHM: 154.7 eV

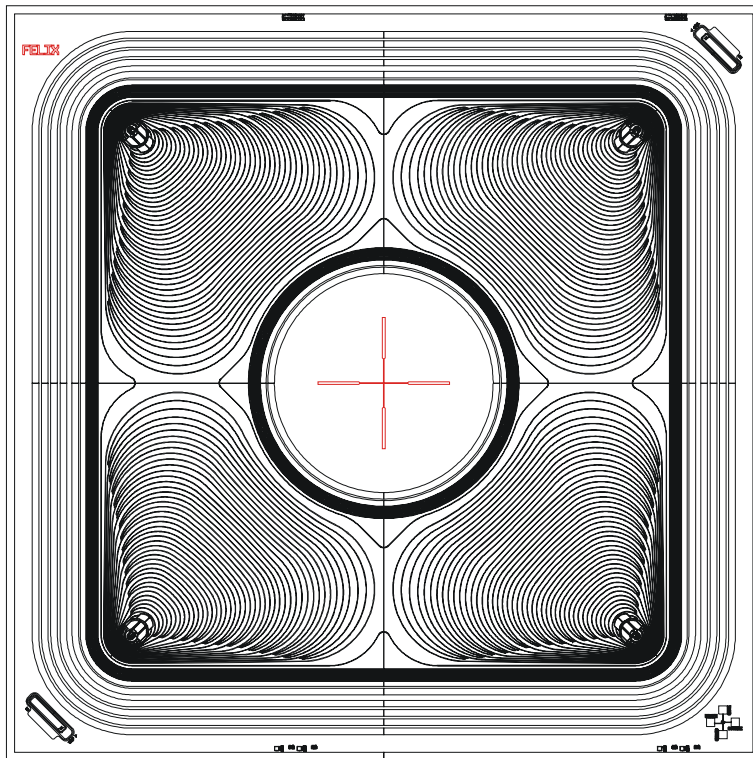
A new multi-element Semiconductor Shift Detector optimized for XRF Elemental Mapping



Project FELIX INFN Gr.5 2003-04

A new multi-element Semiconductor Sift Detector optimized for XRF Elemental Mapping

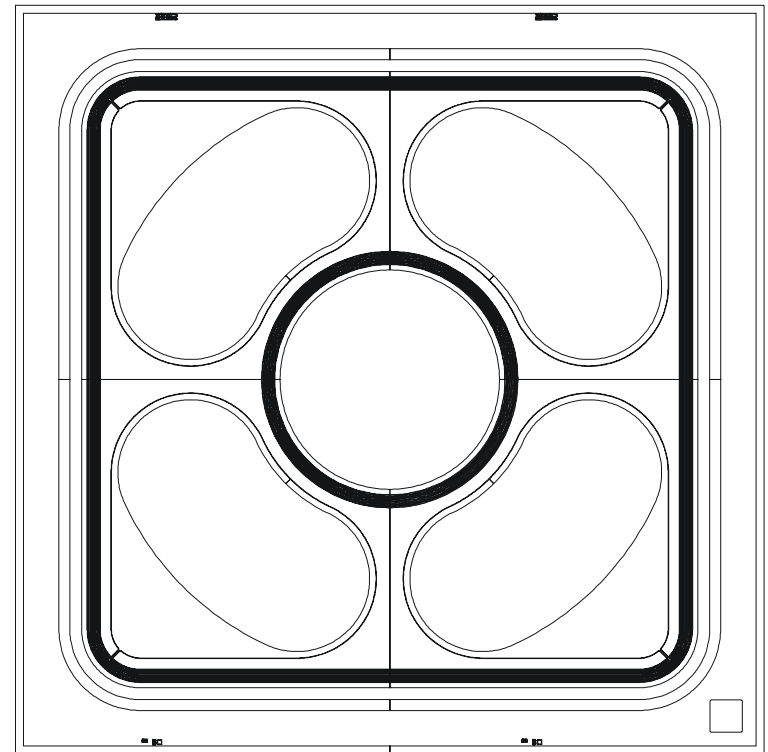
14 mm



Front side

Collecting anode and transistor

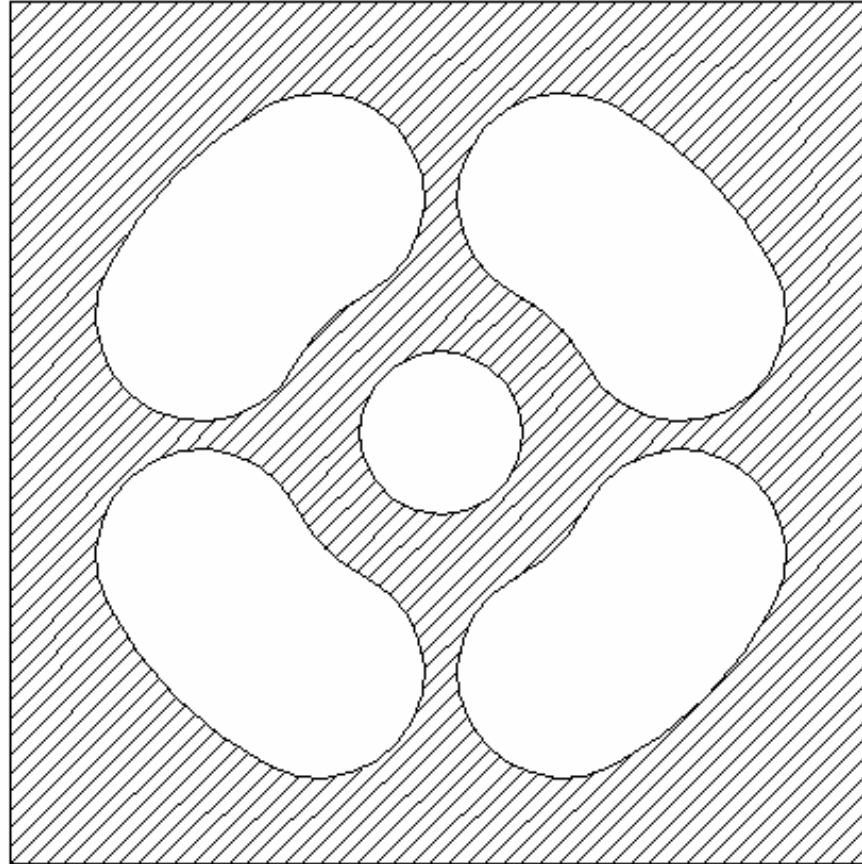
Thickness 450 μm



Back side

Radiation entrance window

SDD4 collimator



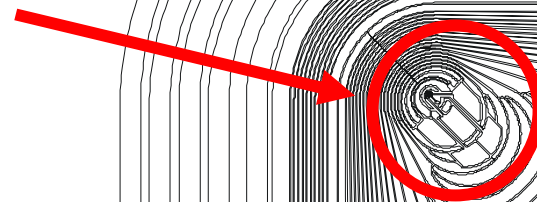
Collimated area $\approx 4 \times 15 \text{ mm}^2$

SDD4: collecting region

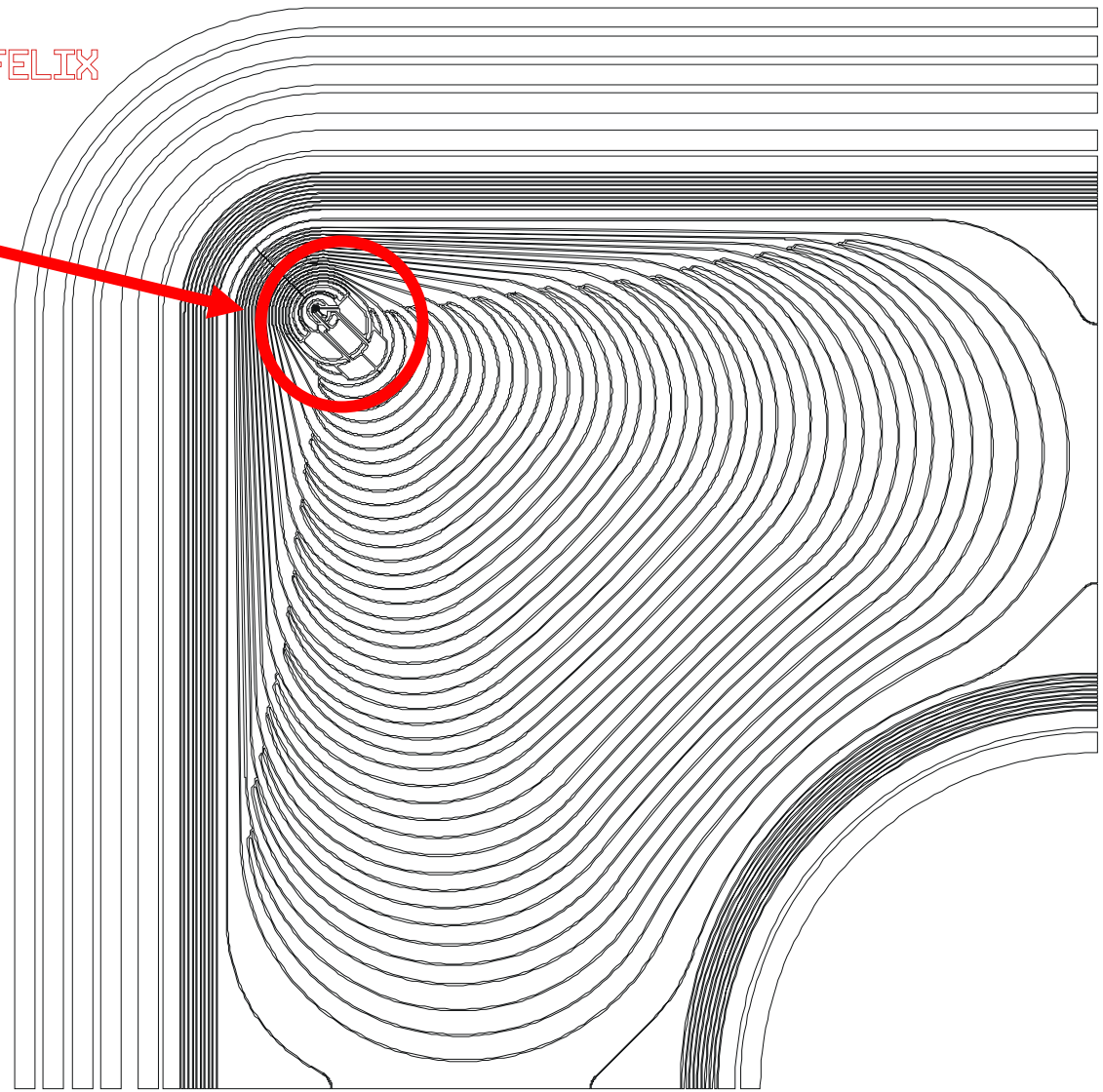
© 2000 ANKOR

FELIX

Collecting anode
and input JFET

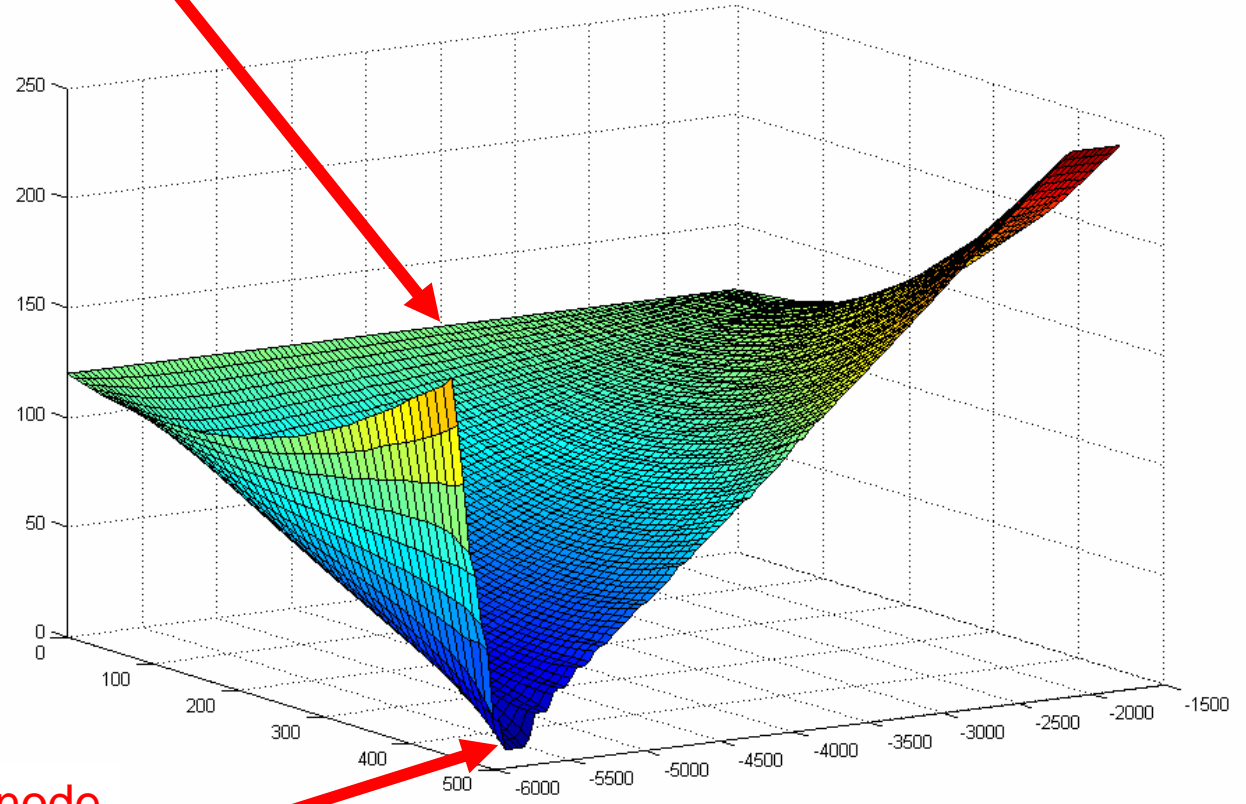
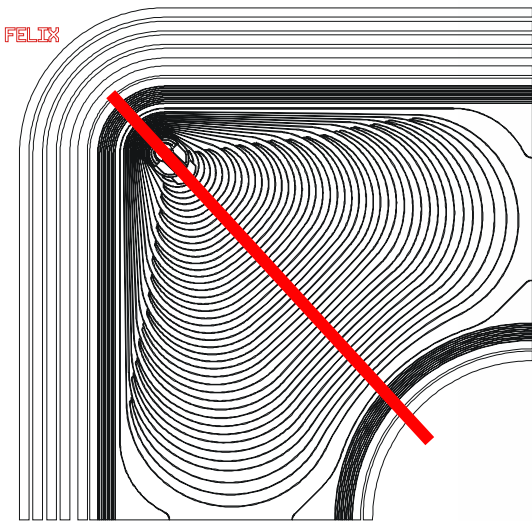


Ultra-low
Detector + JFET
capacitance:
 $C_d + C_g \approx 120 \text{ fF}$



SDD4 potential energy

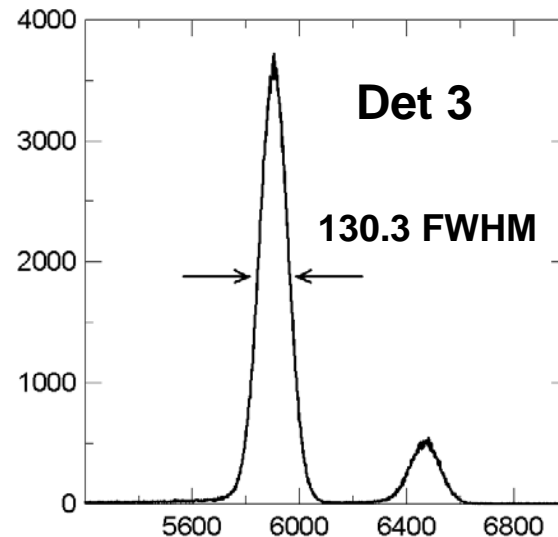
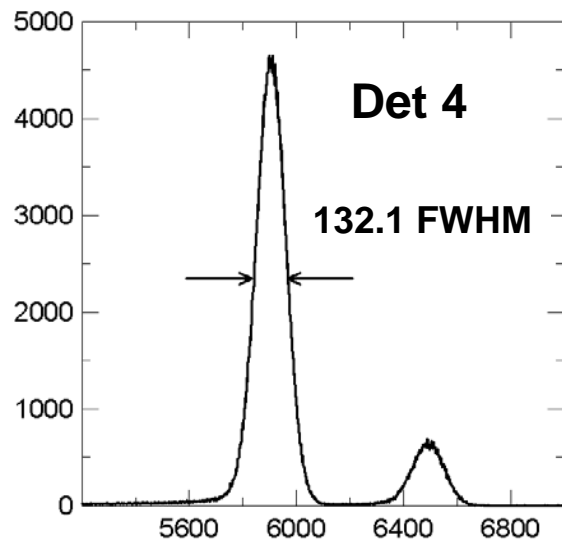
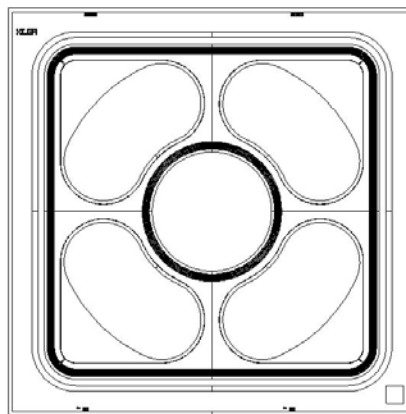
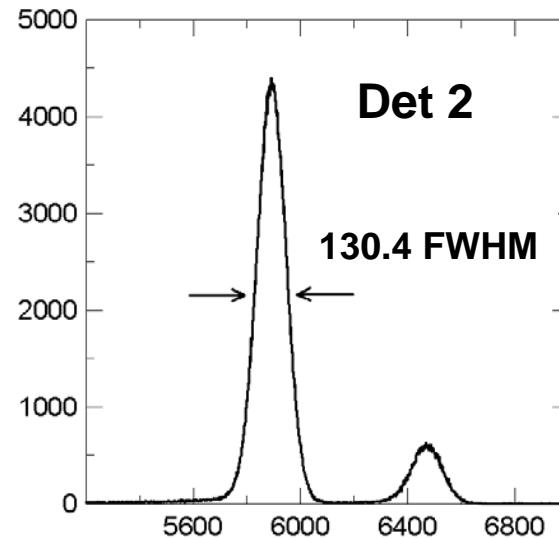
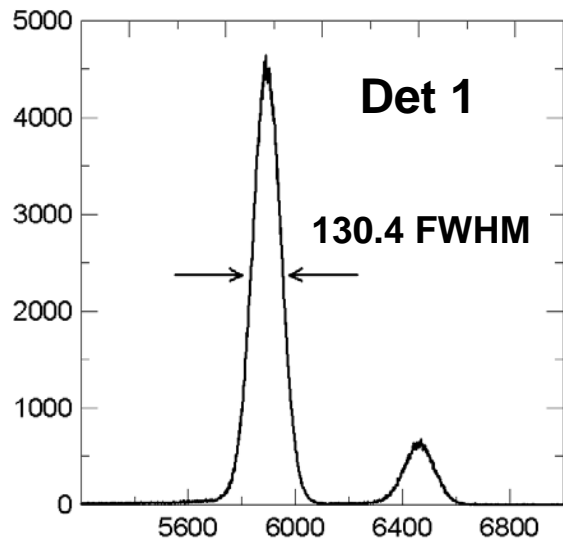
Radiation entrance
window



Collecting anode
and
input JFET

$$C_{\text{DET}} + C_{\text{JFET}} \approx 120\text{fF}$$

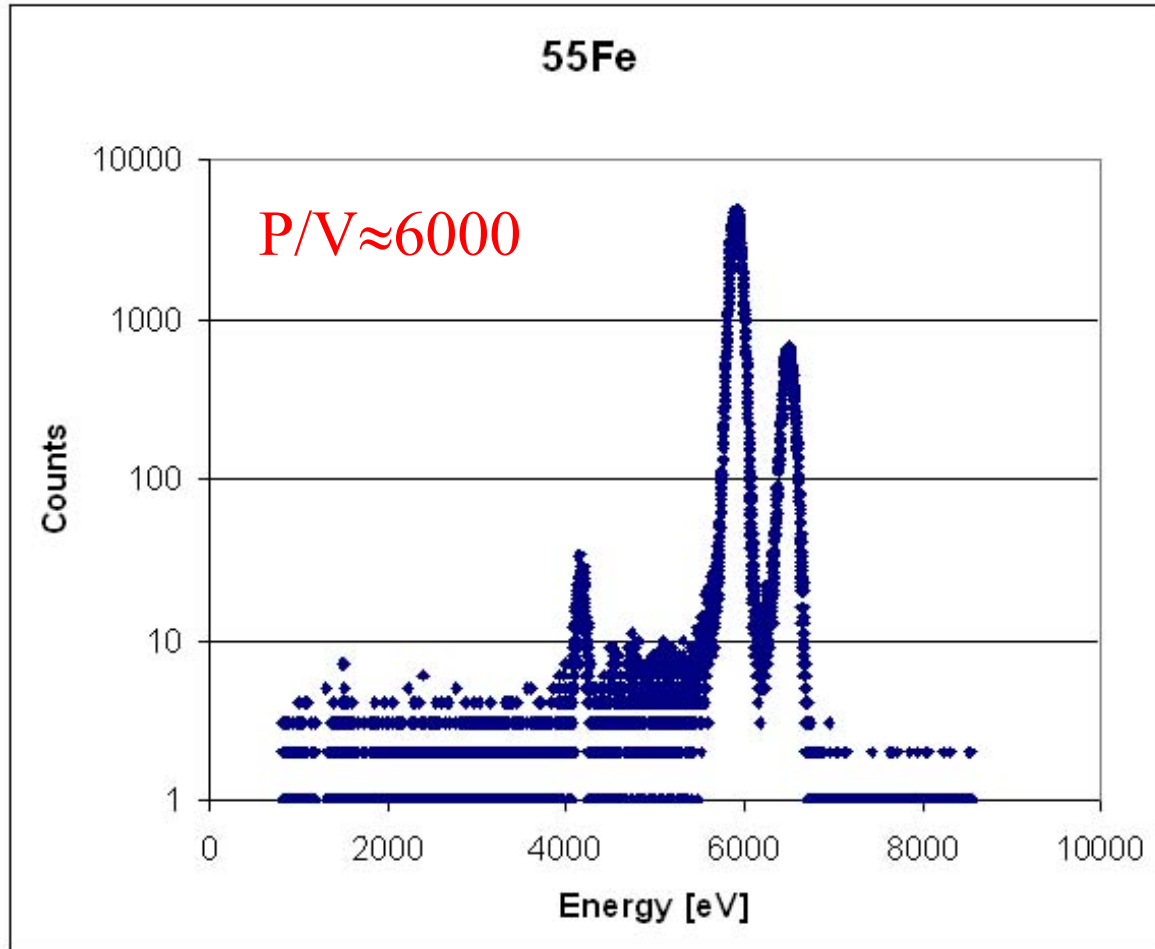
SDD4 preliminary results



Radiation source: ^{55}Fe
Count rate ≈ 2 kcps / channel
 $\tau_{\text{sh}} = 1.5 \mu\text{s}$ NO collimation

SDD4 preliminary results

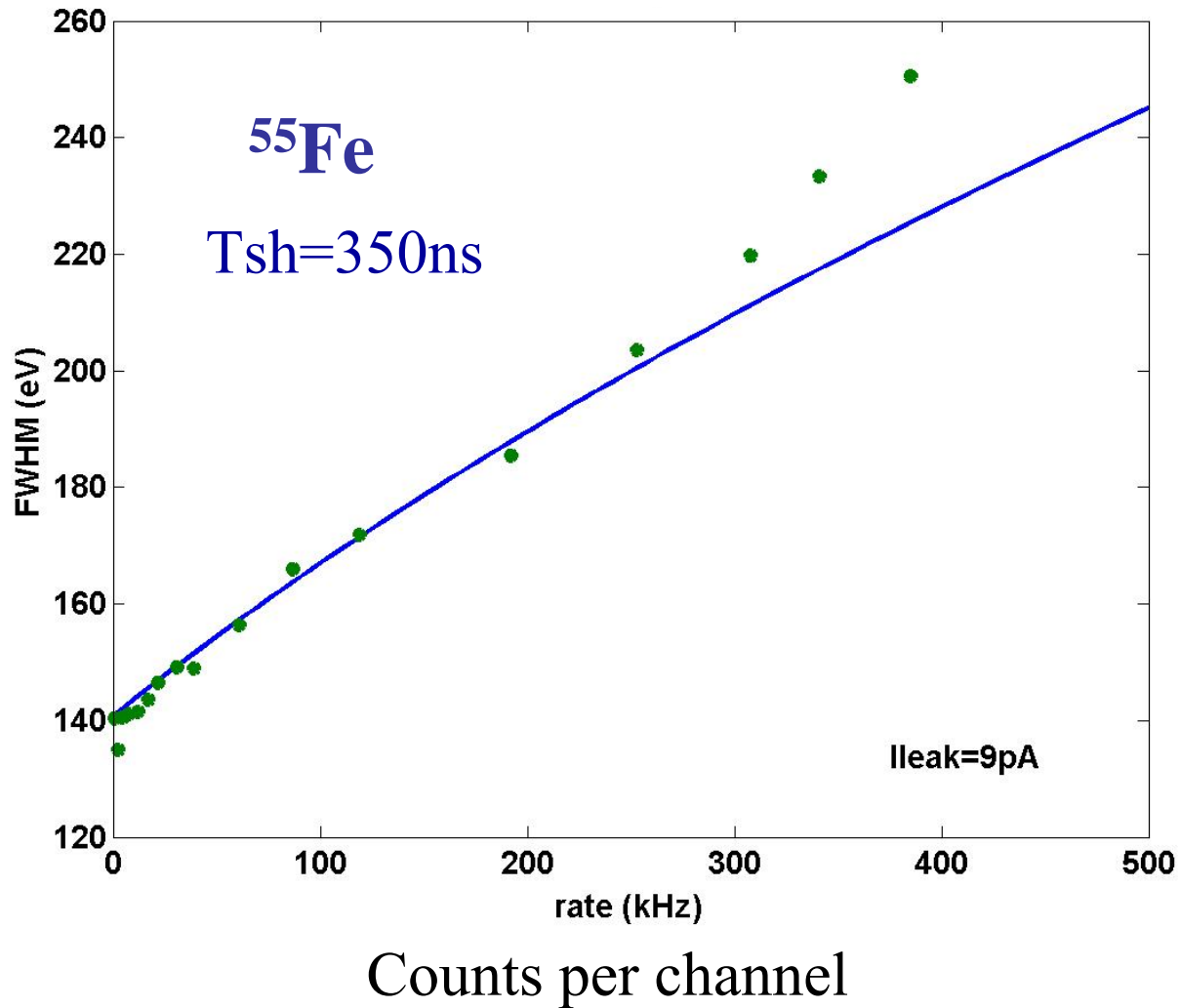
Peak to valley ratio



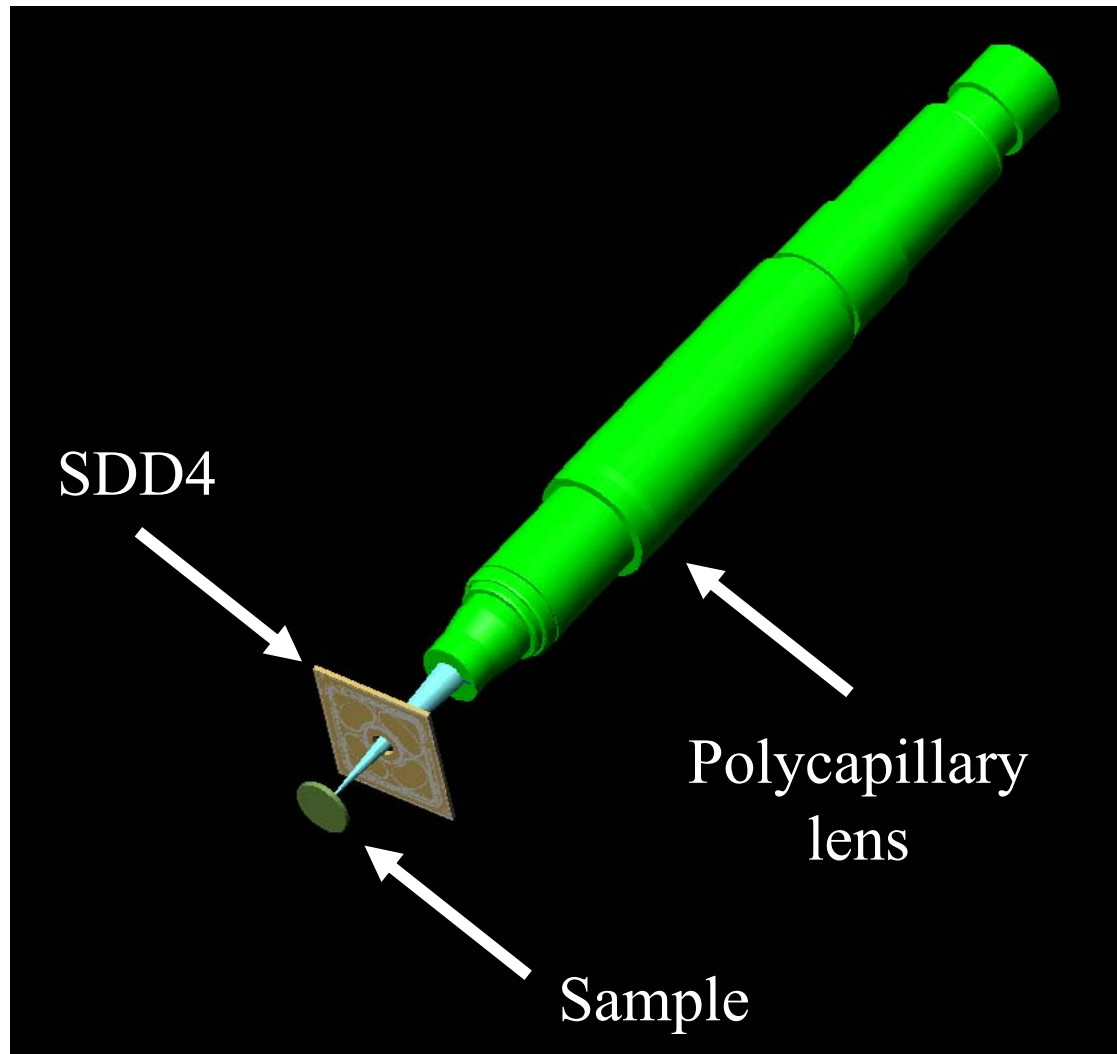
$T_{\text{sh}}=500\text{ns}$ Beam collimated: $\varnothing \approx 500\mu\text{m}$

SDD4 preliminary results

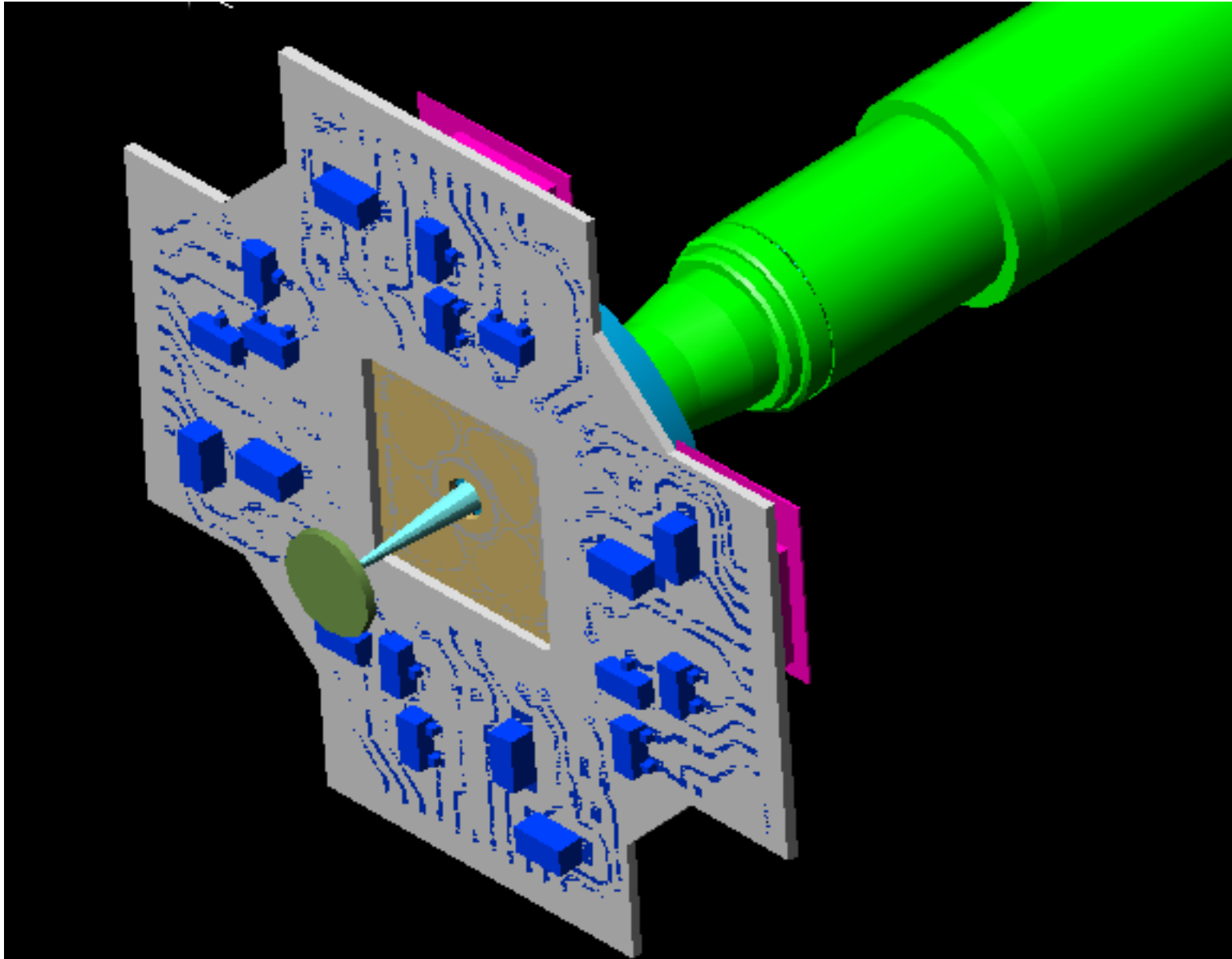
Resolution vs count rate



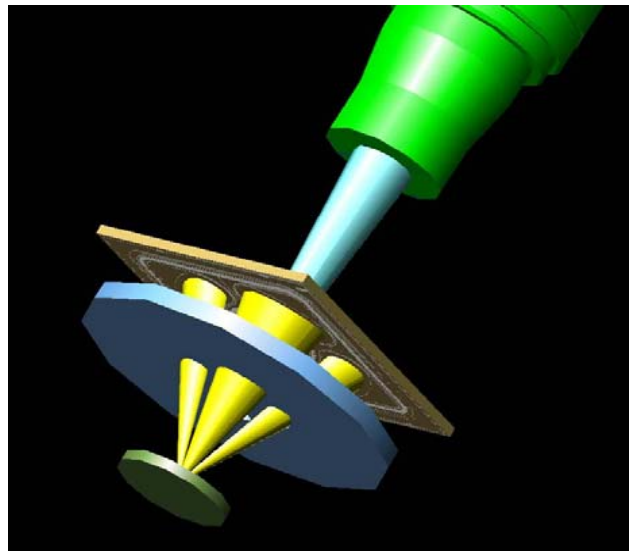
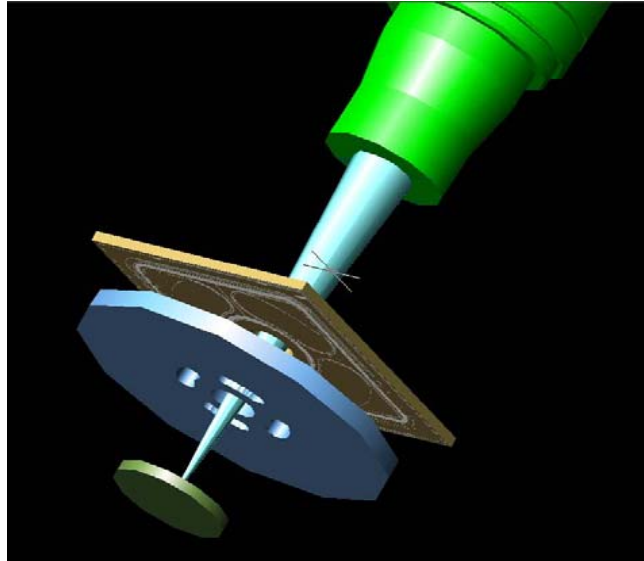
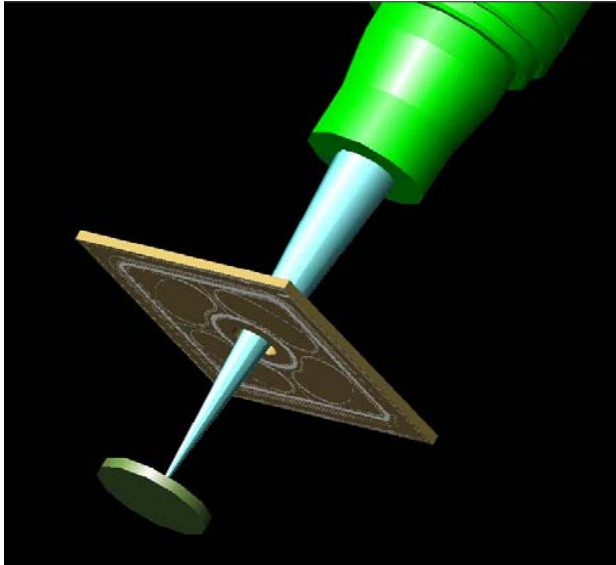
SDD4 measurement head setup



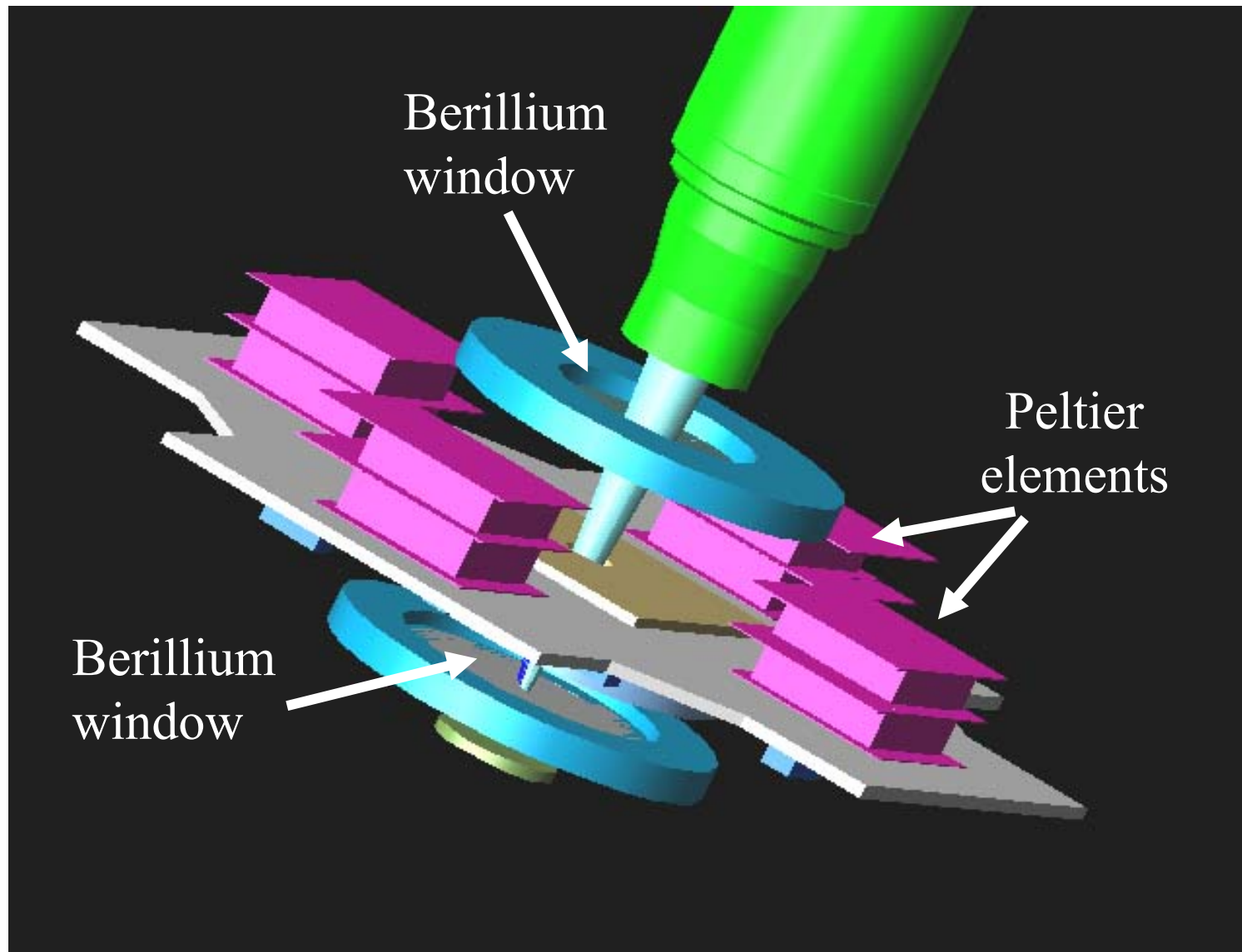
The ceramic board with electronic components

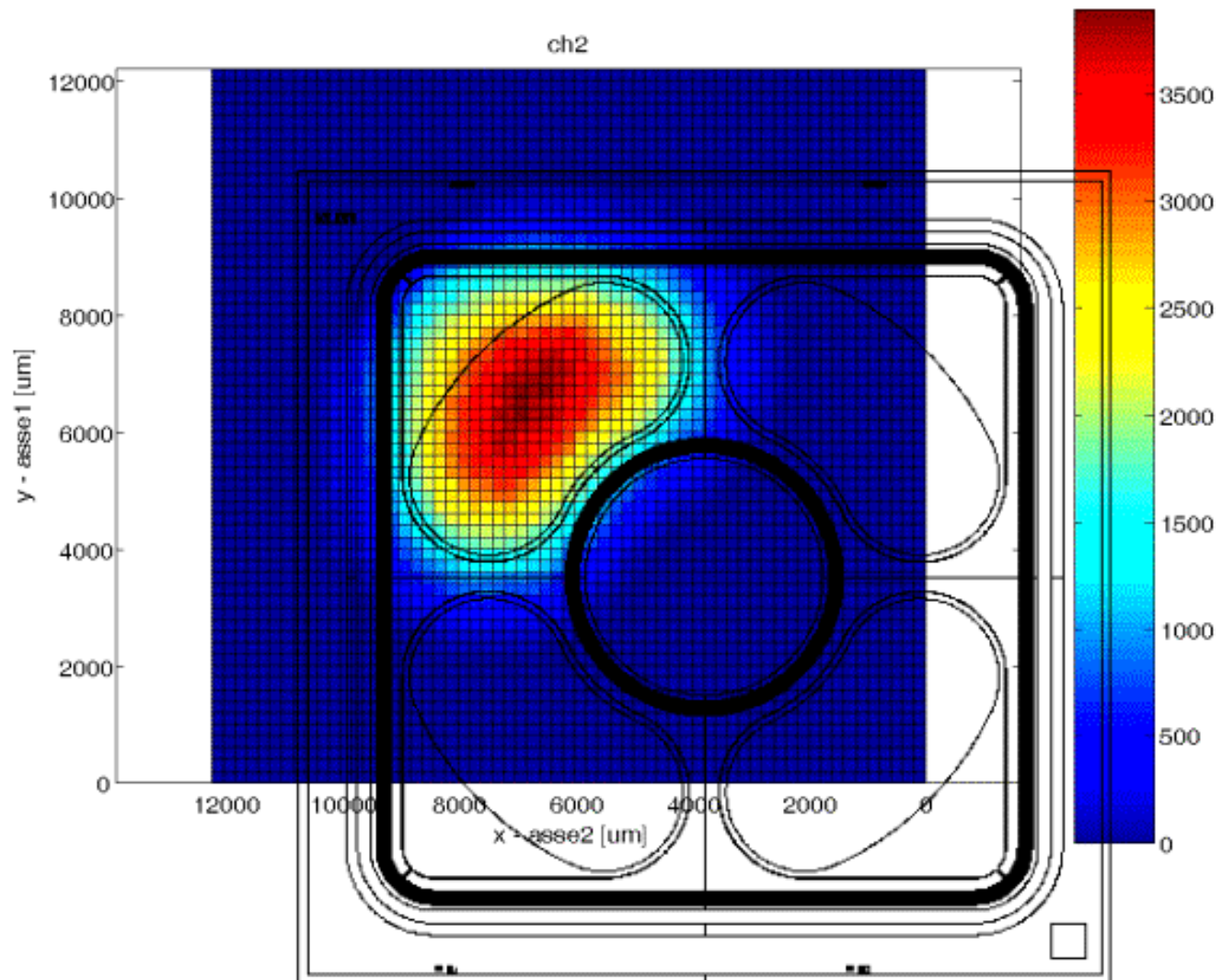


The collimator

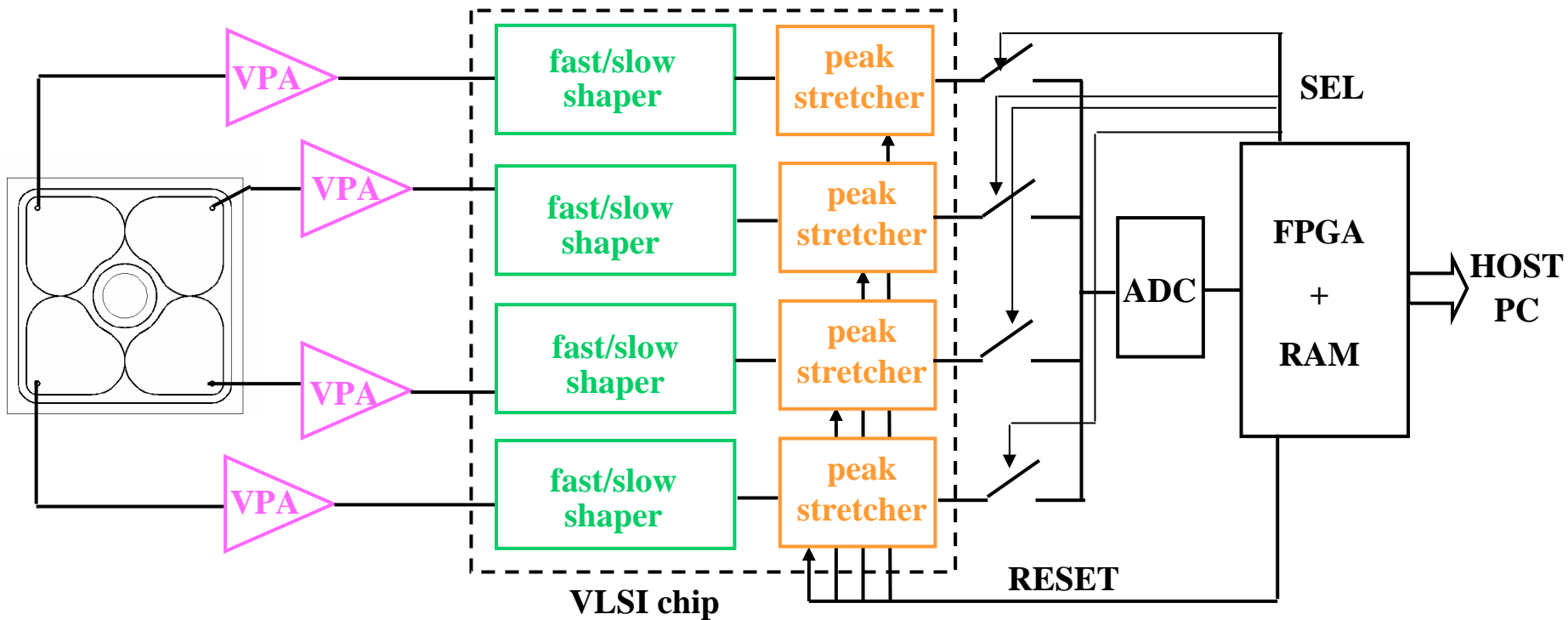


The Peltier refrigerators and the Be windows





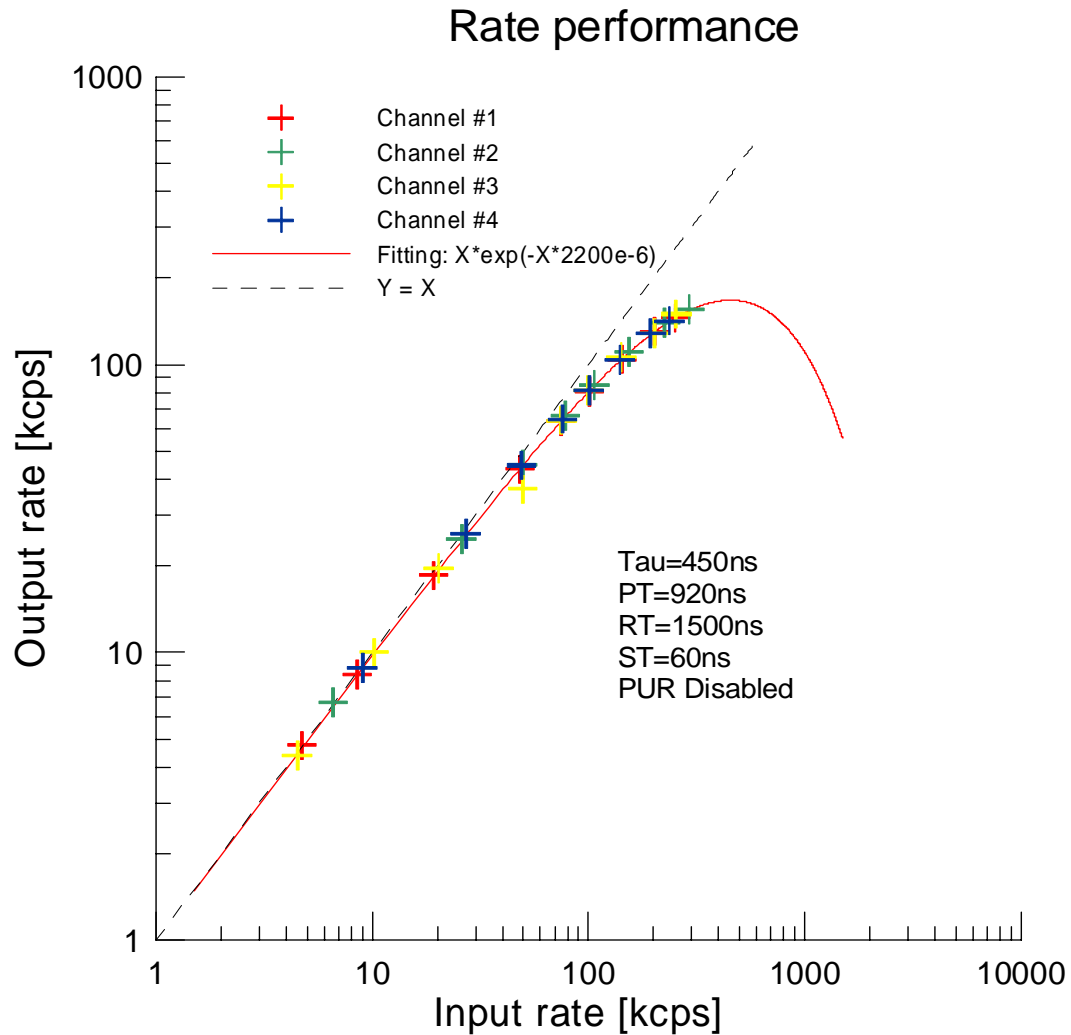
Readout electronics + Data acquisition system for the SDD4



Scheme of principle of the new fast acquisition system presently under development (the histogram is made 'on board')

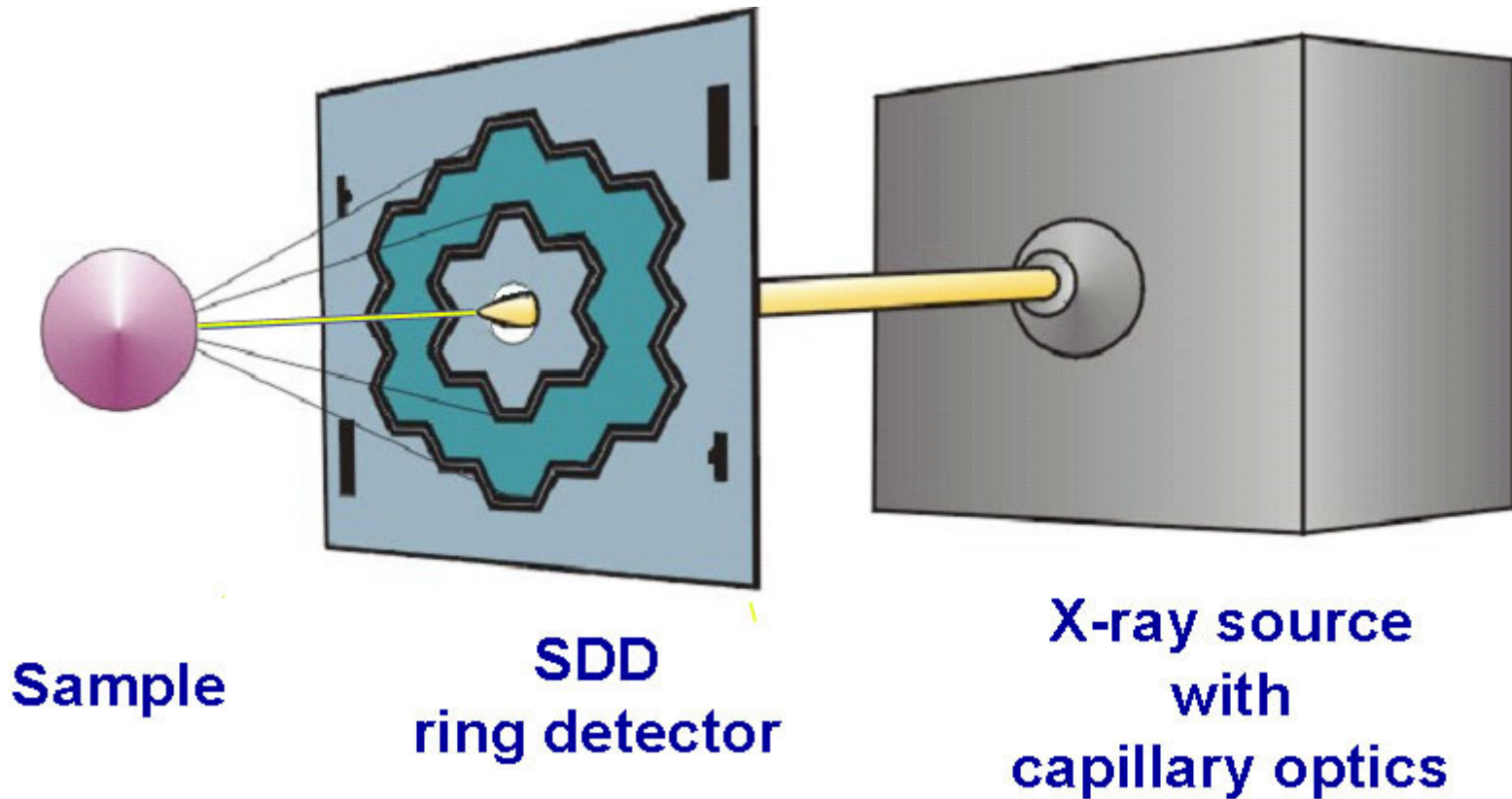
Researchers involved: A.Longoni, C.Guazzoni, S.Buzzetti

PRESTAZIONI DEL NUOVO SISTEMA DI ACQUISIZIONE

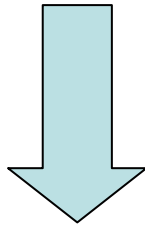


Some applications of the multi-element SDDs

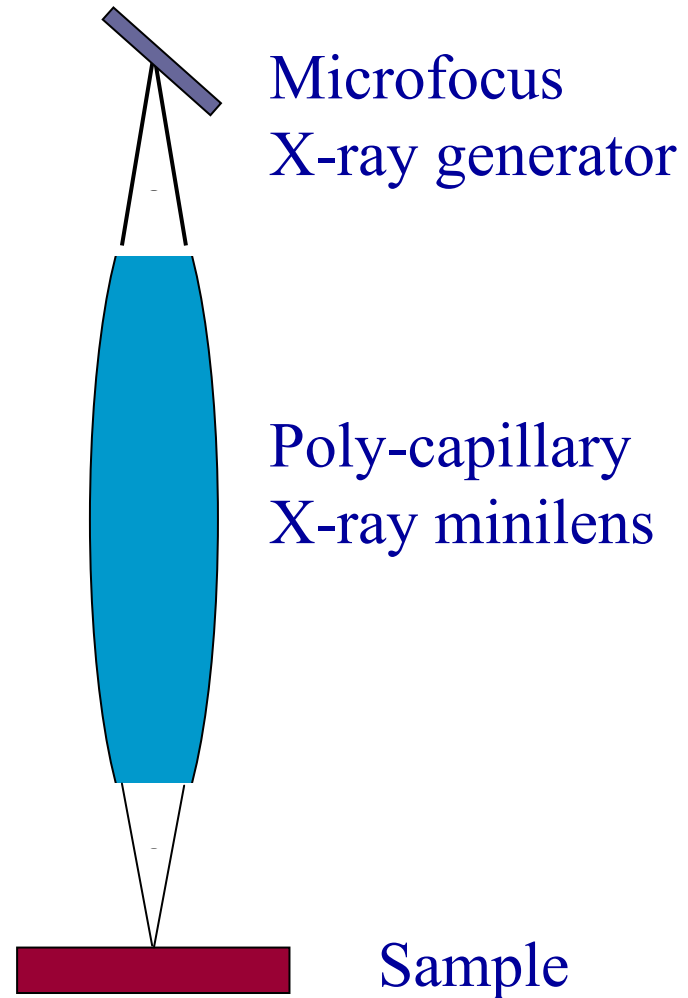
The concept of the multi-element spectrometer for XRF elemental mapping



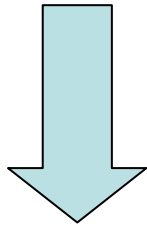
A polycapillary
X-ray lens
allows:



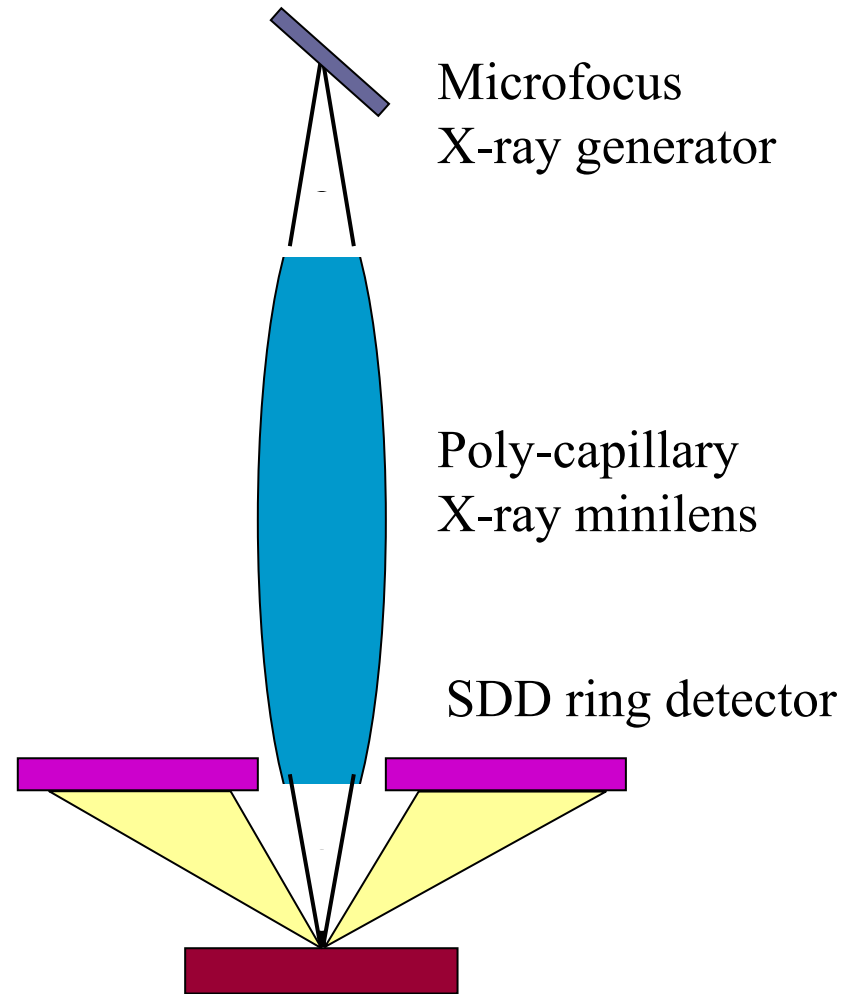
an higher photon flux
in a small excitation spot

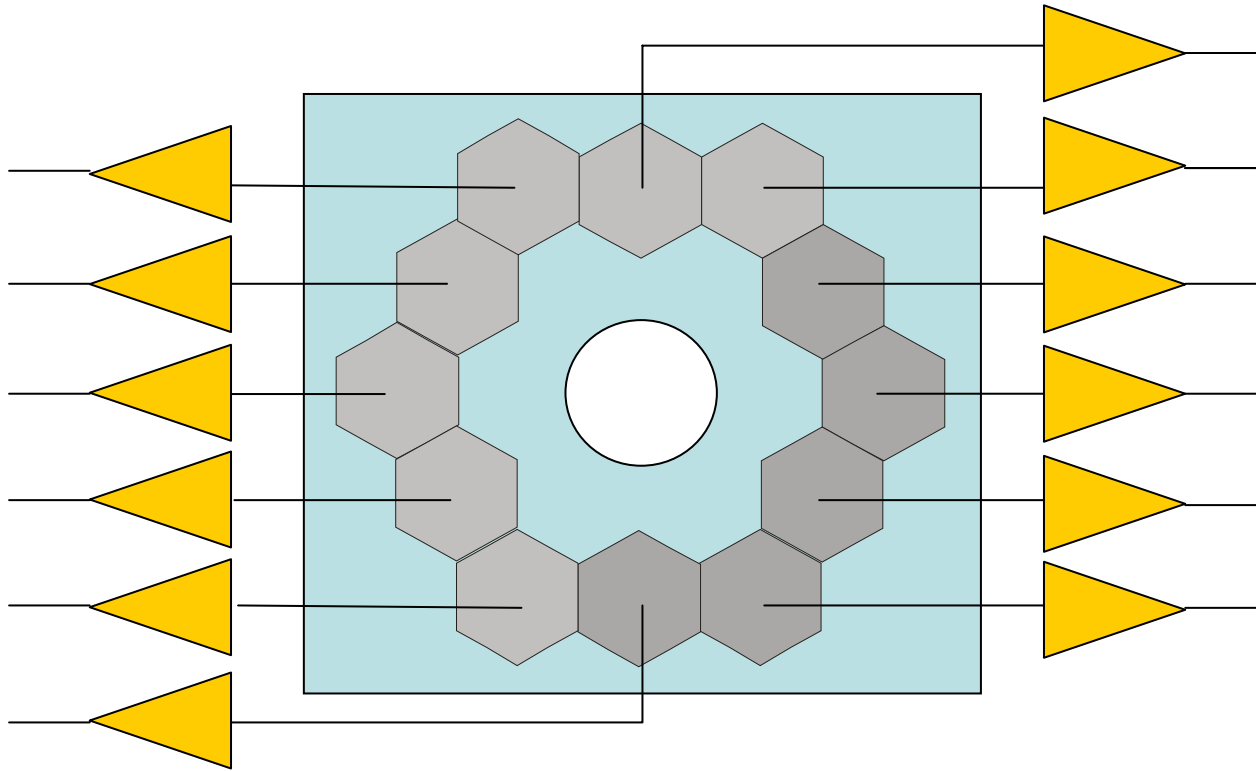


A ring detector centered
on the excitation beam
allows

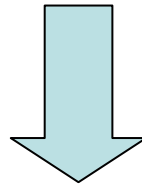


- a larger collection angle of the fluorescence
- an higher detection efficiency at low energy





A multi-element detector allows:

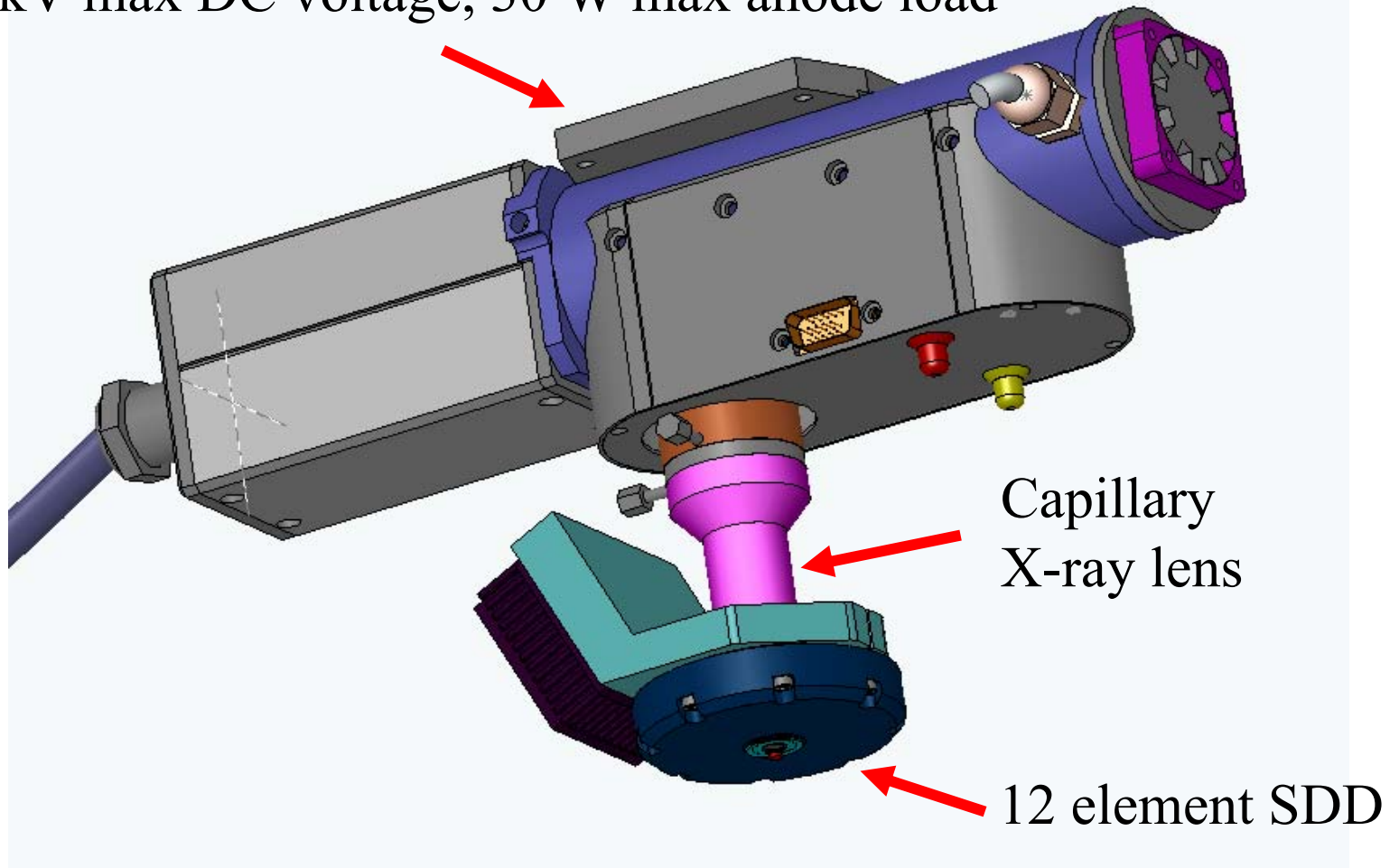


- an higher detection rate for the same total active area

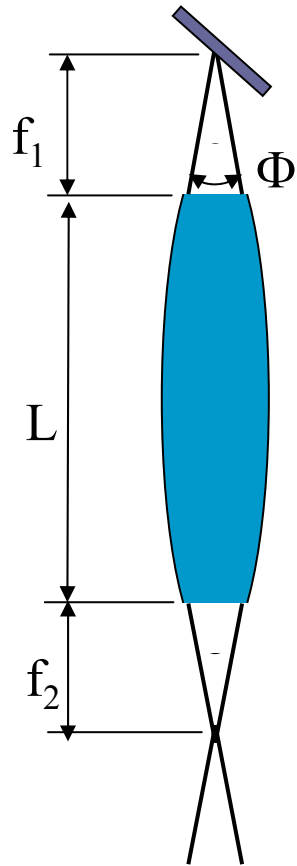
The excitation-detection unit

Microfocus X-ray generator * W anode

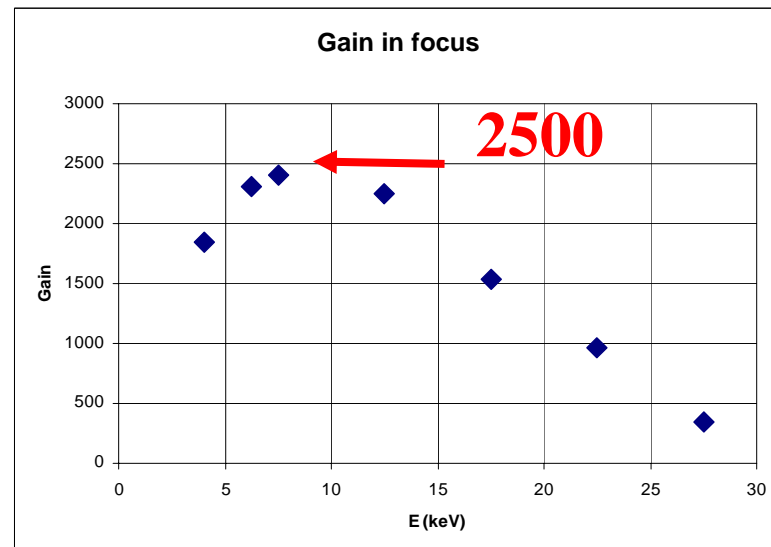
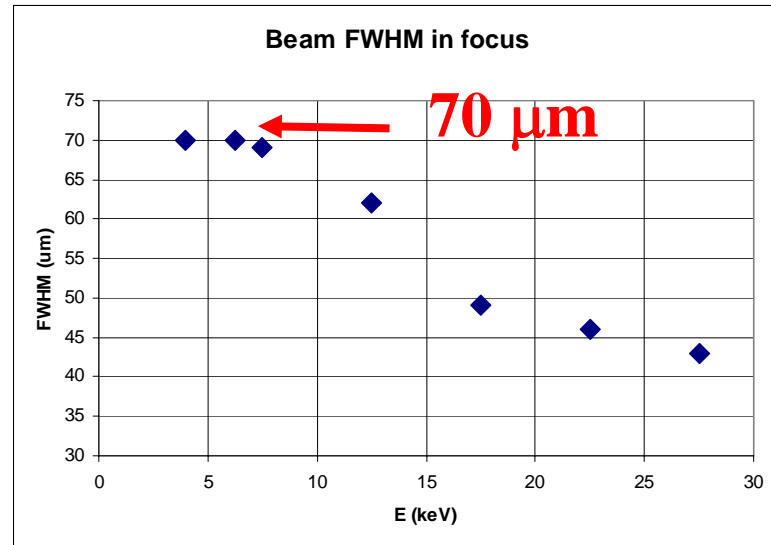
50 kV max DC voltage, 30 W max anode load



The X-ray mini-lens parameters



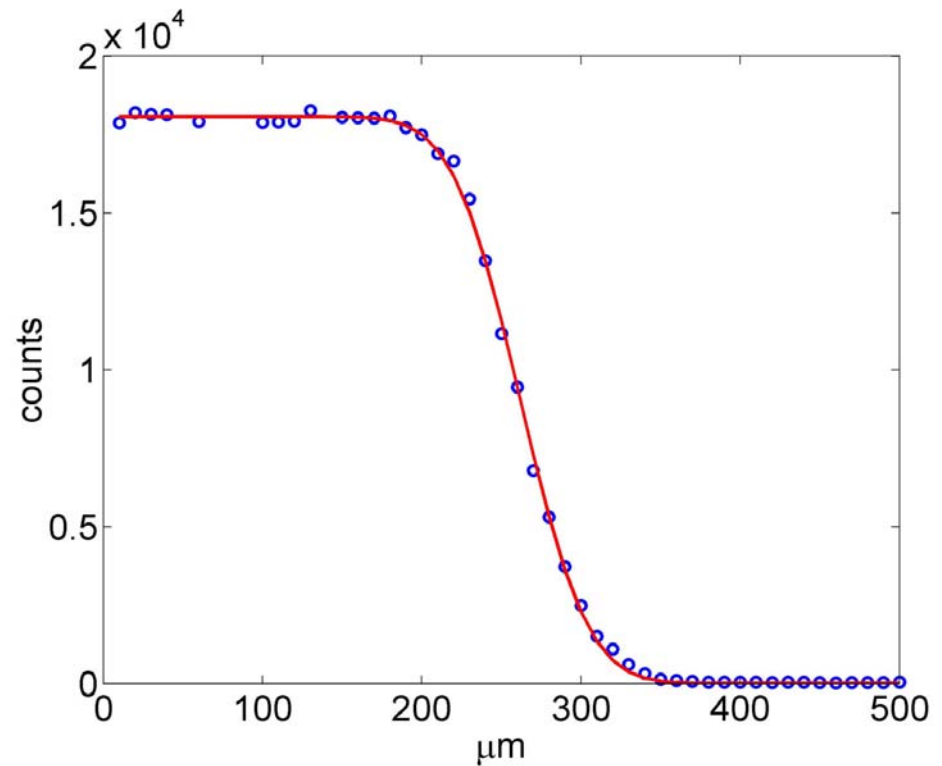
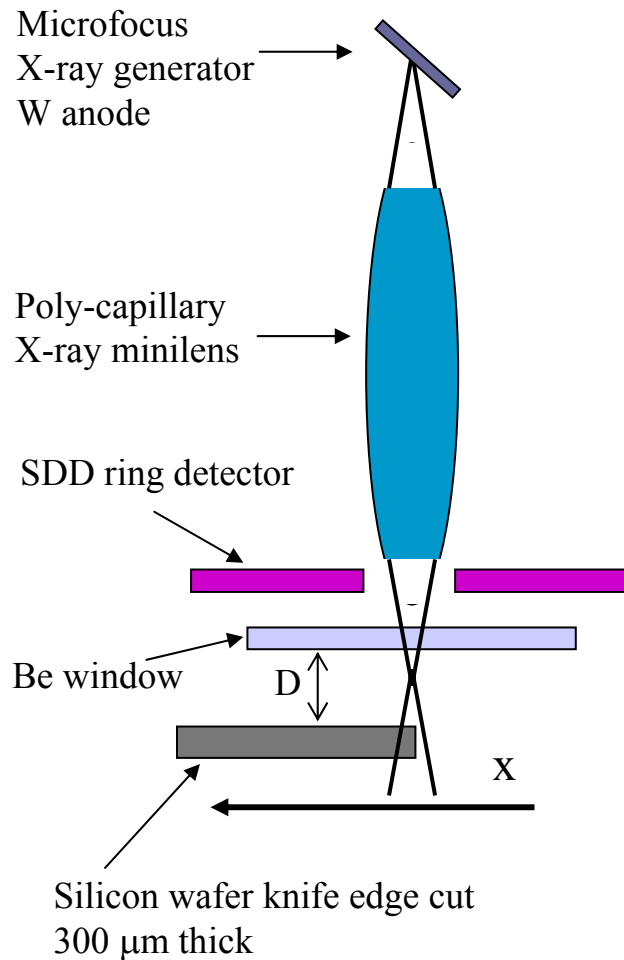
$f_1=40$ mm
 $f_2=20$ mm
 $L=77$ mm
 $\Phi=0.094$ rad



Measured with 15 μ m pinhole

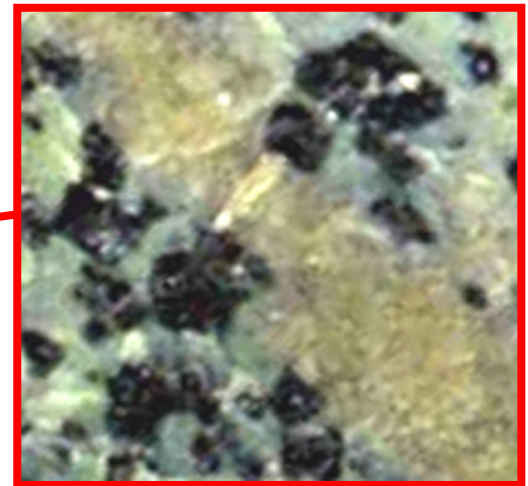
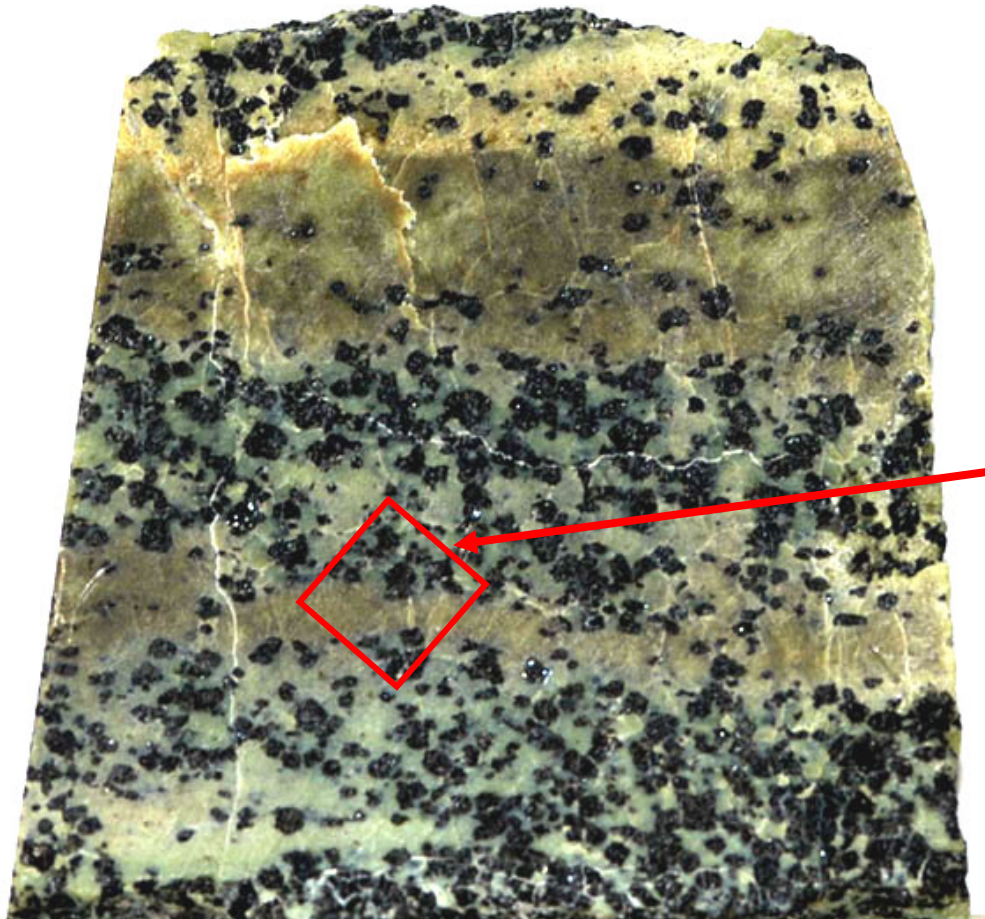
The spatial resolution of the spectrometer - 1

Knife-edge test



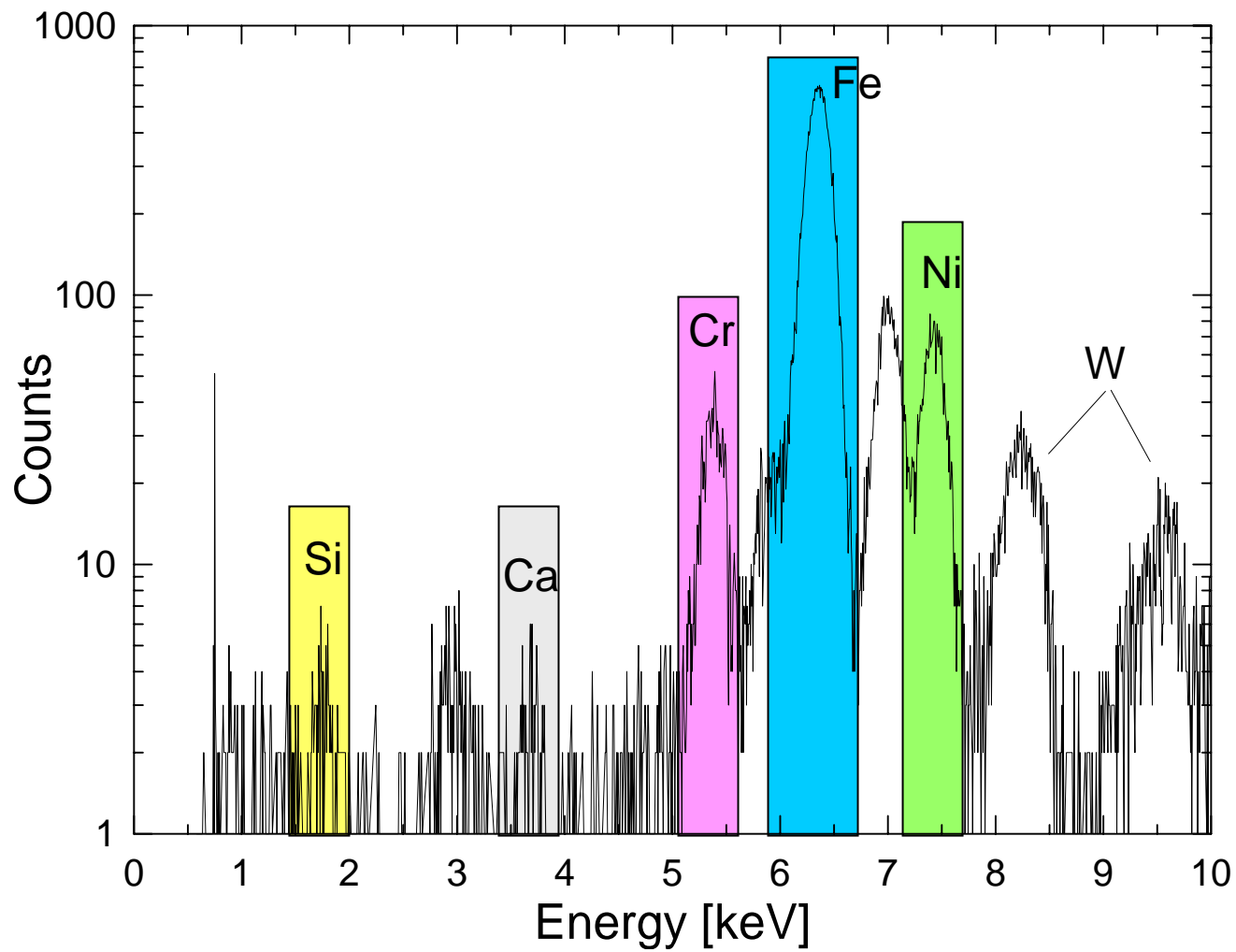
$D=1\text{mm}$ FWHM= $78\mu\text{m}$
(slightly out of focus)

Geology

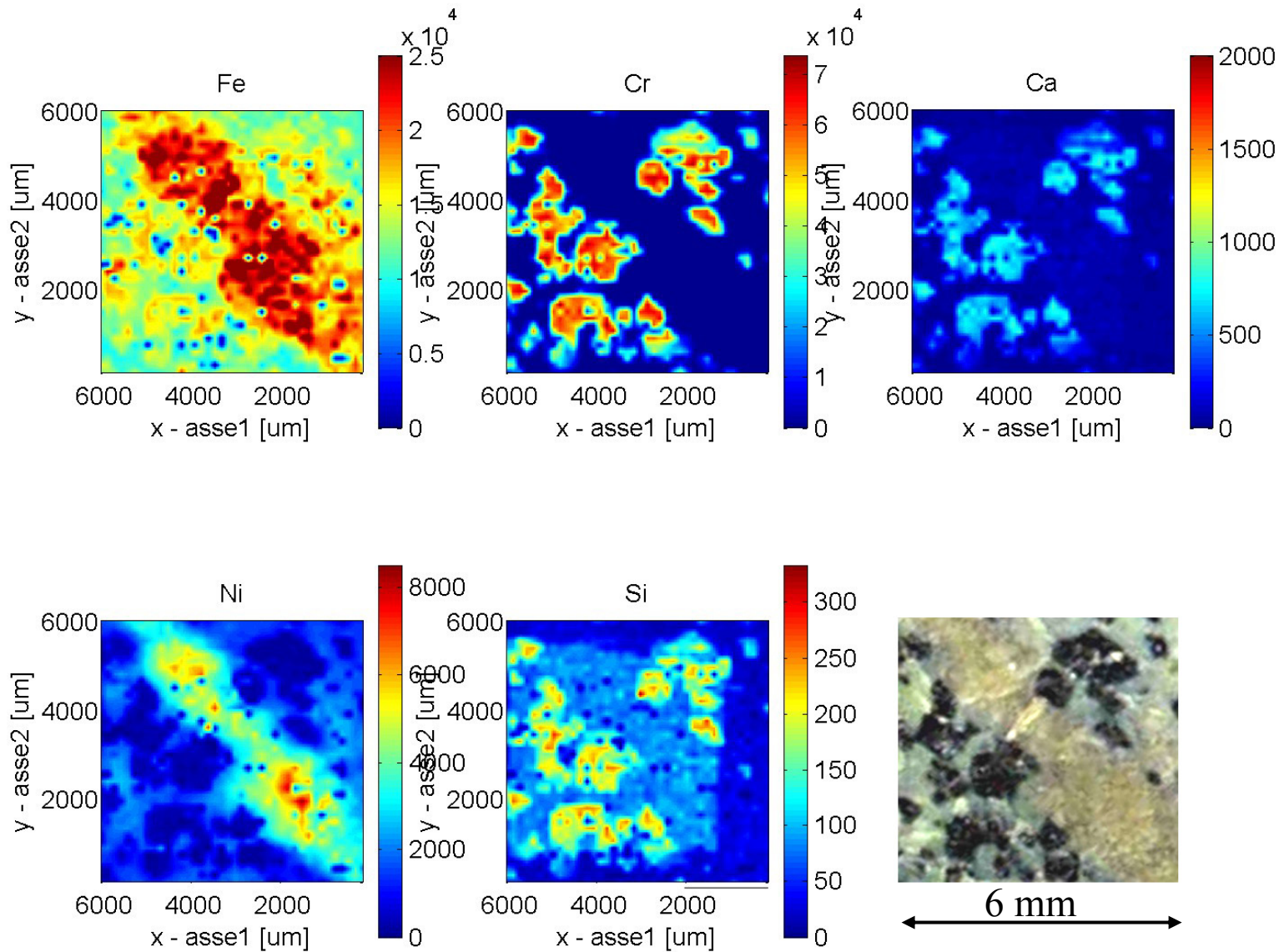


6 mm

Chromite



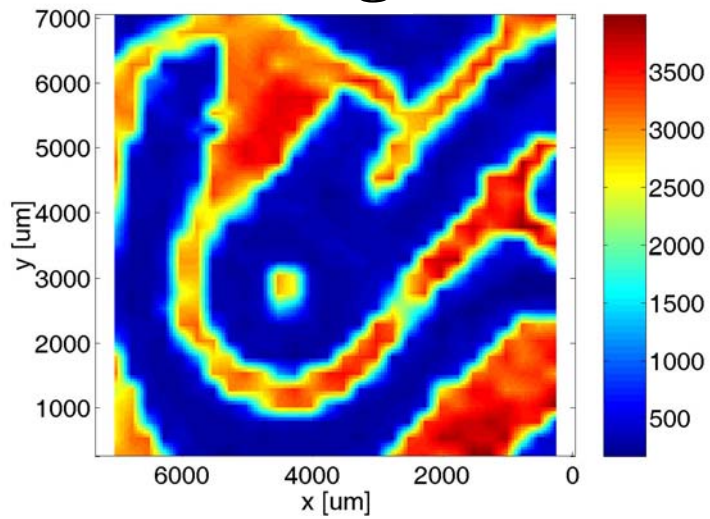
Chromite: main elements



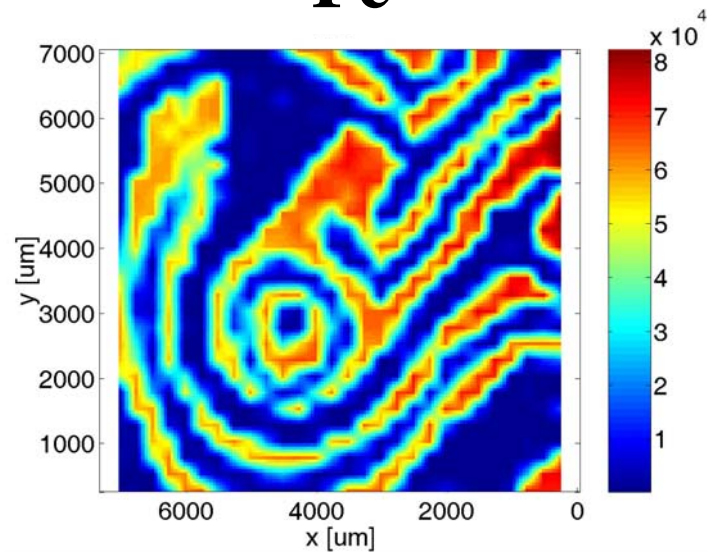


Lombard buckle – inlaid work (agemina)
Second quarter of VII century A.C.
Trezzo d’Adda, Italy

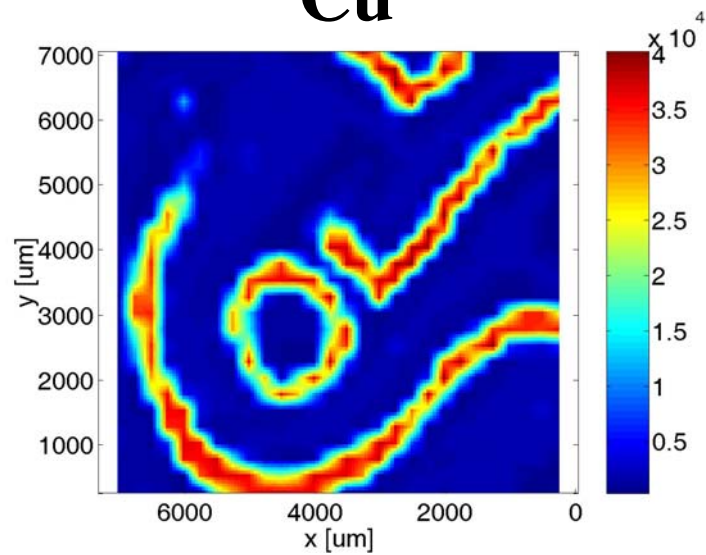
Ag



Fe

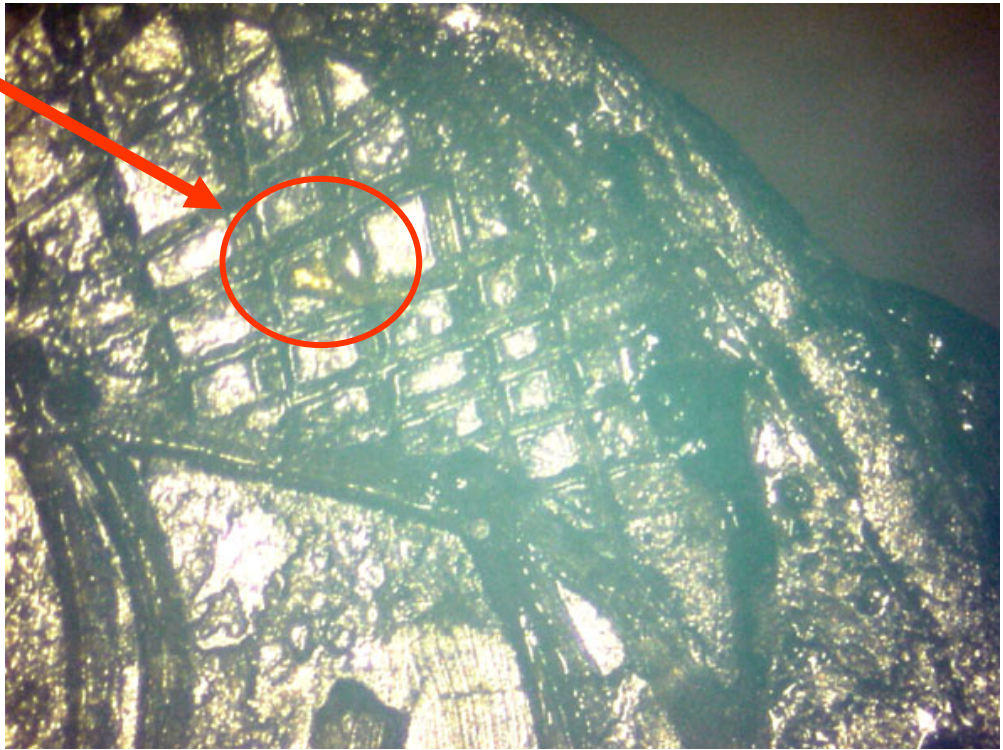
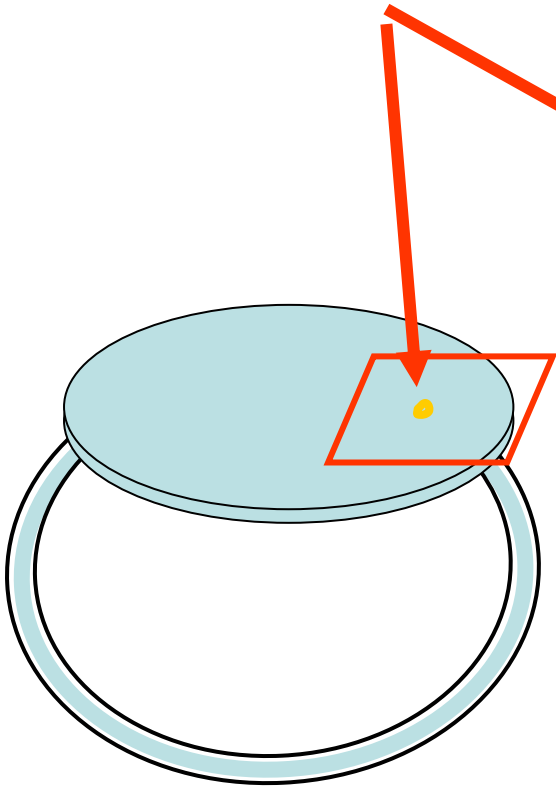


Cu

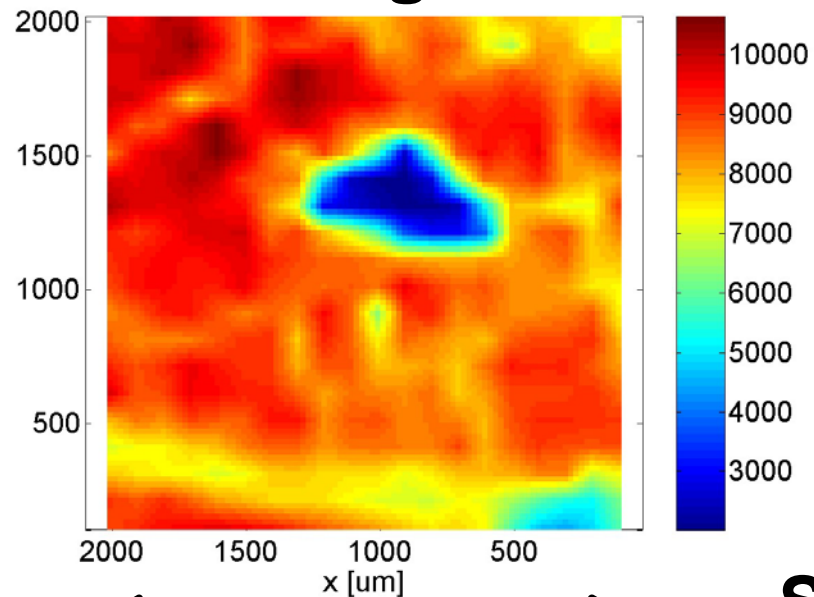


7 mm

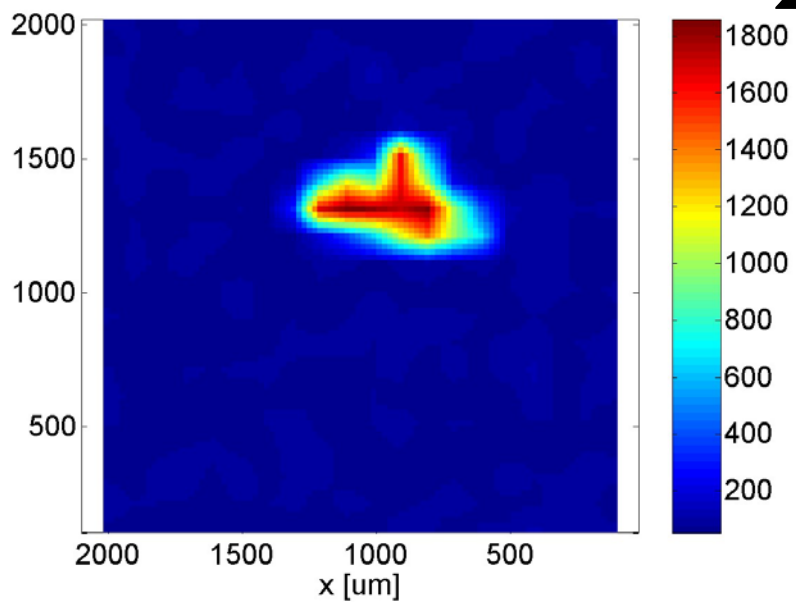
Roman (?) ring



Ag

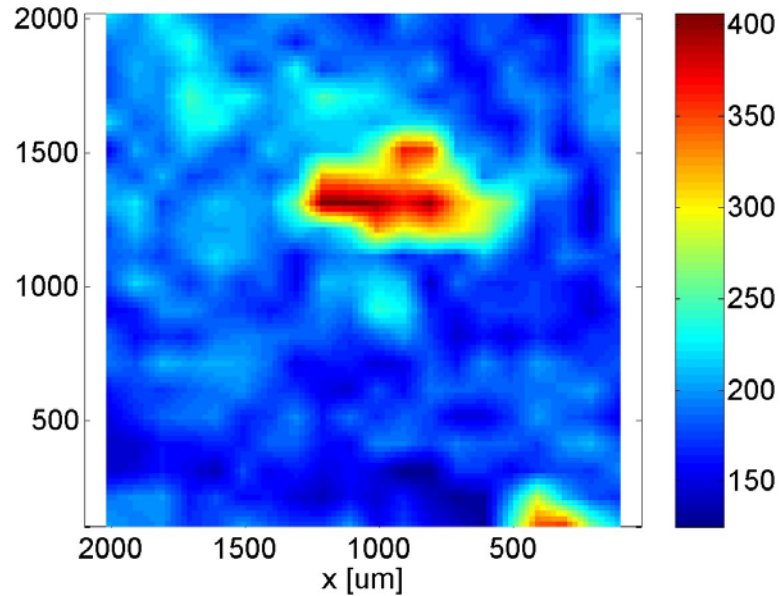


Pb



← 2 mm →

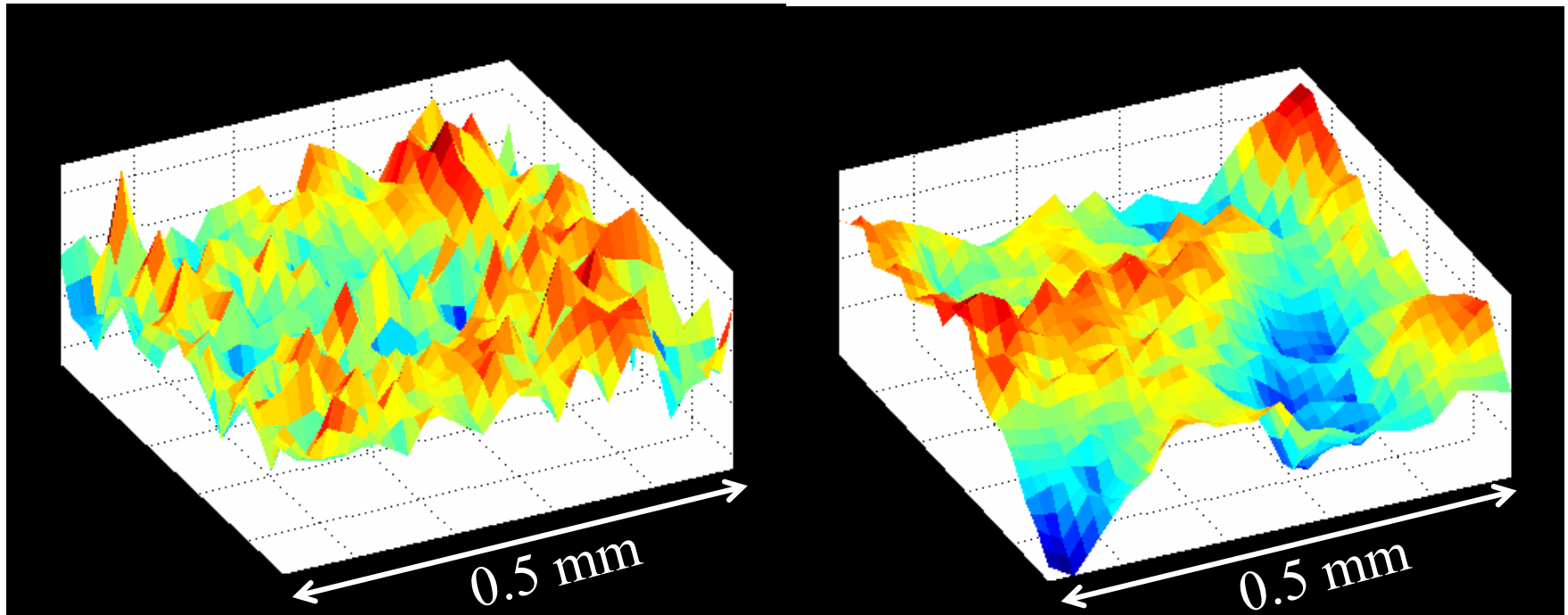
Si



Mretallurgy: study of an Iron-Nichel alloy

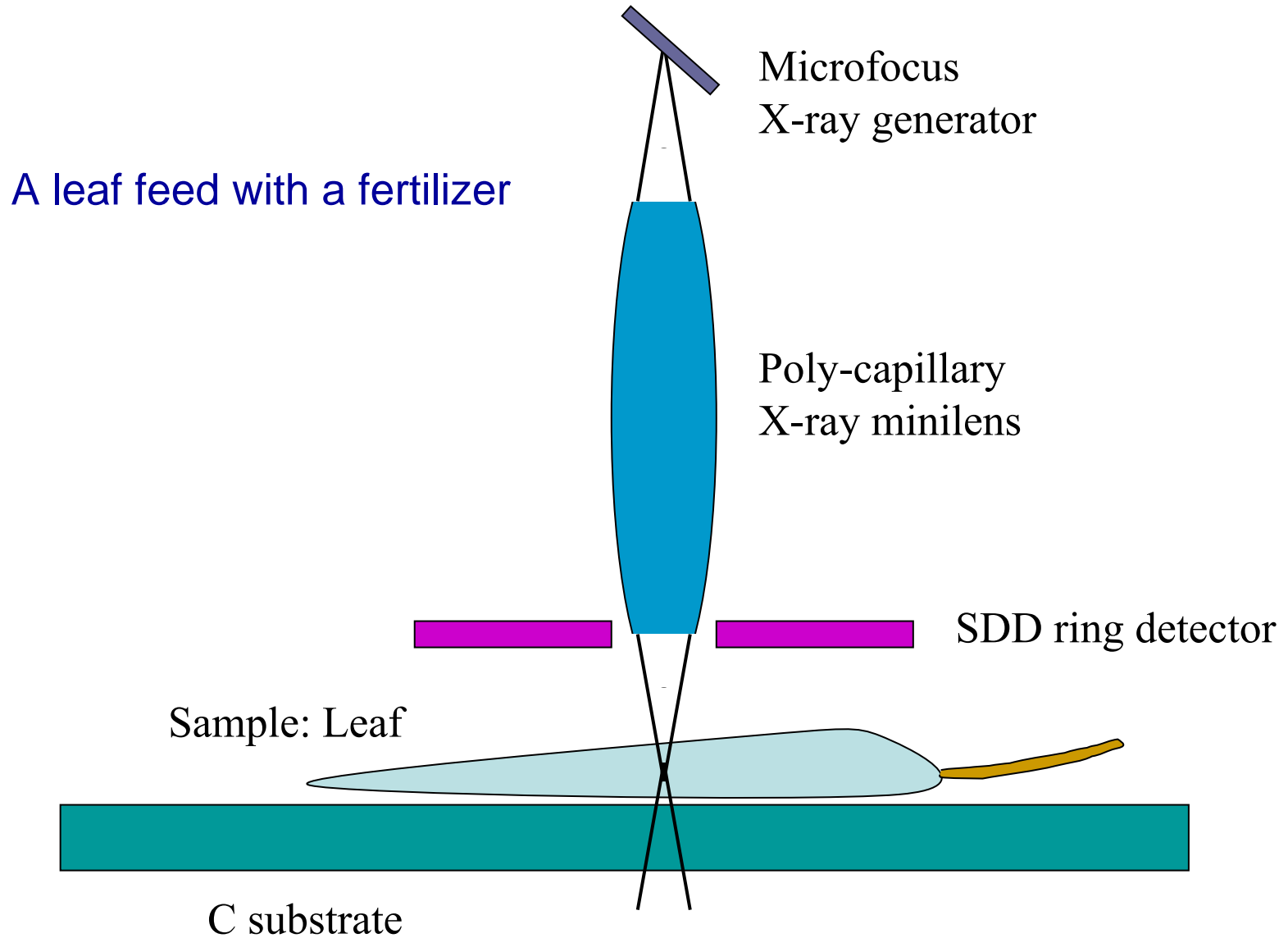
Fe

Ni



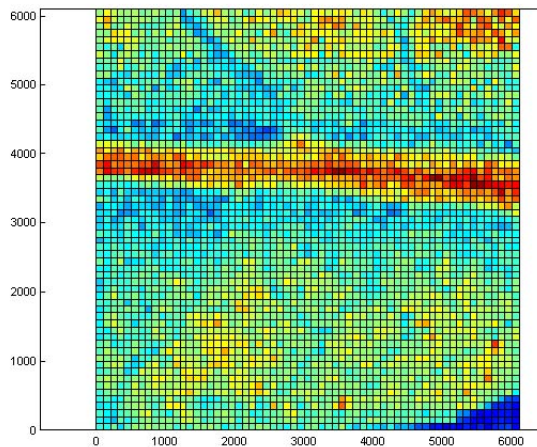
Iron powder with Nickel grains partially diffused on the Iron surface during the syntherization process at 1120 C

Biology

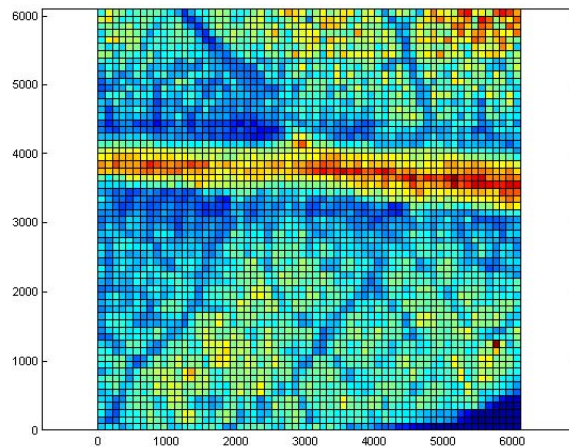


Leaf 'fluorescence' (detail)

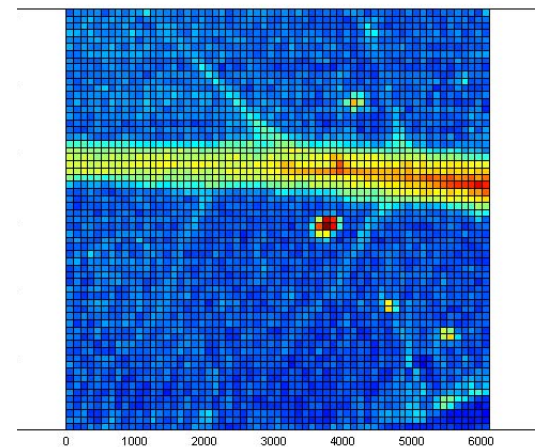
K



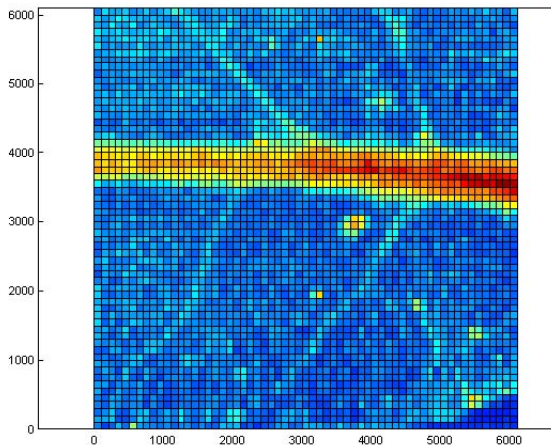
Ca



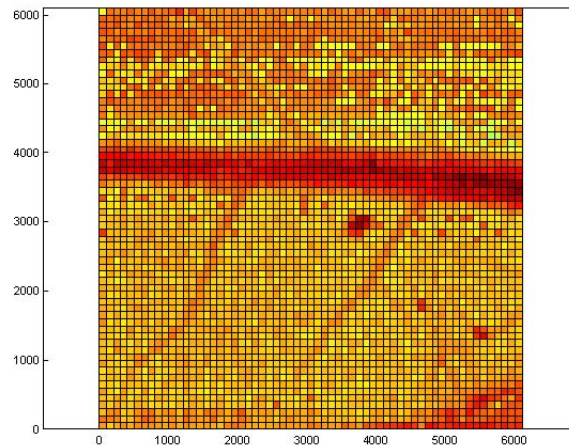
Mn



Fe

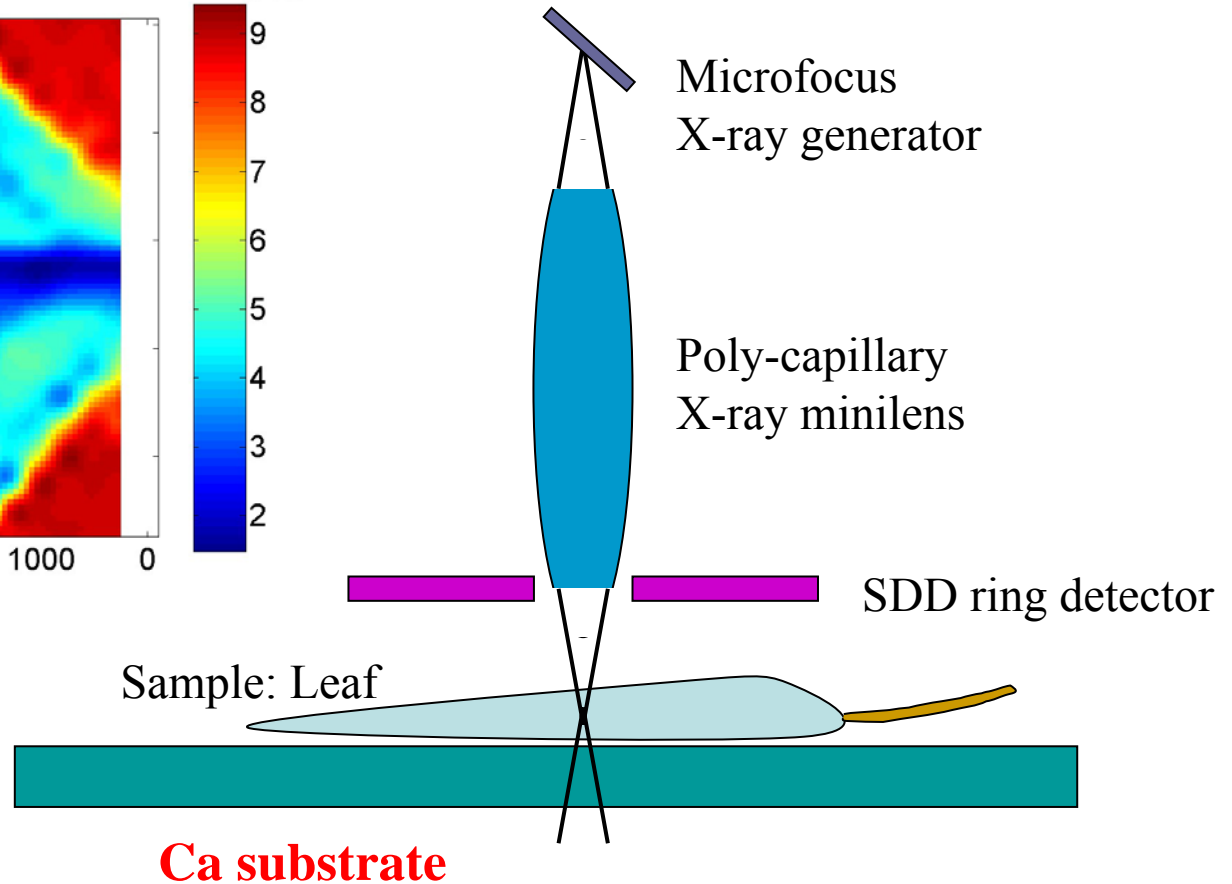
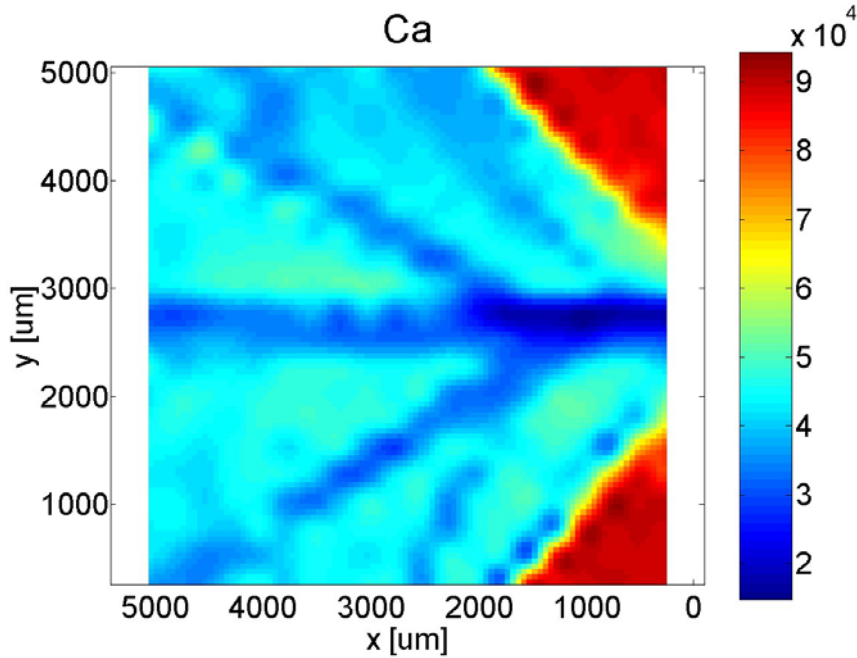


Cu



Scanned area 6x6 mm, 61x61 points, 100 μ m x 100 μ m pitch, 0.5s meas time per point, 6 SDD active
Max counts/pixel: K 406 Ca 2386 Mn 1902 Fe 3822 Cu 6874

Leaf 'radiography' (detail)



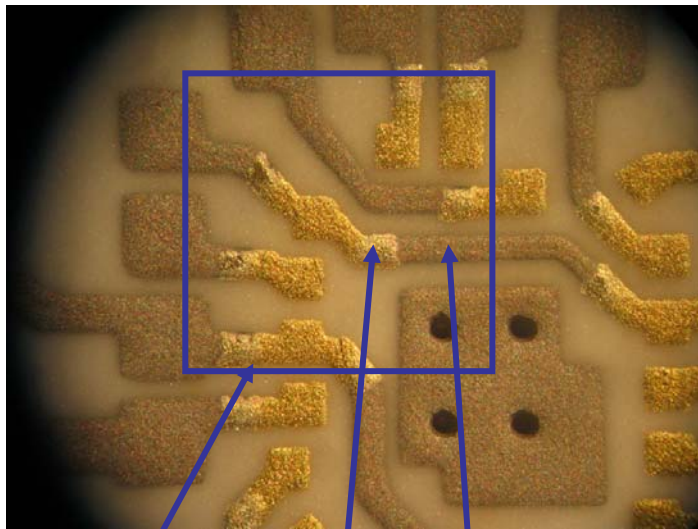
Absorption of $K\alpha$ Ca line (3.69 keV)

Scan: 21x21points, 250 μm x 250 μm steps, measurement time 1s/point

Technology

Alumina board for electronic circuits

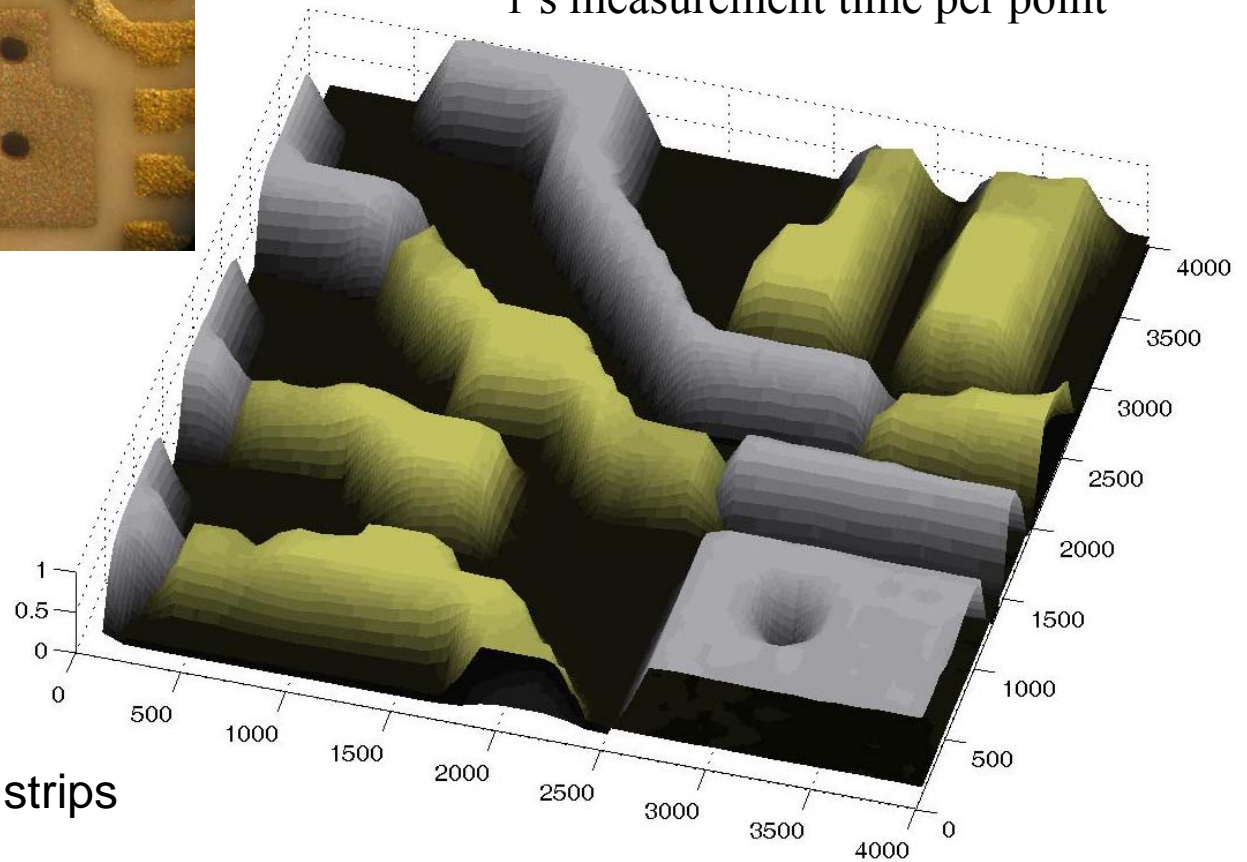
41x41 sampled points
100x100 μm steps
1 s measurement time per point



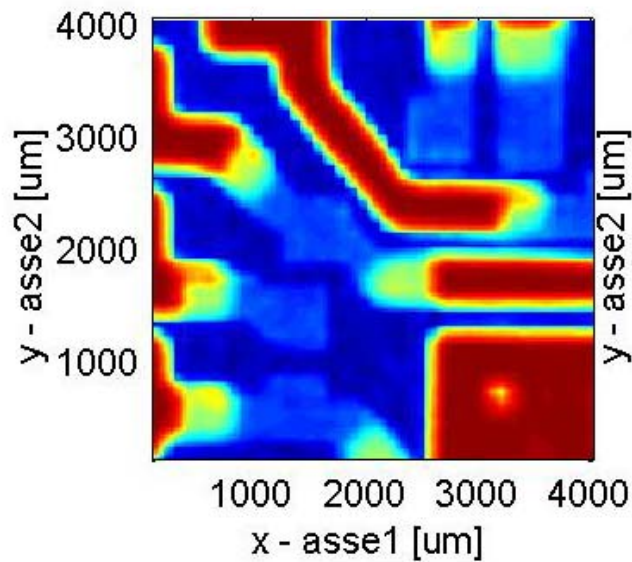
Scanned area
4x4mm²

Gold coating

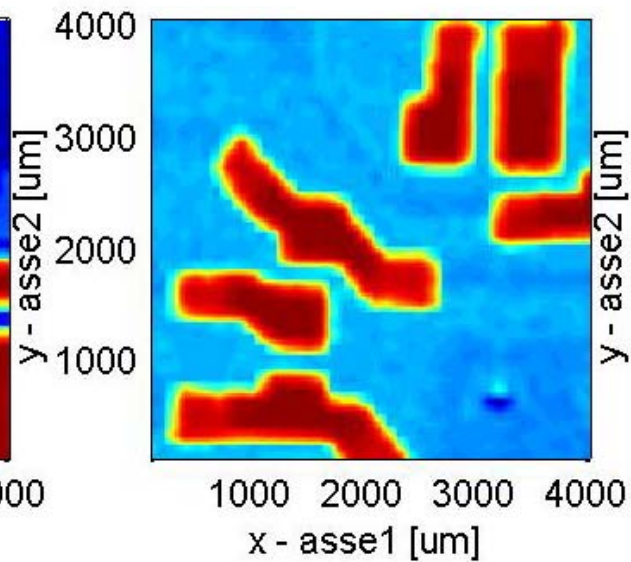
Silver strips



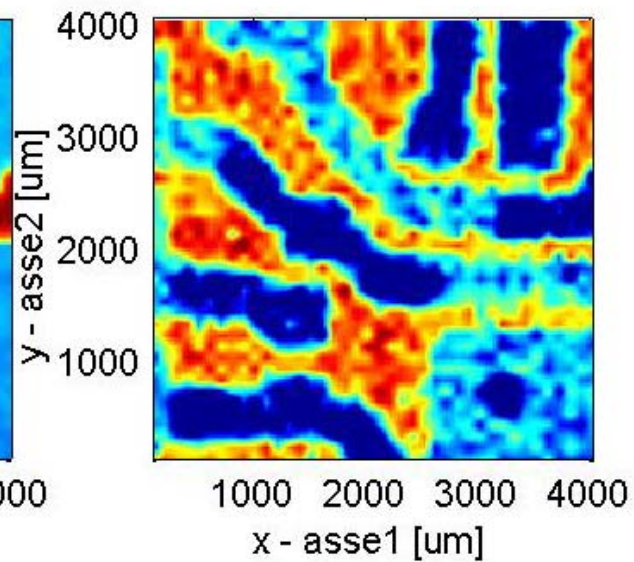
Ag



Au



Al



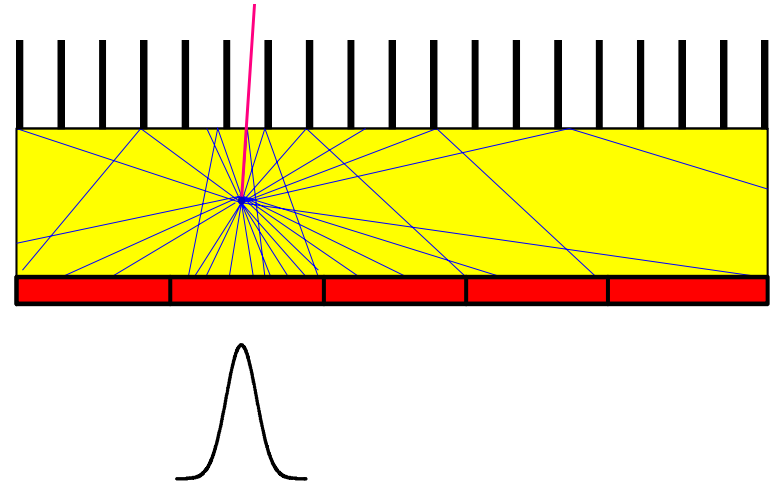
The Gamma ray imaging detectors

SDD arrays coupled with a scintillator crystal

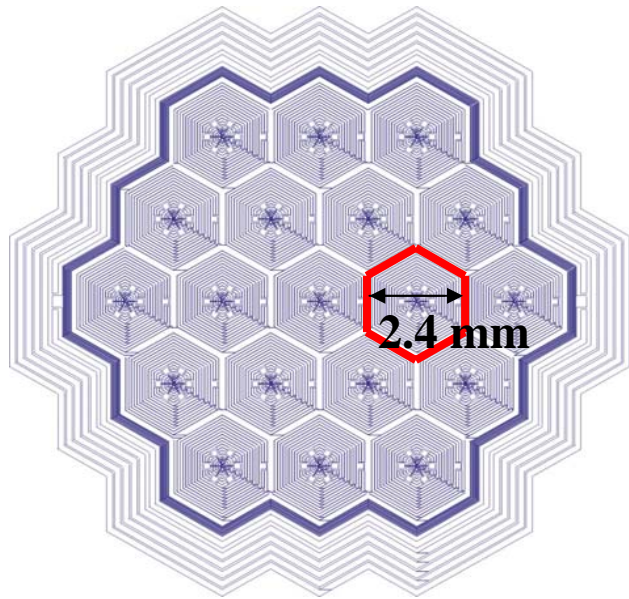
Development of a **small Anger Camera** for high position resolution γ -ray imaging

Applications in Medical Imaging:

- compact diagnostic systems for human imaging (thyroid gland diagnostic, brain imaging, breast imaging..)
- small animal imaging systems with < 0.5 mm position resolution



The first prototype of SDD - CsI(Tl) Anger camera

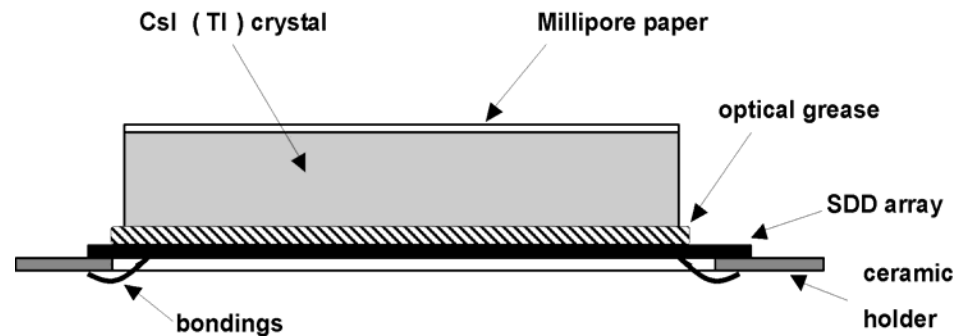
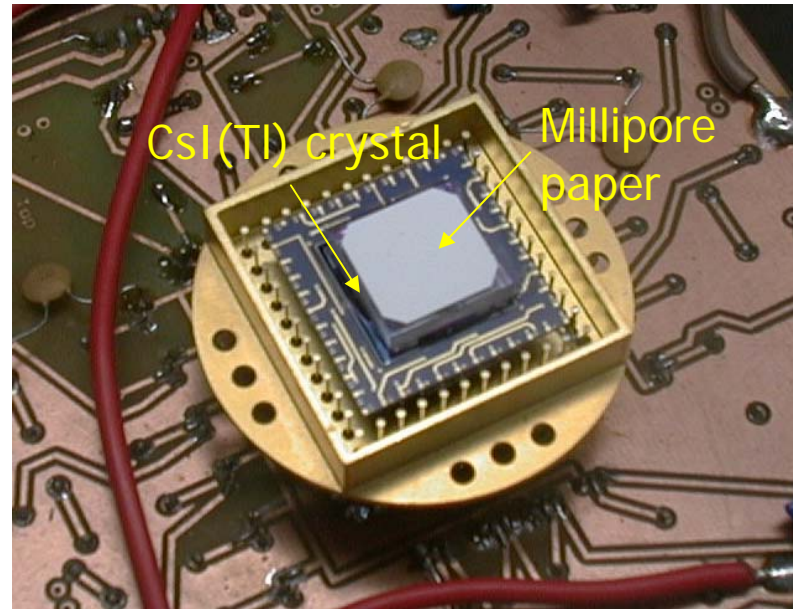


Total area = $5 \text{ mm}^2 \times 19 \sim 1 \text{ cm}^2$

CsI(Tl) thickness = 3 mm

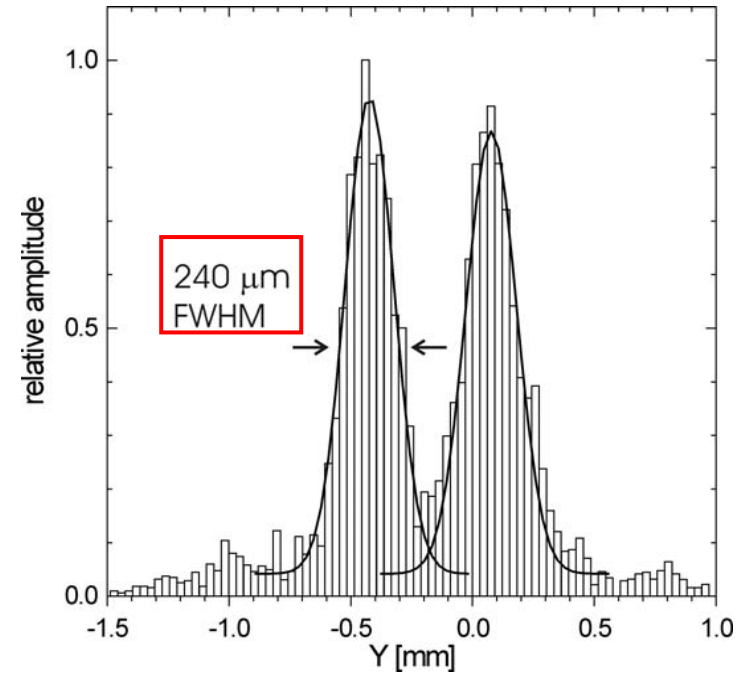
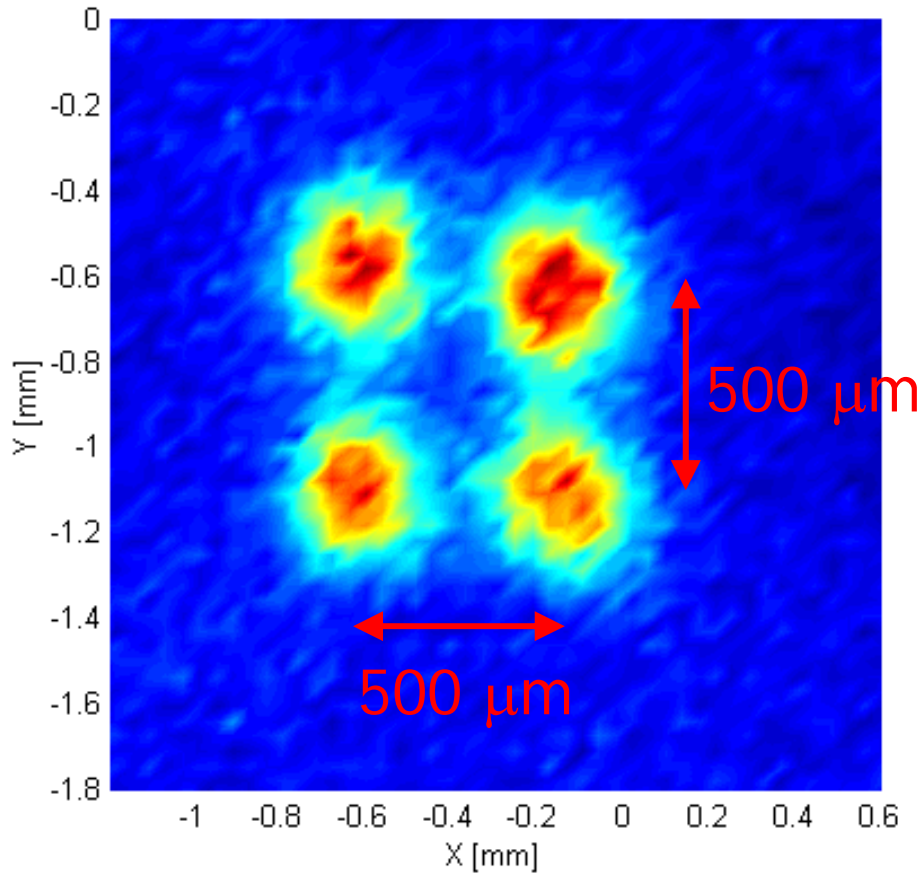
$T = -10^\circ\text{C}$

$E = 122 \text{ keV}$ (^{57}Co)



C.Fiorini, et al., *Nucl. Instr. Meth.*, Vol. A512, 2003.

SDD - CsI(Tl) Anger camera: final results



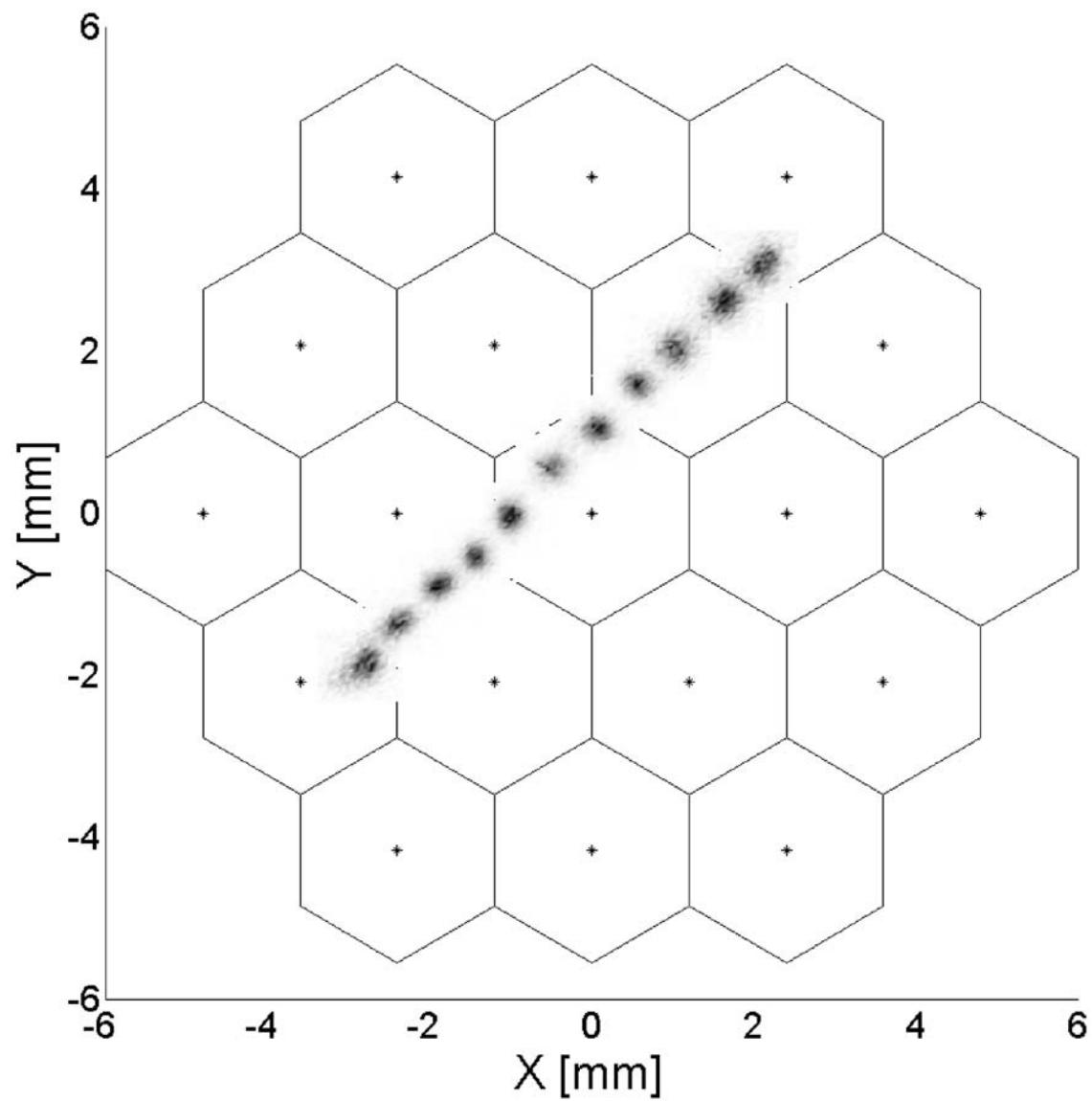
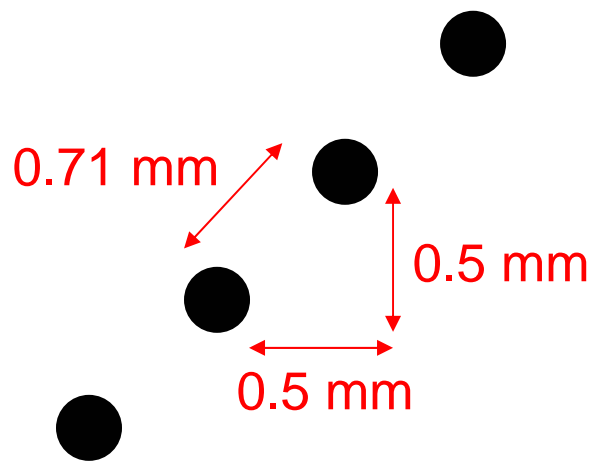
\Rightarrow intrinsic resolution
 $\sim 160 \mu\text{m}$

$E = 122 \text{keV}$ (^{57}Co)

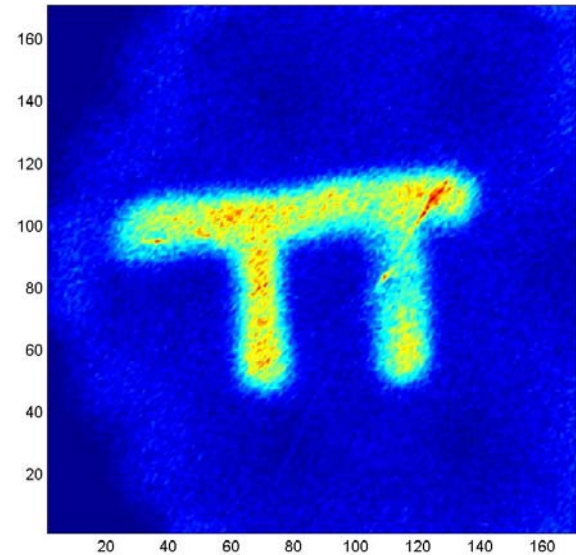
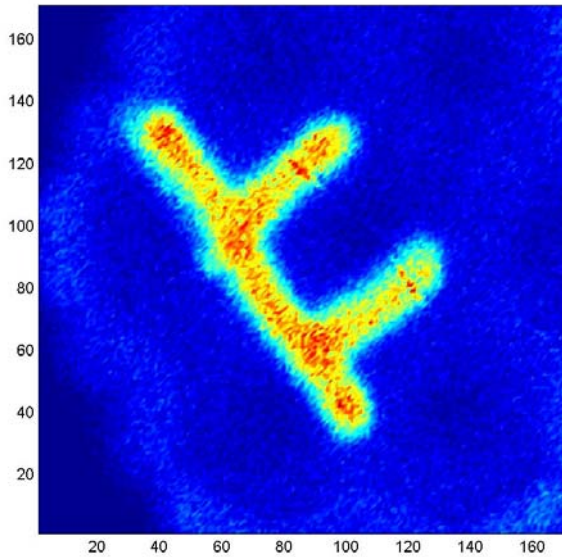
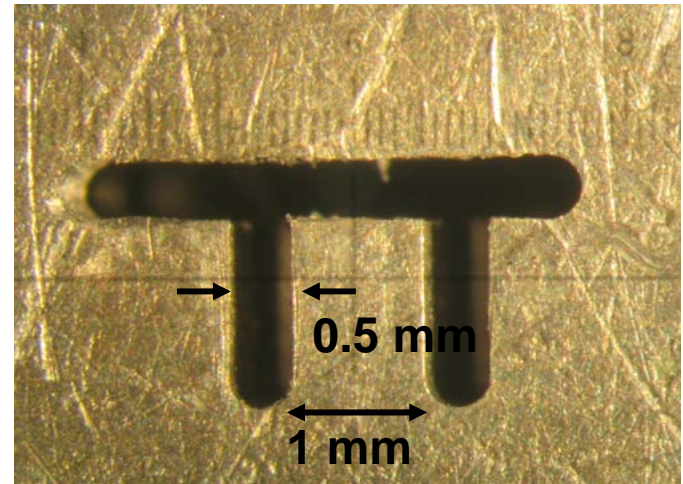
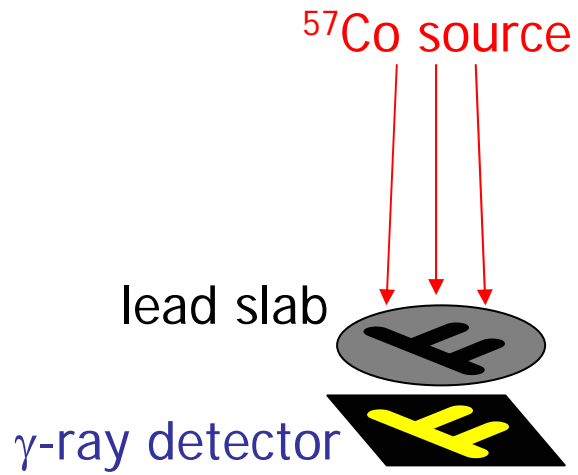
$\varnothing_{\text{collimator}} \sim 180 \mu\text{m}$

\Rightarrow factor 10 better than conventional
Anger Cameras

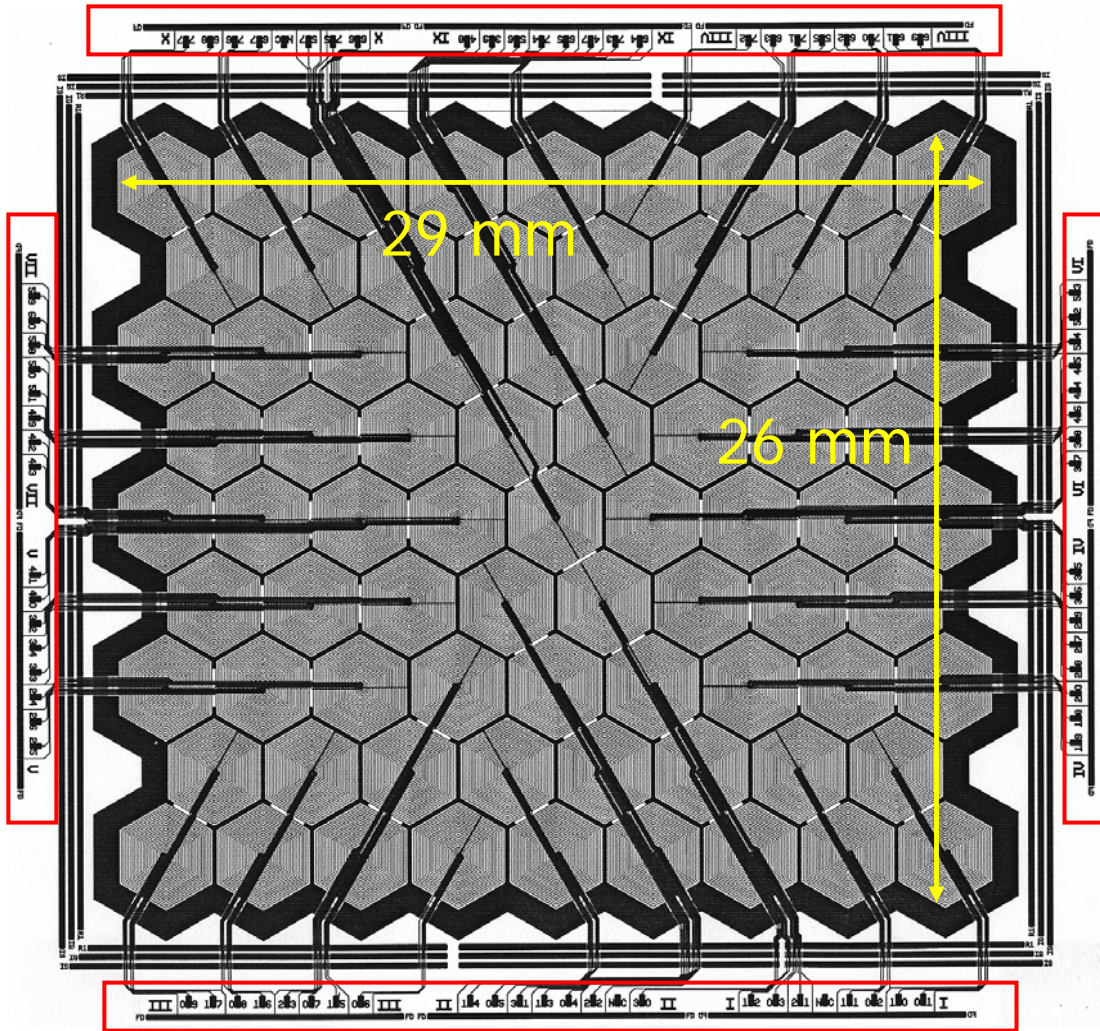
^{57}Co position scan



γ -ray Imaging

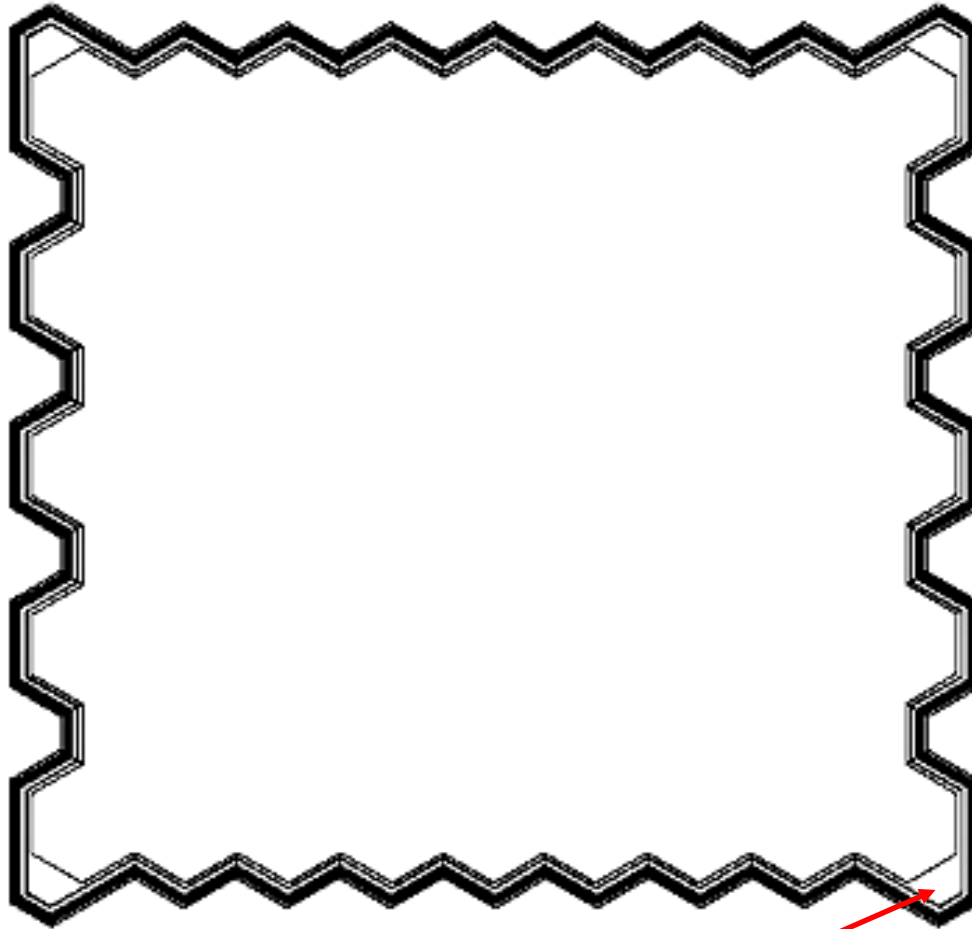


The monolithic array of 77 SDDs: front side



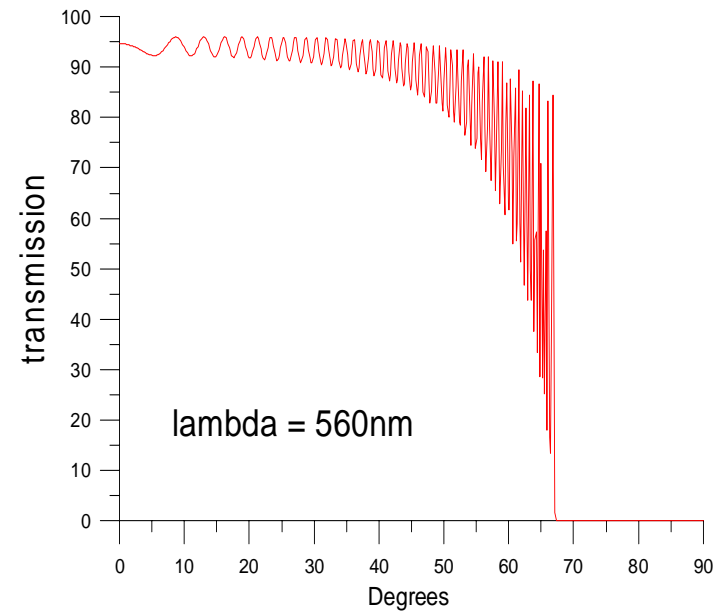
- 77 units, 8.7 mm^2 each
⇒ active area = 6.7 cm^2
- active area: $29 \times 26 \text{ mm}^2$
- two interconnection layers available (polysilicon, Al)
- output pads for bias/signals placed outside the active area

Detector back side

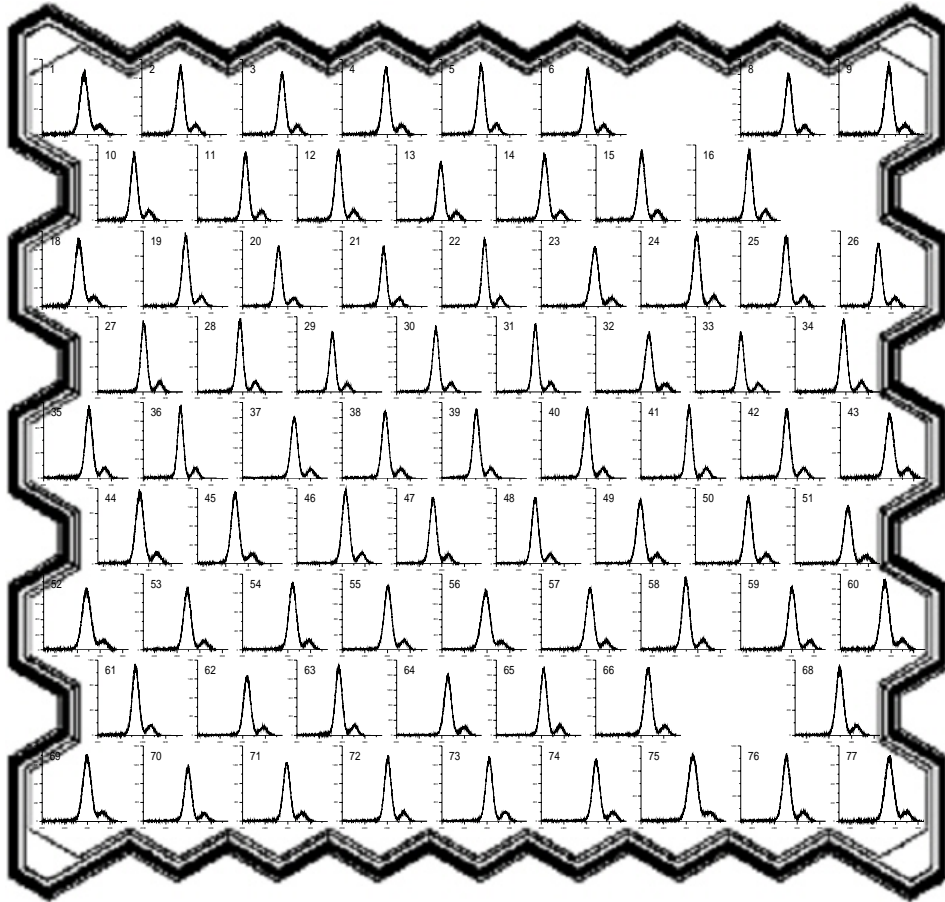


bonding pads

Anti-reflective coatings implemented
Expected QE > 80%



Preliminary characterization of the whole array: ^{55}Fe spectra measured with bias optimized for each unit



room T

$$\tau_{\text{shaping}} = 0.25\mu\text{s}$$

V_{BACK} optimized for
each unit: $-76\text{V} \div -94\text{V}$
(alternatively R#1 can
be optimized for each
unit, with the same results)

noise is good and
uniform among
all units

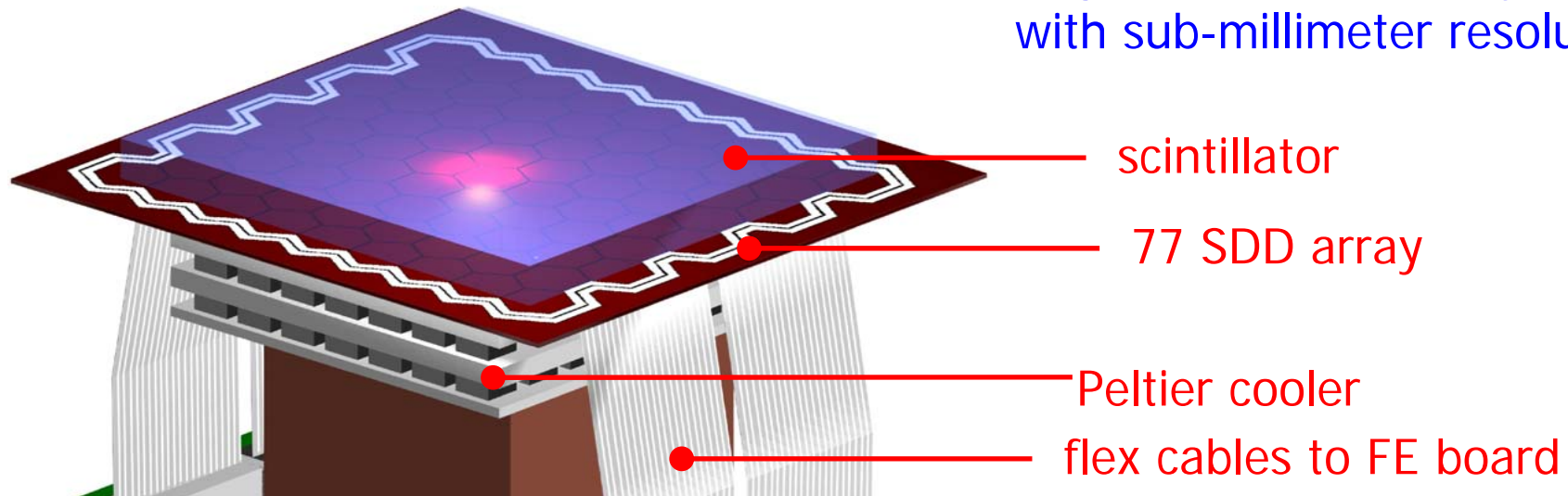
(3 units are not working)

The DRAGO project *

(DRift detector Array-based Gamma camera for Oncology)

Purpose:

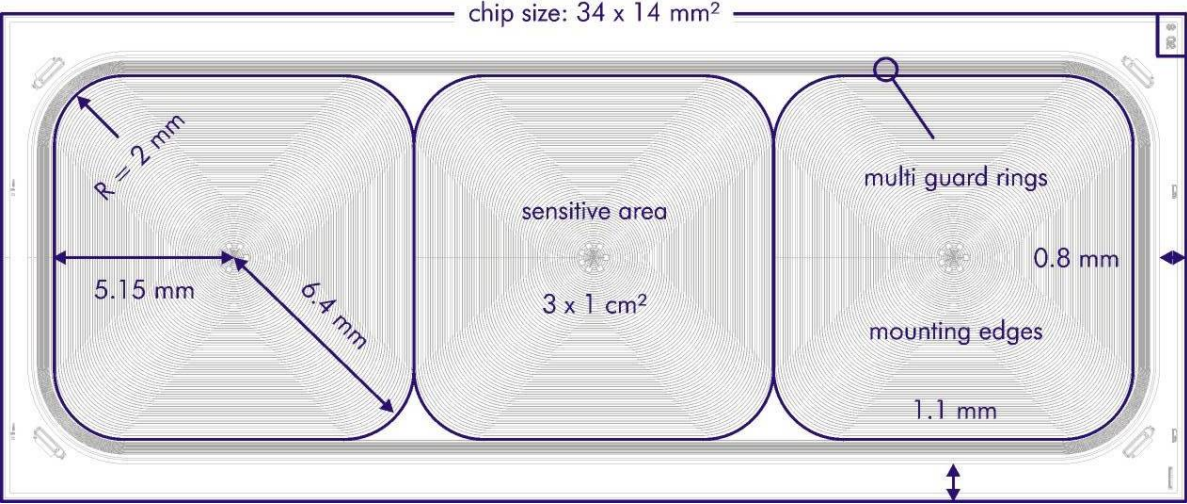
development of a compact Anger Camera for γ -ray imaging with sub-millimeter resolution



* Project INFN Gr.5 2003-05

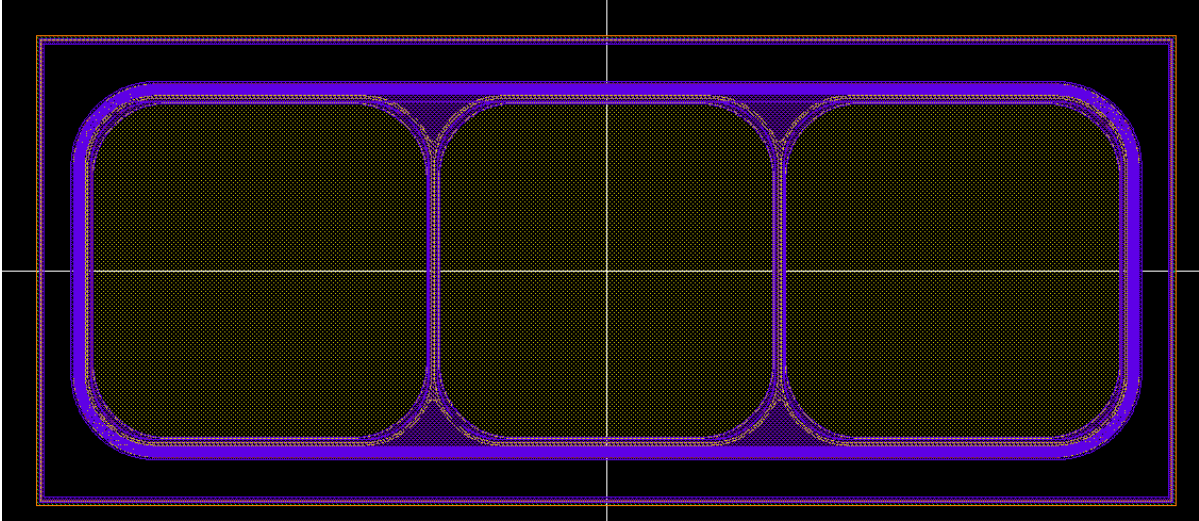
The large-area SDDs

SDD 1cm² x 3 for the experiment SIDDHARTA INFN – EU 6° program



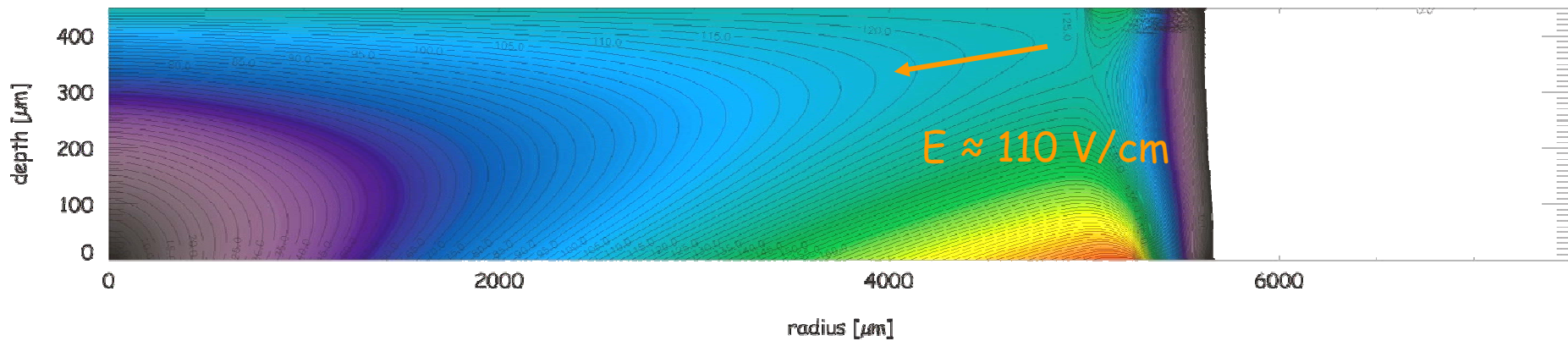
Structured side

Radiation entrance window

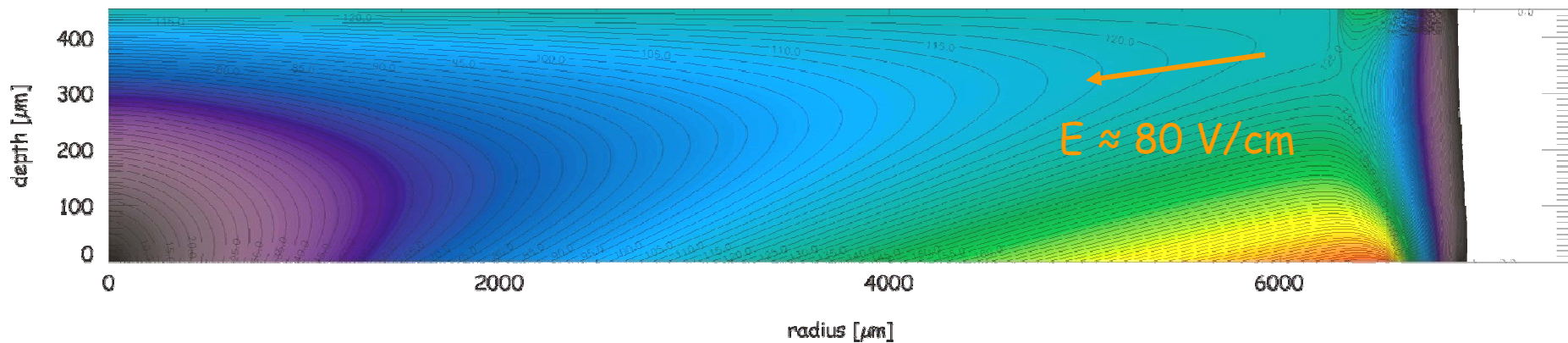


Unstructured side

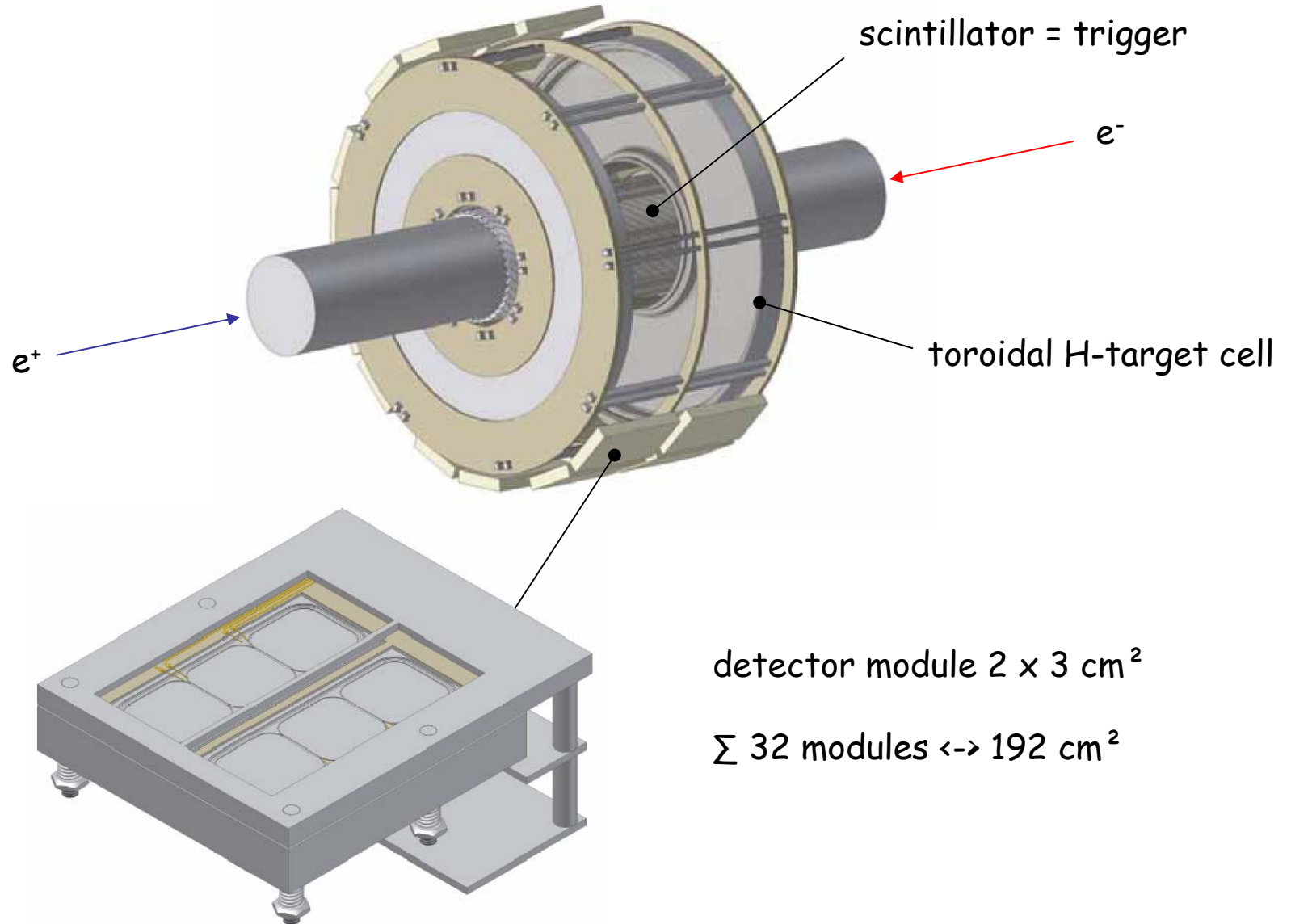
horizontal/vertical centerline



diagonal



Detector Setup



Conclusions

The Devices here presented are today the best results of the “nearly old” idea of the the SDDs (E. Gatti and P. Rehak, 1983).

SDDs (under different commercial names) are nowadays widely used in several applications (SEMs, Synchrotrons, Portable XRF spectrometers, Mars exploration, ...).

Other devices derived from the original idea of Gatti and Rehak, the “fully depleted” PN-CCDs, are flying in a satellite for X-ray astronomy (XMM mission).

New devices, similarly derived from the original idea, are on the way: CDDs, DEPMOS pixel arrays, avalanche SDDs,

The INFN has believed in SDDs and has supported their development, in cooperation with the MPI Halblaiterlabor, from the very beginning of these devices.